

# TAS6424MS-Q1 45W、2MHz デジタル入力、4 チャンネル車載用 Class-D オーディオ・アンプ、負荷ダンパ保護および I<sup>2</sup>C 診断機能搭載



## 1 特長

- 車載アプリケーション向けに AEC-Q100 認証済み
  - 温度グレード 1: -40°C ~ 125°C、T<sub>A</sub>
- 高度な負荷診断機能
  - DC 診断を入力クロックなしで実行
  - インピーダンスおよび位相応答を使った AC 診断によるツイータ検出
- CISPR25-L5 EMC 仕様に容易に適合
- オーディオ入力
  - 4 チャンネルの I<sup>2</sup>S または 4/8 チャンネルの TDM 入力
  - 入力サンプル・レート: 44.1kHz、48kHz、96kHz
  - 入力フォーマット: 16 ビットから 32 ビットの I<sup>2</sup>S および TDM
- オーディオ出力
  - 4 チャンネルのブリッジ結合負荷 (BTL)
  - 2 チャンネルの平行 BTL (PBTL)
  - 最高 2.1MHz の出力スイッチング周波数
  - 27W (10% THD、14.4V BTL、4Ω 負荷)
  - 45W (10% THD、14.4V BTL、2Ω 負荷)
  - 80W (10% THD、18V PBTL、2Ω 負荷)
- 14.4V BTL、4Ω 負荷でのオーディオ性能
  - THD+N < 0.02% (1W)
  - 出力ノイズ: 42μV<sub>RMS</sub>
  - クロストーク: -90dB
- 負荷診断
  - 出力負荷の開路と短絡
  - 出力からバッテリまたはグラウンドへの短絡
  - 最大 6kΩ のライン出力検出
  - ホストと独立の動作
- 保護
  - 出力電流制限および短絡保護
  - 40V の負荷ダンパ
  - グラウンド・オープン / 電源オープンへの耐性
  - DC オフセット
  - 過熱
  - 低電圧および過電圧
- 一般的な動作
  - 4.5V ~ 18V の電源電圧
  - 4 つのアドレス・オプションを持つ I<sup>2</sup>C 制御
  - ラッチ付きおよびラッチなしクリップ検出

## 2 アプリケーション

- 車載ヘッド・ユニット
- 車載外部アンプ

## 3 概要

TAS6424MS-Q1 デバイスは 4 チャンネルのデジタル入力 Class-D オーディオ・アンプで、2.1MHz の PWM スwitching 周波数を実装しているため、非常に小さなサイズの PCB でコスト最適化されたソリューションを実現可能です。開始 / 停止イベントについて最低 4.5V で完全な動作を行い、最高 40kHz のオーディオ帯域幅で非常に優れた音質を提供します。

出力スイッチング周波数は、AM ラジオ帯域より高く設定することも、低く設定することもできます。AM 帯域よりも高く設定すると、AM 帯域への干渉をなくすと同時に、出力フィルタを小さくしてコストを低減できます。AM 帯域よりも低く設定すると、効率を最適化できます。

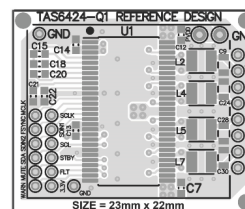
デバイスには負荷診断機能が組み込まれており、出力の誤接続や、AC 結合されたツイータを検出して診断できるため、製造プロセスにおいてテスト時間を短縮するために役立ちます。

TAS6424MS-Q1 Class-D オーディオ・アンプは、車載用ヘッド・ユニット、および外部アンプ・モジュールで使用するよう設計されています。1、2、4 チャンネルのピン互換デバイスについては、「[デバイスのオプション](#)」の表を参照してください。

### 製品情報

| 部品番号         | パッケージ <sup>(1)</sup> | 本体サイズ (公称)       |
|--------------|----------------------|------------------|
| TAS6424MS-Q1 | HSSOP (56)           | 18.41mm × 7.49mm |

- (1) 利用可能なすべてのパッケージについては、このデータシート末尾にある注文情報を参照してください。



## Table of Contents

|  |           |  |           |
|--|-----------|--|-----------|
| <b>1 特長</b> .....                                | <b>1</b>  | 9.6 Register Maps.....                                 | <b>34</b> |
| <b>2 アプリケーション</b> .....                          | <b>1</b>  | <b>10 Application Information Disclaimer</b> .....     | <b>50</b> |
| <b>3 概要</b> .....                                | <b>1</b>  | 10.1 Application Information.....                      | <b>50</b> |
| <b>4 Revision History</b> .....                  | <b>2</b>  | 10.2 Typical Applications.....                         | <b>52</b> |
| <b>5 Device Options</b> .....                    | <b>3</b>  | <b>11 Power Supply Recommendations</b> .....           | <b>57</b> |
| <b>6 Pin Configuration and Functions</b> .....   | <b>4</b>  | <b>12 Layout</b> .....                                 | <b>58</b> |
| <b>7 Specifications</b> .....                    | <b>6</b>  | 12.1 Layout Guidelines.....                            | <b>58</b> |
| 7.1 Absolute Maximum Ratings.....                | <b>6</b>  | 12.2 Layout Example.....                               | <b>58</b> |
| 7.2 ESD 定格.....                                  | <b>6</b>  | 12.3 Thermal Considerations.....                       | <b>58</b> |
| 7.3 Recommended Operating Conditions.....        | <b>6</b>  | <b>13 Device and Documentation Support</b> .....       | <b>60</b> |
| 7.4 Thermal Information.....                     | <b>7</b>  | 13.1 Documentation Support.....                        | <b>60</b> |
| 7.5 Electrical Characteristics.....              | <b>7</b>  | 13.2 Related Documentation.....                        | <b>60</b> |
| 7.6 Typical Characteristics.....                 | <b>12</b> | 13.3 Receiving Notification of Documentation Updates.. | <b>60</b> |
| <b>8 Parameter Measurement Information</b> ..... | <b>17</b> | 13.4 サポート・リソース.....                                    | <b>60</b> |
| <b>9 Detailed Description</b> .....              | <b>18</b> | 13.5 商標.....   | <b>60</b> |
| 9.1 Overview.....                                | <b>18</b> | 13.6 静電気放電に関する注意事項.....                                | <b>60</b> |
| 9.2 Functional Block Diagram.....                | <b>18</b> | 13.7 用語集.....  | <b>60</b> |
| 9.3 Feature Description.....                     | <b>19</b> | <b>14 Mechanical, Packaging, and Orderable</b>         |           |
| 9.4 Device Functional Modes.....                 | <b>30</b> | <b>Information</b> .....                               | <b>60</b> |
| 9.5 Programming.....                             | <b>31</b> |  |           |

## 4 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

| DATE          | REVISION | NOTES            |
|---------------|----------|------------------|
| November 2020 | *        | Initial release. |

## 5 Device Options

| Part Number  | Channel Count | Power-Supply Voltage Range | Channel Current Limit (Typ) | Non-Latching Clip Detect WARN Pin <sup>(1)</sup> | Output Power per channel / 10% THD |                              |                         |                               |
|--------------|---------------|----------------------------|-----------------------------|--|------------------------------------|------------------------------|-------------------------|-------------------------------|
|              |               |                            |                             |  | 4 $\Omega$ / BTL 14.4 V            | 4 $\Omega$ / BTL Max Voltage | 2 $\Omega$ / BTL 14.4 V | 2 $\Omega$ / PBTL Max Voltage |
| TAS6424-Q1   | 4             | 4.5 V to 26.4 V            | 6.5 A                       | N  | 27 W                               | 75 W at 25 V                 | 45 W                    | 150 W at 25 V                 |
| TAS6424M-Q1  | 4             | 4.5 V to 18 V              | 6.5 A                       | N  | 27 W                               | 45 W at 18 V                 | 45 W                    | 80 W at 18 V                  |
| TAS6424L-Q1  | 4             | 4.5 V to 18 V              | 4.8 A                       | N  | 27 W                               | 45 W at 18 V                 | 27 W                    | 80 W at 18 V                  |
| TAS6422-Q1   | 2             | 4.5 V to 26.4 V            | 6.5 A                       | N  | 27 W                               | 75 W at 25 V                 | 45 W                    | 150 W at 25 V                 |
| TAS6421-Q1   | 1             | 4.5 V to 26.4 V            | 6.5 A                       | Y  | 27 W                               | 75 W at 25 V                 | 45 W                    | N/A                           |
| TAS6424LS-Q1 | 4             | 4.5 V to 18 V              | 4.8 A                       | Y  | 27 W                               | 75 W at 25 V                 | 27 W                    | 80 W at 18 V                  |
| TAS6424MS-Q1 | 4             | 4.5 V to 18 V              | 6.5 A                       | Y  | 27 W                               | 45 W at 18 V                 | 45 W                    | 80 W at 18 V                  |
| TAS6422E-Q1  | 2             | 4.5 V to 26.4 V            | 6.5 A                       | Y  | 27 W                               | 75 W at 25 V                 | 45 W                    | 150 W at 25 V                 |

(1) Register configurable function. N = Latched clip detect only. Y = Supports both latched and non-latched clip detect .

## 6 Pin Configuration and Functions

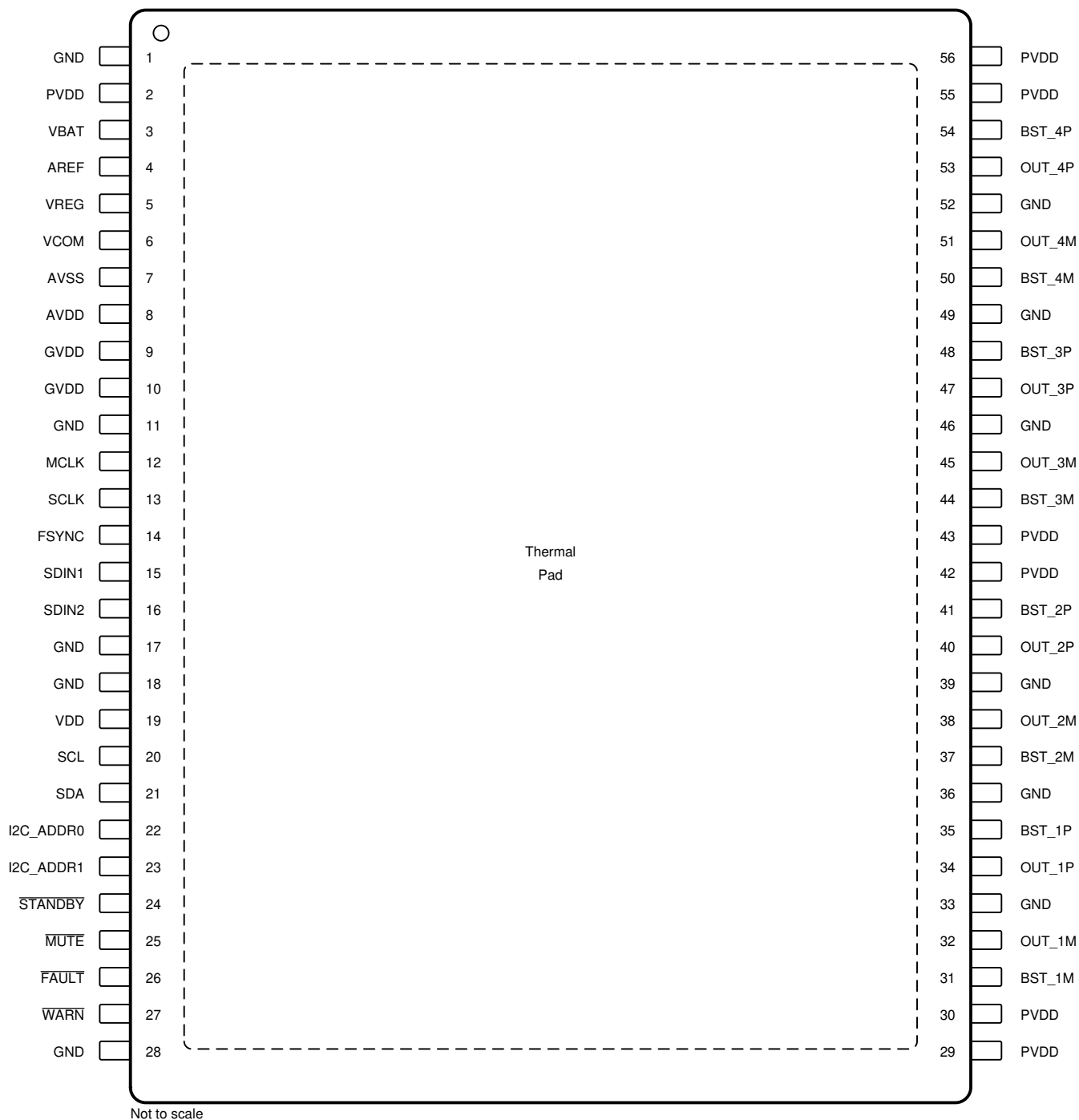


图 6-1. DKQ Package, 56-Pin HSSOP With Exposed Thermal Pad, Top View

表 6-1. Pin Functions

| PIN  |     | TYPE <sup>(1)</sup> | DESCRIPTION   |
|------|-----|---------------------|---|
| NAME | NO. |                     |   |
| AREF | 4   | PWR                 | VREG and VCOM bypass capacitor return                                   |
| AVDD | 8   | PWR                 | Voltage regulator bypass. Connect 1 $\mu$ F capacitor from AVDD to AVSS |
| AVSS | 7   | PWR                 | AVDD bypass capacitor return  |

**表 6-1. Pin Functions (continued)**

| PIN         |   | TYPE <sup>(1)</sup> | DESCRIPTION  |
|-------------|---|---------------------|--|
| NAME        | NO.   |                     |  |
| BST_1M      | 31  | PWR                 | Bootstrap capacitor connection pins for high-side gate driver  |
| BST_1P      | 35  | PWR                 | Bootstrap capacitor connection pins for high-side gate driver  |
| BST_2M      | 37  | PWR                 | Bootstrap capacitor connection pins for high-side gate driver  |
| BST_2P      | 41  | PWR                 | Bootstrap capacitor connection pins for high-side gate driver  |
| BST_3M      | 44  | PWR                 | Bootstrap capacitor connection pins for high-side gate driver  |
| BST_3P      | 48  | PWR                 | Bootstrap capacitor connection pins for high-side gate driver  |
| BST_4M      | 50  | PWR                 | Bootstrap capacitor connection pins for high-side gate driver  |
| BST_4P      | 54  | PWR                 | Bootstrap capacitor connection pins for high-side gate driver  |
| FAULT       | 26  | DO                  | Reports a fault (active low, open drain), 100-kΩ internal pull-up resistor   |
| FSYNC       | 14  | DI                  | Audio frame clock input  |
| GND         | 1, 11, 17, 18,<br>28, 33, 36, 39,<br>46, 49, 52 | GND                 | Ground   |
| GVDD        | 9   | PWR                 | Gate drive voltage regulator derived from VBAT input pin. Connect 2.2 μF capacitor to GND                            |
|             | 10  |                     | Gate drive voltage regulator derived from VBAT input pin. Connect 2.2 μF capacitor to GND                            |
| I2C_ADDR0   | 22  | DI                  | I <sup>2</sup> C address pins. Refer to 表 9-8  |
| I2C_ADDR1   | 23  |                     |  |
| MCLK        | 12  | DI                  | Audio master clock input   |
| MUTE        | 25  | DI                  | Mutes the device outputs (active low) while keeping output FETs switching at 50%, 100-kΩ internal pull-down resistor |
| OUT_1M      | 32  | NO                  | Negative output for the channel  |
| OUT_1P      | 34  | PO                  | Positive output for the channel  |
| OUT_2M      | 38  | NO                  | Negative output for the channel  |
| OUT_2P      | 40  | PO                  | Positive output for the channel  |
| OUT_3M      | 45  | NO                  | Negative output for the channel  |
| OUT_3P      | 47  | PO                  | Positive output for the channel  |
| OUT_4M      | 51  | NO                  | Negative output for the channel  |
| OUT_4P      | 53  | PO                  | Positive output for the channel  |
| PVDD        | 2, 29, 30, 42,<br>43, 55, 56                    | PWR                 | PVDD voltage input (can be connected to battery). Bulk capacitor and bypass capacitor required                       |
| SCL         | 20  | DI                  | I <sup>2</sup> C clock input   |
| SCLK        | 13  | DI                  | Audio bit and serial clock input   |
| SDA         | 21  | DI/O                | I <sup>2</sup> C data input and output   |
| SDIN1       | 15  | DI                  | TDM data input and audio I <sup>2</sup> S data input for channels 1 and 2  |
| SDIN2       | 16  | DI                  | Audio I <sup>2</sup> S data input for channels 3 and 4   |
| STANDBY     | 24  | DI                  | Enables low power standby state (active Low), 100-kΩ internal pull-down resistor                                     |
| VBAT        | 3   | PWR                 | Battery voltage input  |
| VCOM        | 6   | PWR                 | Bias voltage   |
| VDD         | 19  | PWR                 | 3.3 V external supply voltage  |
| VREG        | 5   | PWR                 | Voltage regulator bypass   |
| WARN        | 27  | DO                  | Clip and overtemperature warning (active low, open drain), 100-kΩ internal pull-up resistor                          |
| Thermal Pad | —   | GND                 | Provides both electrical and thermal connection for the device. Heatsink must be connected to GND.                   |

(1) GND = ground, PWR = power, PO = positive output, NO = negative output, DI = digital input, DO = digital output, DI/O = digital input and output, NC = no connection

## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                         |   |                     | MIN  | MAX       | UNIT |
|-------------------------|---|---------------------|------|-----------|------|
| PVDD, VBAT              | DC supply voltage relative to GND   |                     | -0.3 | 30        | V    |
| V <sub>MAX</sub>        | Transient supply voltage: PVDD, VBAT  | t ≤ 400 ms exposure | -1   | 40        | V    |
| V <sub>RAMP</sub>       | Supply-voltage ramp rate: PVDD, VBAT  |                     |      | 75        | V/ms |
| VDD                     | DC supply voltage relative to GND   |                     | -0.3 | 3.5       | V    |
| I <sub>MAX</sub>        | Maximum current per pin (PVDD, VBAT, OUT_xP, OUT_xM, GND)   |                     |      | ±8        | A    |
| I <sub>MAX_PULSED</sub> | Pulsed supply current per PVDD pin (one shot)   | t < 100 ms          |      | ±12       | A    |
| V <sub>LOGIC</sub>      | Input voltage for logic pins (SCL, SDA, SDIN1, SDIN2, MCLK, BCLK, LRCLK, MUTE, /STANDBY, I2C_ADDRx) |                     | -0.3 | VDD + 0.5 | V    |
| V <sub>GND</sub>        | Maximum voltage between GND pins  |                     | -0.3 | 0.3       | V    |
| T <sub>J</sub>          | Maximum operating junction temperature  |                     | -55  | 150       | °C   |
| T <sub>stg</sub>        | Storage temperature   |                     | -55  | 150       | °C   |

- (1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 7.2 ESD 定格

|                    |       |   | 値     | 単位 |
|--------------------|-------|---|-------|----|
| V <sub>(ESD)</sub> | 静電気放電 | 人体モデル (HBM)、AEC Q100-002 <sup>(1)</sup><br>HBM ESD 分類レベル 2 準拠 | ±3000 | V  |
|                    |       | デバイス帯電モデル (CDM)、AEC Q100-011<br>CDM ESD 分類レベル C4B 準拠          | ±500  |    |
|                    |       | すべてのピン<br>コーナー・ピン (1、28、29、56)                                | ±1000 | V  |

- (1) (1) AEC Q100-002 は、HBM ストレス試験を ANSI/ESDA/JEDEC JS-001 仕様に従って実施することを示しています。

### 7.3 Recommended Operating Conditions

|                     |  |  | MIN | TYP  | MAX | UNIT |
|---------------------|--|--|-----|------|-----|------|
| PVDD                | Output FET Supply Voltage Range                        | Relative to GND                        | 4.5 |      | 18  | V    |
| V <sub>BAT</sub>    | Battery Supply Voltage Input                           | Relative to GND                        | 4.5 | 14.4 | 18  |      |
| VDD                 | DC Logic supply  | Relative to GND                        | 3.0 | 3.3  | 3.5 |      |
| T <sub>A</sub>      | Ambient temperature                                    |  | -40 |      | 125 | °C   |
| T <sub>J</sub>      | Junction temperature                                   | An adequate thermal design is required | -40 |      | 150 |      |
| R <sub>L</sub>      | Minimum speaker load impedance                         | BTL Mode                               | 2   | 4    |     | Ω    |
|                     |  | PBTL Mode                              | 1   | 2    |     |      |
| R <sub>PU_I2C</sub> | I <sup>2</sup> C pullup resistance on SDA and SCL pins |  | 1   | 4.7  | 10  | kΩ   |
| C <sub>Bypass</sub> | External capacitance on bypass pins                    | Pin 2, 3, 5, 6, 8, 19                  |     | 1    |     | μF   |
| C <sub>GVDD</sub>   | External capacitance on GVDD pins                      | Pin 9, 10                              |     | 2.2  |     | μF   |
| C <sub>OUT</sub>    | External capacitance to GND on OUT pins                | Limit set by DC-diagnostic timing      |     | 1    | 3.3 | μF   |

### 7.3 Recommended Operating Conditions (continued)

|       |                          |   | MIN | TYP | MAX | UNIT    |
|-------|--------------------------|---|-----|-----|-----|---------|
| $L_O$ | Output filter inductance | Minimum inductance at $I_{SD}$ current levels | 1   |     |     | $\mu H$ |

### 7.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |  | TAS6424MS-Q1 <sup>(2)</sup> | TAS6424MS-Q1 <sup>(3)</sup> |
|-------------------------------|--|-----------------------------|-----------------------------|
|                               |  | DKQ (HSSOP)                 | DKQ(HSSOP)                  |
|                               |  | 56 PINS                     | 56 PINS                     |
| $R_{\theta JA}$               | Junction-to-ambient thermal resistance       | 37.3                        | -                           |
| $R_{\theta JC(top)}$          | Junction-to-case (top) thermal resistance    | 0.4                         | 1.1                         |
| $R_{\theta JB}$               | Junction-to-board thermal resistance         | 15.2                        | -                           |
| $\Psi_{JT}$                   | Junction-to-top characterization parameter   | 0.2                         | -                           |
| $\Psi_{JB}$                   | Junction-to-board characterization parameter | 14.7                        | 10                          |
| $R_{\theta JC(bot)}$          | Junction-to-case (bottom) thermal resistance | n/a                         | -                           |

- (1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.  
(2) JEDEC Standard 4 Layer PCB.  
(3) Measured using the TAS6424MS-Q1 EVM layout and heat sink. The device is not intended to be used without a heatsink.

### 7.5 Electrical Characteristics

Test conditions (unless otherwise noted): TC = 25°C, PVDD = VBAT = 14.4 V, VDD = 3.3 V, RL = 4  $\Omega$ , Pout = 1 W/ch, f = 1 kHz, f<sub>SW</sub> = 2.11 MHz, AES17 Filter, default I2C settings

| PARAMETER                |                               | TEST CONDITIONS                                    | MIN | TYP | MAX | UNIT    |
|--------------------------|-------------------------------|--|-----|-----|-----|---------|
| <b>OPERATING CURRENT</b> |                               |  |     |     |     |         |
| $I_{PVDD\_IDLE}$         | PVDD idle current             | All channels playing, no audio input               |     | 75  | 90  | mA      |
| $I_{VBAT\_IDLE}$         | VBAT idle current             | All channels playing, no audio input               |     | 90  | 100 | mA      |
| $I_{PVDD\_STBY}$         | PVDD standby current          | STANDBY Active, VDD = 0 V                          |     | 0.5 | 1   | $\mu A$ |
| $I_{VBAT\_STBY}$         | VBAT standby current          | STANDBY Active, VDD = 0 V                          |     | 4   | 6   | $\mu A$ |
| $I_{VDD}$                | VDD supply current            | All channels playing, -60-dB signal                |     | 15  | 18  | mA      |
| <b>OUTPUT POWER</b>      |                               |  |     |     |     |         |
| $P_{O\_BTL}$             | Output power per channel, BTL | 4 $\Omega$ , PVDD = 14.4 V, THD+N = 1%, TC = 75°C  | 20  | 22  | W   |         |
|                          |                               | 4 $\Omega$ , PVDD = 14.4 V, THD+N = 10%, TC = 75°C | 25  | 27  |     |         |
|                          |                               | 2 $\Omega$ , PVDD = 14.4 V, THD+N = 1%, TC = 75°C  | 38  | 40  |     |         |
|                          |                               | 2 $\Omega$ , PVDD = 14.4 V, THD+N = 10%, TC = 75°C | 42  | 45  |     |         |
|                          |                               | 4 $\Omega$ , PVDD = 18 V, THD+N = 1%, TC = 75°C    | 30  | 33  |     |         |
|                          |                               | 4 $\Omega$ , PVDD = 18 V, THD+N = 10%, TC = 75°C   | 40  | 45  |     |         |

## 7.5 Electrical Characteristics (continued)

Test conditions (unless otherwise noted): TC = 25°C, PVDD = VBAT = 14.4 V, VDD = 3.3 V, RL = 4 Ω, Pout = 1 W/ch, f = 1 kHz, f<sub>SW</sub> = 2.11 MHz, AES17 Filter, default I2C settings

| PARAMETER               |  | TEST CONDITIONS  | MIN  | TYP | MAX | UNIT |
|-------------------------|--|--|------|-----|-----|------|
| P <sub>O_PBT</sub> L    | Output power per channel in parallel mode, PBT | 2 Ω, PVDD = 14.4 V, THD+N = 1%, TC = 75°C                                    | 35   | 40  |     | W    |
|                         |  | 2 Ω, PVDD = 14.4 V, THD+N = 10%, TC = 75°C                                   | 45   | 50  |     |      |
|                         |  | 1 Ω, PVDD = 14.4 V, THD+N = 1%, TC = 75°C                                    | 72   | 80  |     |      |
|                         |  | 1 Ω, PVDD = 14.4 V, THD+N = 10%, TC = 75°C                                   | 80   | 90  |     |      |
|                         |  | 2 Ω, PVDD = 18 V, THD+N = 1%, TC = 75°C                                      | 60   | 65  |     |      |
|                         |  | 2 Ω, PVDD = 18 V, THD+N = 10%, TC = 75°C                                     | 75   | 80  |     |      |
| EFF <sub>P</sub>        | Power efficiency                               | 4 channels operating, 25-W output power/ch 4 Ω load,PVDD = 14.4 V, TC = 25°C | 86%  |     |     |      |
| AUDIO PERFORMANCE       |  |  |      |     |     |      |
| V <sub>n</sub>          | Output noise voltage                           | Zero input, A-weighting, gain level 1, PVDD = 14.4 V                         | 42   |     |     | μV   |
|                         |  | Zero input, A-weighting, gain level 2, PVDD = 14.4 V                         | 55   |     |     |      |
|                         |  | Zero input, A-weighting, gain level 3, PVDD = 18 V                           | 67   |     |     |      |
|                         |  | Zero input, A-weighting, gain level 4, PVDD = 18 V                           | 85   |     |     |      |
| GAIN                    | Peak Output Voltage/dBFS                       | gain level 1, Register 0x01, bit 1-0 = 00                                    | 7.5  |     |     | V/FS |
|                         |  | gain level 2, Register 0x01, bit 1-0 = 01                                    | 15   |     |     |      |
|                         |  | gain level 3, Register 0x01, bit 1-0 = 10                                    | 21   |     |     |      |
|                         |  | gain level 4, Register 0x01, bit 1-0 = 11                                    | 29   |     |     |      |
| GAIN <sub>VAR</sub>     | Channel Gain Variation                         | Gain variation for all gain levels.  | -0.5 | 0.5 |     | dB   |
| Crosstalk               | Channel crosstalk                              | PVDD = 14.4 Vdc + 1 VRMS, f = 1 kHz  | -90  |     |     | dB   |
| PSRR                    | Power-supply rejection ratio                   | PVDD = 14.4 Vdc + 1 VRMS, f = 1 kHz  | 75   |     |     | dB   |
| THD+N                   | Total harmonic distortion + noise              |  | 0.02 |     |     |      |
| G <sub>CH</sub>         | Channel-to-channel gain variation              |  | -0.5 | 0   | 0.5 | dB   |
| LINE OUTPUT PERFORMANCE |  |  |      |     |     |      |
| V <sub>n_LINEOUT</sub>  | LINE output noise voltage                      | Zero input, A-weighting, channel set to LINE MODE                            | 42   |     |     | μV   |
| V <sub>O_LINEOUT</sub>  | LINE output voltage                            | 0dB input, channel set to LINE MODE  | 5.5  |     |     | VRMS |
| THD+N                   | Line output total harmonic distortion + noise  | VO = 2 VRMS , channel set to LINE MODE                                       | 0.01 |     |     |      |
| DIGITAL INPUT PINS      |  |  |      |     |     |      |
| V <sub>IH</sub>         | Input logic level high                         |  | 70   |     |     | %VDD |
| V <sub>IL</sub>         | Input logic level low                          |  |      |     | 30  | %VDD |
| I <sub>IH</sub>         | Input logic current, high                      | VI = VDD   |      |     | 15  | μA   |

## 7.5 Electrical Characteristics (continued)

Test conditions (unless otherwise noted): TC = 25°C, PVDD = VBAT = 14.4 V, VDD = 3.3 V, RL = 4 Ω, Pout = 1 W/ch, f = 1 kHz, f<sub>SW</sub> = 2.11 MHz, AES17 Filter, default I2C settings

| PARAMETER                        |  | TEST CONDITIONS  | MIN  | TYP  | MAX | UNIT |
|----------------------------------|--|--|------|------|-----|------|
| I <sub>IL</sub>                  | Input logic current, low                 | V <sub>I</sub> = 0   |      |      | -15 | μA   |
| PWM OUTPUT STAGE                 |  |  |      |      |     |      |
| R <sub>DS(on)</sub>              | FET drain-to-source resistance           | Not including bond wire and package resistance             |      | 90   |     | mΩ   |
| OVER VOLTAGE (OV) PROTECTIONI    |  |  |      |      |     |      |
| V <sub>PVDD_OV</sub>             | PVDD overvoltage shutdown                |  | 19.3 | 20   | 22  | V    |
| V <sub>PVDD_OV_HY S</sub>        | PVDD overvoltage shutdown hysteresis     |  |      | 0.8  |     | V    |
| V <sub>VBAT_OV</sub>             | VBAT overvoltage shutdown                |  | 20   | 21.5 | 23  | V    |
| V <sub>VBAT_OV_HY S</sub>        | VBAT overvoltage shutdown hysteresis     |  |      | 0.6  |     |      |
| UNDER VOLTAGE (UV) PROTECTIONI   |  |  |      |      |     |      |
| V <sub>BATUV</sub>               | VBAT undervoltage shutdown               |  |      | 4    | 4.5 | V    |
| V <sub>BATUV_HYS</sub>           | VBAT undervoltage shutdown hysteresis    |  |      | 0.2  |     | V    |
| PVDD <sub>UV</sub>               | PVDD undervoltage shutdown               |  |      | 4    | 4.5 | V    |
| PVDD <sub>UV_HY S</sub>          | PVDD undervoltage shutdown hysteresis    |  |      | 0.2  |     | V    |
| BYPASS VOLTAGES                  |  |  |      |      |     |      |
| V <sub>GVDD</sub>                | Gate drive bypass pin voltage            |  |      | 7    |     | V    |
| V <sub>AVDD</sub>                | Analog bypass pin voltage                |  |      | 6    |     | V    |
| V <sub>VCOM</sub>                | Common bypass pin voltage                |  |      | 2.5  |     | V    |
| V <sub>VREG</sub>                | Regulator bypass pin voltage             |  |      | 5.5  |     | V    |
| POWER-ON RESET(POR)              |  |  |      |      |     |      |
| V <sub>POR</sub>                 | VDD voltage for POR                      |  |      | 2.1  | 2.7 | V    |
| V <sub>POR_HY</sub>              | VDD POR recovery hysteresis voltage      |  |      | 0.5  |     | V    |
| OVER TEMPERATURE (OT) PROTECTION |  |  |      |      |     |      |
| OTW(i)                           | Channel overtemperature warning          |  |      | 150  |     | °C   |
| OTSD(i)                          | Channel overtemperature shutdown         |  |      | 175  |     | °C   |
| OTW                              | Global junction overtemperature warning  |  |      | 130  |     | °C   |
| OTSD                             | Global junction overtemperature shutdown |  |      | 160  |     | °C   |
| OT <sub>HYS</sub>                | Overtemperature hysteresis               |  |      | 15   |     | °C   |
| LOAD OVER CURRENT PROTECTION     |  |  |      |      |     |      |
| I <sub>LIM</sub>                 | Overcurrent cycle-by-cycle limit         | OC Level 1   | 4.0  | 4.8  |     | A    |
|                                  |  | OC Level 2   | 6.0  | 7    |     | A    |
| I <sub>SD</sub>                  | Overcurrent shutdown                     | OC Level 1, Any short to supply, ground, or other channels |      | 7    |     | A    |
|                                  |  | OC Level 2, Any short to supply, ground, or other channels |      | 9    |     | A    |
| MUTE MODE                        |  |  |      |      |     |      |
| G <sub>MUTE</sub>                | Output attenuation                       |  |      | 100  |     | dB   |
| CLICK AND POP                    |  |  |      |      |     |      |
| V <sub>CP</sub>                  | Output click and pop voltage             | ITU-R 2k filter, High-Z/MUTE to Play, Play to Mute/High-Z  |      | 7    |     | mV   |

## 7.5 Electrical Characteristics (continued)

Test conditions (unless otherwise noted): TC = 25°C, PVDD = VBAT = 14.4 V, VDD = 3.3 V, RL = 4 Ω, Pout = 1 W/ch, f = 1 kHz, f<sub>SW</sub> = 2.11 MHz, AES17 Filter, default I2C settings

| PARAMETER                             |  | TEST CONDITIONS                              | MIN  | TYP | MAX  | UNIT |
|---------------------------------------|--|--|------|-----|------|------|
| <b>DC OFFSET</b>                      |  |  |      |     |      |      |
| V <sub>OFFSET</sub>                   | Output offset voltage  |  |      | 2   | 5    | mV   |
| <b>DC DETECT</b>                      |  |  |      |     |      |      |
| DC <sub>FAULT</sub>                   | Output DC fault protection                                     |  |      | 2   | 2.5  | V    |
| <b>DIGITAL OUTPUT PINS</b>            |  |  |      |     |      |      |
| V <sub>OH</sub>                       | Output voltage for logic level high                            | I = ±2 mA                                    | 90   |     |      | %VDD |
| V <sub>OL</sub>                       | Output voltage for logic level low                             | I = ±2 mA                                    |      |     | 10   | %VDD |
| t <sub>DELAY_CLIPDET</sub>            | Signal delay when output clipping detected                     |  |      |     | 20   | μs   |
| <b>LOAD DIAGNOSTICS</b>               |  |  |      |     |      |      |
| S2P                                   | Maximum resistance to detect a short from OUT pin(s) to PVDD   |  |      |     | 500  | Ω    |
| S2G                                   | Maximum resistance to detect a short from OUT pin(s) to ground |  |      |     | 200  | Ω    |
| SL                                    | Shorted load detection tolerance                               | Other channels in Hi-Z                       |      |     | ±0.5 | Ω    |
| OL                                    | Open load  | Other channels in Hi-Z                       | 40   | 70  |      | Ω    |
| T <sub>DC_DIAG</sub>                  | DC diagnostic time   | All 4 Channels                               |      | 230 |      | ms   |
| LO                                    | Line output  |  |      |     | 6    | kΩ   |
| T <sub>LINE_DIAG</sub>                | Line output diagnostic time                                    |  |      | 40  |      | ms   |
| AC <sub>IMP</sub>                     | AC impedance accuracy  | Offset                                       |      |     | ±0.5 | Ω    |
|                                       |  | Gain linearity, f = 19 kHz, RL = 2 Ω to 16 Ω |      |     | 0.25 |      |
| T <sub>AC_DIAG</sub>                  | AC diagnostic time   | All 4 Channels                               |      | 520 |      | ms   |
| <b>I2C_ADDR PINS</b>                  |  |  |      |     |      |      |
| t <sub>I2C_ADDR</sub>                 | Time delay needed for I2C address set-up                       |  |      | 300 |      | μs   |
| <b>I2C CONTROL PORT</b>               |  |  |      |     |      |      |
| t <sub>BUS</sub>                      | Bus free time between start and stop conditions                |  | 1.3  |     |      | μs   |
| t <sub>HOLD1</sub>                    | Hold time, SCL to SDA  |  | 0    |     |      | ns   |
| t <sub>HOLD2</sub>                    | Hold time, start condition to SCL                              |  | 0.6  |     |      | μs   |
| t <sub>START</sub>                    | I2C startup time after VDD power on reset                      |  |      |     | 12   | ms   |
| t <sub>RISE</sub>                     | Rise time, SCL and SDA   |  |      |     | 300  | ns   |
| t <sub>FALL</sub>                     | Fall time, SCL and SDA   |  |      |     | 300  | ns   |
| t <sub>SU1</sub>                      | Setup, SDA to SCL  |  | 100  |     |      | ns   |
| t <sub>SU2</sub>                      | Setup, SCL to start condition                                  |  | 0.6  |     |      | μs   |
| t <sub>SU3</sub>                      | Setup, SCL to stop condition                                   |  | 0.6  |     |      | μs   |
| t <sub>W(H)</sub>                     | Required pulse duration SCL high                               |  | 0.6  |     |      | μs   |
| t <sub>W(L)</sub>                     | Required pulse duration SCL low                                |  | 1.3  |     |      | μs   |
| <b>SERIAL AUDIO PORT</b>              |  |  |      |     |      |      |
| D <sub>MCLK</sub> , D <sub>SCLK</sub> | Allowable input clock duty cycle                               |  | 0.45 | 0.5 | 0.55 |      |
| f <sub>MCLK</sub>                     | Supported MCLK frequencies                                     | 128, 256, or 512                             | 128  |     | 512  | xFS  |
| f <sub>MCLK_Max</sub>                 | Maximum frequency  |  |      |     | 25   | MHz  |
| t <sub>SCY</sub>                      | SCLK pulse cycle time  |  | 40   |     |      | ns   |

## 7.5 Electrical Characteristics (continued)

Test conditions (unless otherwise noted): TC = 25°C, PVDD = VBAT = 14.4 V, VDD = 3.3 V, RL = 4 Ω, Pout = 1 W/ch, f = 1 kHz, f<sub>SW</sub> = 2.11 MHz, AES17 Filter, default I2C settings

| PARAMETER              |   | TEST CONDITIONS            | MIN | TYP | MAX | UNIT |
|------------------------|---|----------------------------|-----|-----|-----|------|
| t <sub>SCL</sub>       | SCLK pulse-with LOW   |                            | 16  |     |     | ns   |
| t <sub>SCH</sub>       | SCLK pulse-with HIGH  |                            | 16  |     |     | ns   |
| t <sub>RISE/FALL</sub> | Rise and fall time  |                            |     | <5  |     | ns   |
| t <sub>SF</sub>        | Required FSYNC to SCLK rising edge                          |                            | 8   |     |     | ns   |
| t <sub>FS</sub>        | FSYNC rising edge to SCLK edge                              |                            | 8   |     |     | ns   |
| t <sub>DS</sub>        | DATA set-up time  |                            | 8   |     |     | ns   |
| t <sub>DH</sub>        | DATA hold time  |                            | 8   |     |     | ns   |
| t <sub>h</sub>         | Required SDIN hold time after SCLK rising edge              |                            |     | 15  |     | ns   |
| t <sub>su</sub>        | Required SDIN setup time before SCLK rising edge            |                            |     | 15  |     | ns   |
| C <sub>i</sub>         | Input capacitance, pins MCLK, SCLK, FSYNC, SDIN1, SDIN2     |                            |     |     | 10  | pf   |
| T <sub>LA</sub>        | Latency from input to output measured in FSYNC sample count | FSYNC = 44.1 kHz or 48 kHz |     |     | 30  |      |
|                        |   | FSYNC = 96 kHz             |     |     | 12  |      |

## 7.6 Typical Characteristics

$T_A = 25\text{ }^{\circ}\text{C}$ ,  $V_{DD} = 3.3\text{ V}$ ,  $V_{BAT} = PVDD = 14.4\text{ V}$ ,  $R_L = 4\text{ }\Omega$ ,  $f_{IN} = 1\text{ kHz}$ ,  $f_s = 48\text{ kHz}$ ,  $f_{SW} = 2.1\text{ MHz}$ , AES17 filter, default I<sup>2</sup>C settings, see [Figure 10-2](#) and [Figure 10-3](#) (unless otherwise noted)

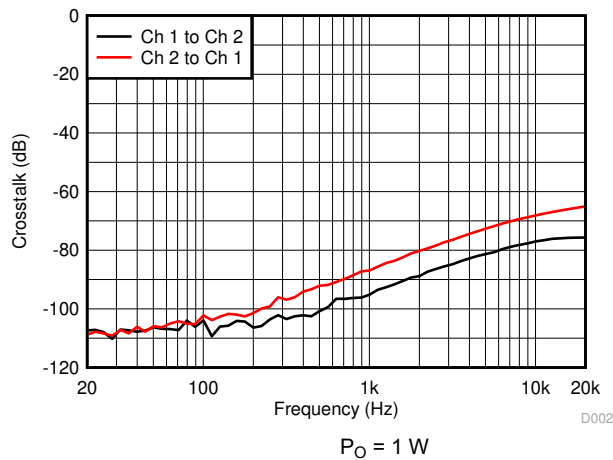


Figure 7-1. Crosstalk vs Frequency

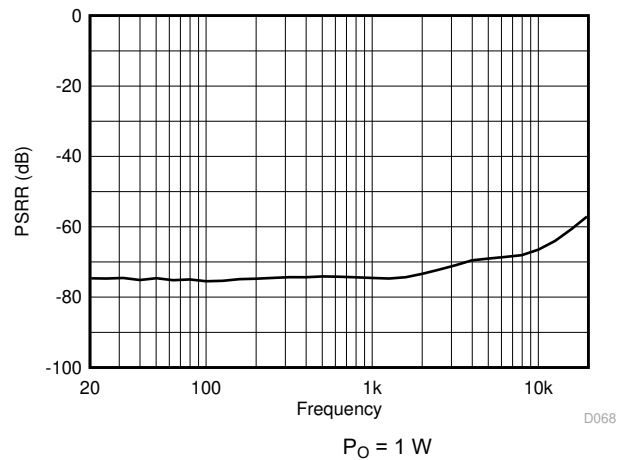


Figure 7-2. PVDD PSRR vs Frequency

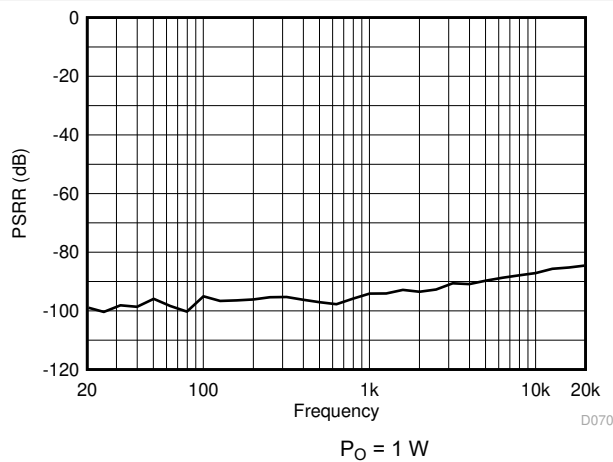


Figure 7-3. VBAT PSRR vs Frequency

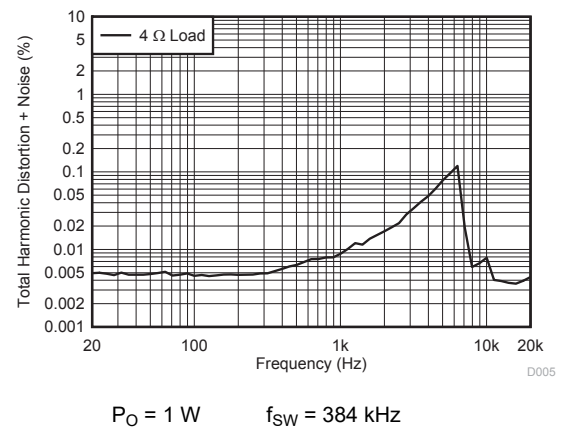


Figure 7-4. THD+N vs Frequency

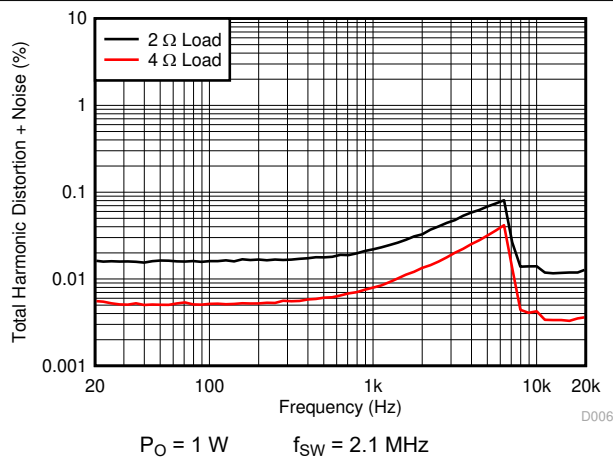


Figure 7-5. THD+N vs Frequency

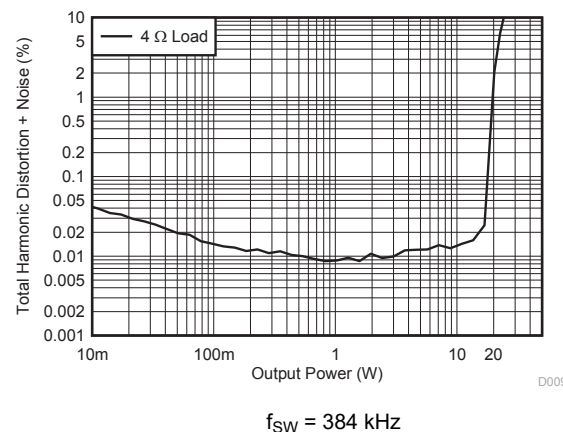


Figure 7-6. THD+N vs Power

## 7.6 Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$ ,  $V_{DD} = 3.3\text{ V}$ ,  $V_{BAT} = PV_{DD} = 14.4\text{ V}$ ,  $R_L = 4\ \Omega$ ,  $f_{IN} = 1\text{ kHz}$ ,  $f_s = 48\text{ kHz}$ ,  $f_{SW} = 2.1\text{ MHz}$ , AES17 filter, default I<sup>2</sup>C settings, see [Figure 10-2](#) and [Figure 10-3](#) (unless otherwise noted)

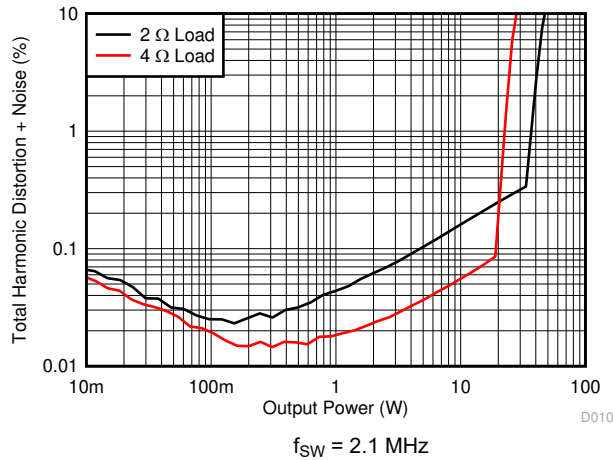


Figure 7-7. THD+N vs Power

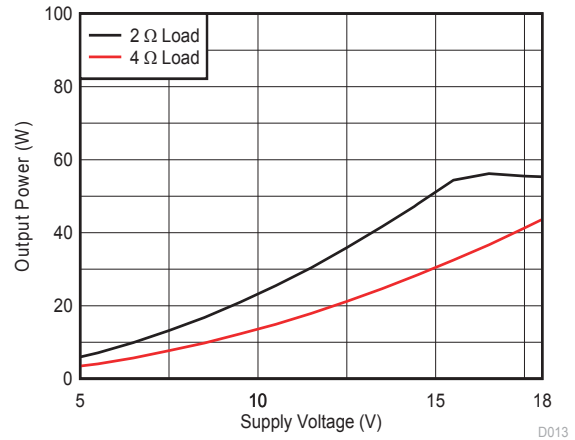


Figure 7-8. Output Power vs Supply Voltage

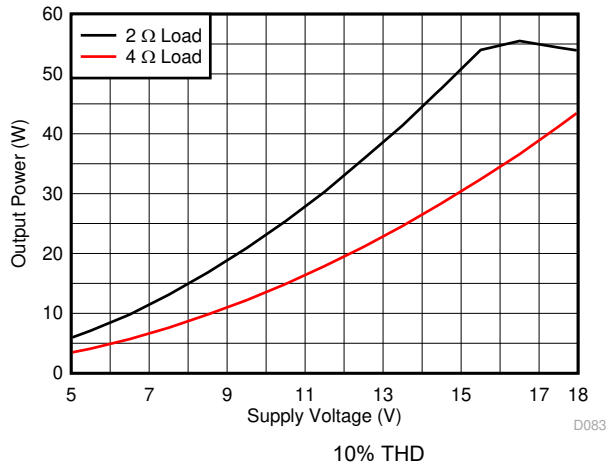


Figure 7-9. Output Power vs Supply Voltage

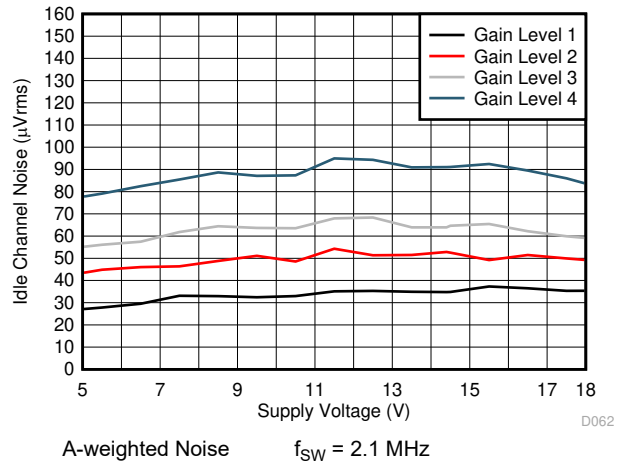


Figure 7-10. Noise vs Supply voltage

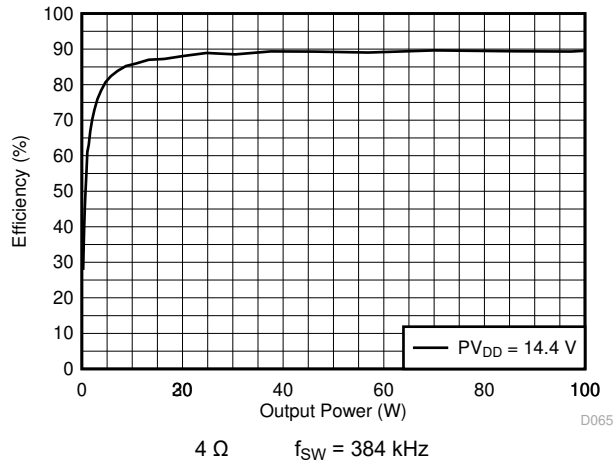


Figure 7-11. PVDD Power Efficiency vs Total Output Power

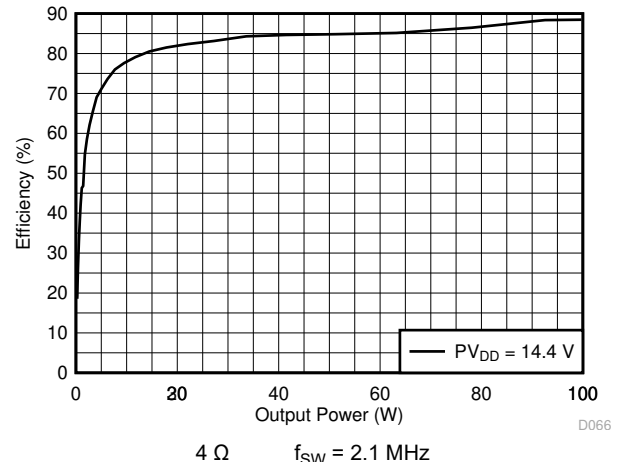


Figure 7-12. PVDD Power Efficiency vs Total Output Power

## 7.6 Typical Characteristics (continued)

$T_A = 25\text{ }^{\circ}\text{C}$ ,  $V_{DD} = 3.3\text{ V}$ ,  $V_{BAT} = PV_{DD} = 14.4\text{ V}$ ,  $R_L = 4\text{ }\Omega$ ,  $f_{IN} = 1\text{ kHz}$ ,  $f_s = 48\text{ kHz}$ ,  $f_{SW} = 2.1\text{ MHz}$ , AES17 filter, default I<sup>2</sup>C settings, see [Figure 10-2](#) and [Figure 10-3](#) (unless otherwise noted)

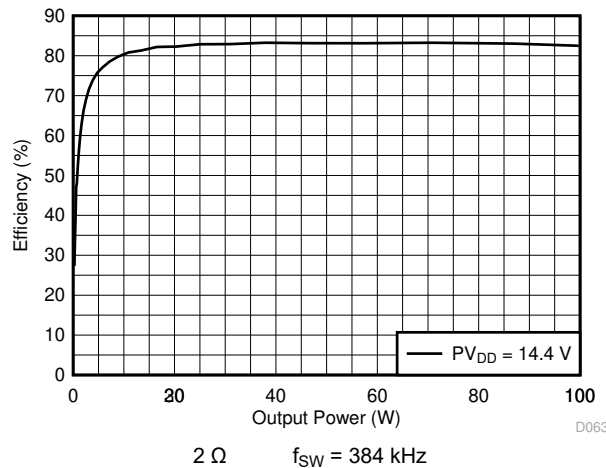


Figure 7-13. PVDD Power Efficiency vs Total Output Power

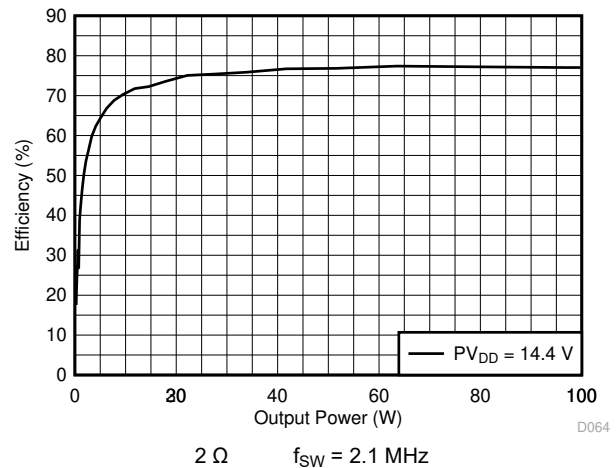


Figure 7-14. PVDD Power Efficiency vs Total Output Power

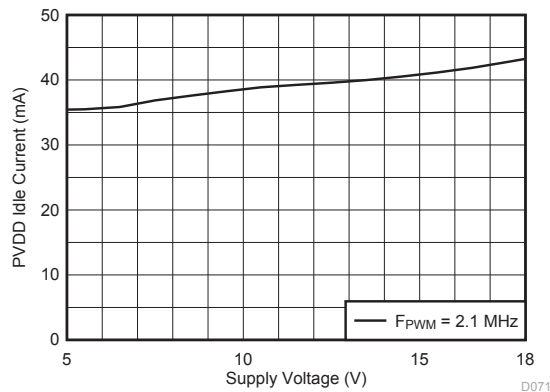


Figure 7-15. PVDD Idle Current vs Voltage

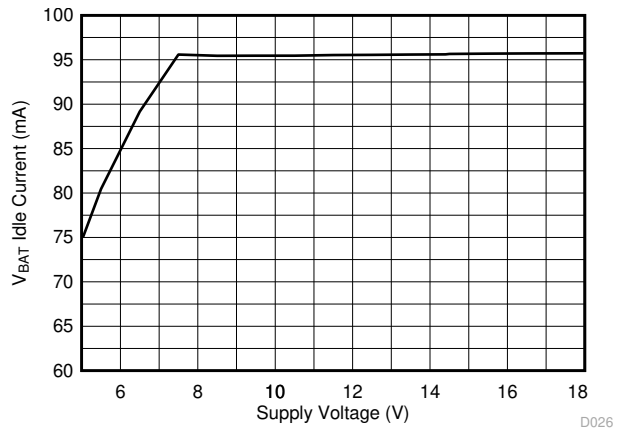


Figure 7-16. VBAT Idle Current vs Voltage

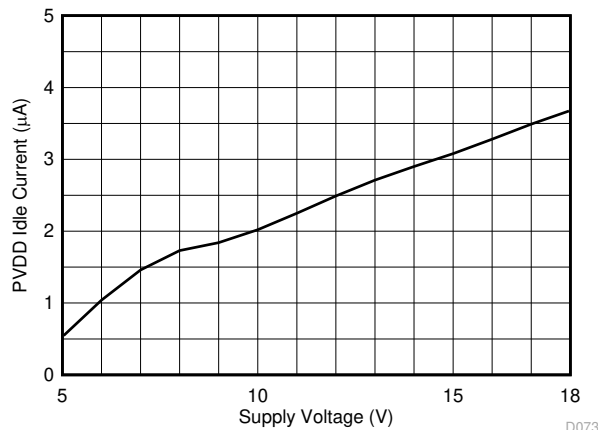


Figure 7-17. PVDD Standby Current vs Voltage

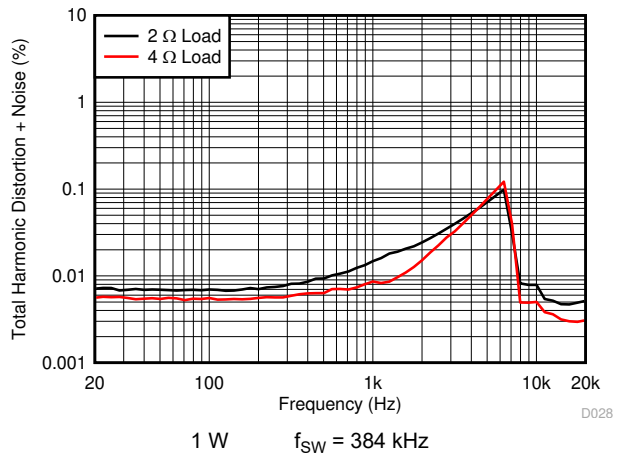
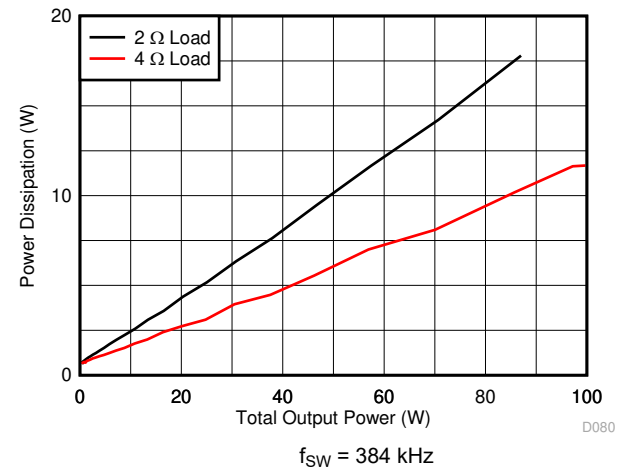
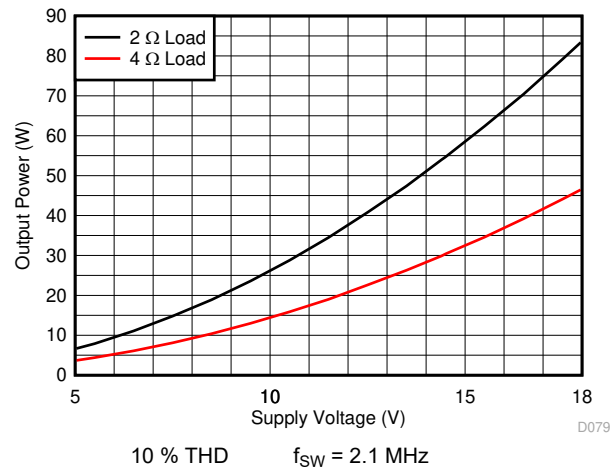
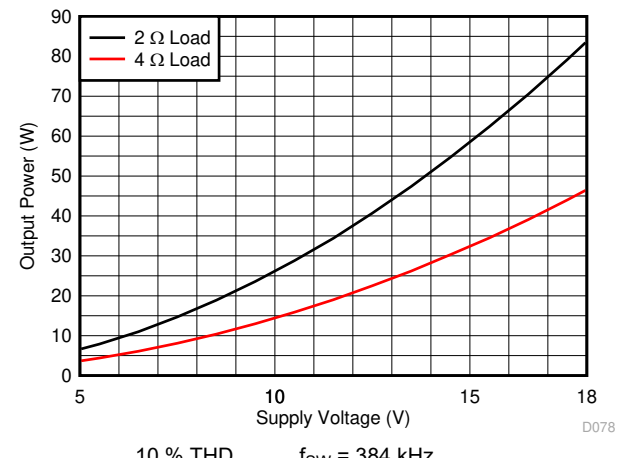
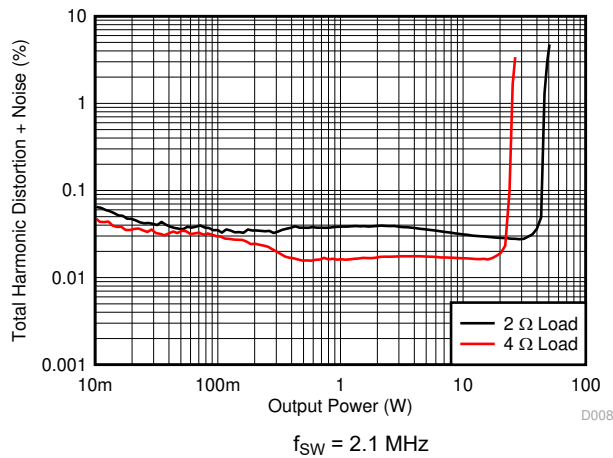
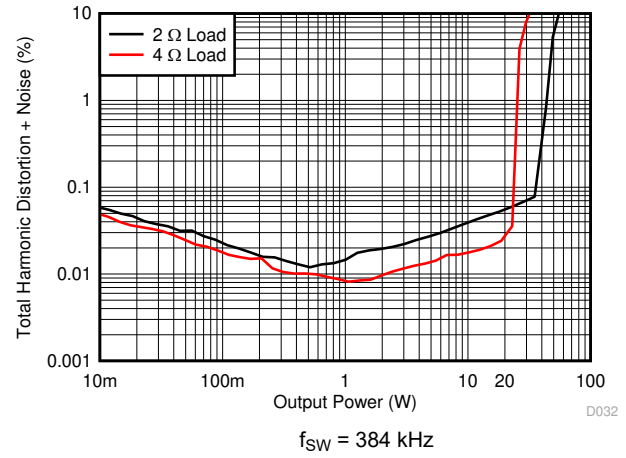
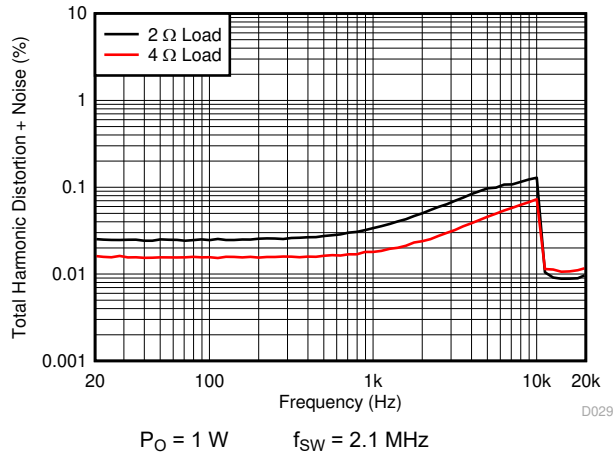


Figure 7-18. PBTl THD+N vs Frequency

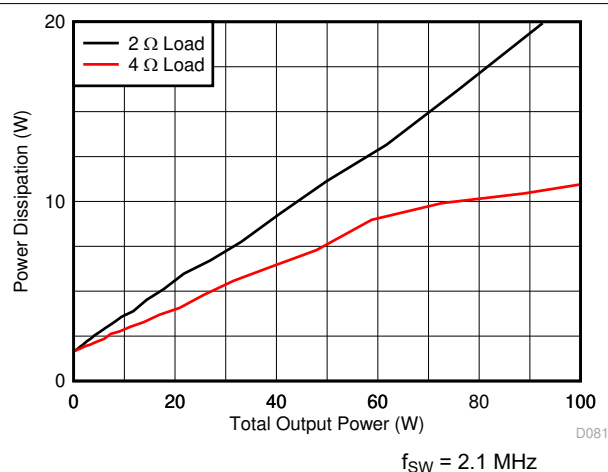
## 7.6 Typical Characteristics (continued)

$T_A = 25\text{ }^{\circ}\text{C}$ ,  $V_{DD} = 3.3\text{ V}$ ,  $V_{BAT} = PV_{DD} = 14.4\text{ V}$ ,  $R_L = 4\text{ }\Omega$ ,  $f_{IN} = 1\text{ kHz}$ ,  $f_s = 48\text{ kHz}$ ,  $f_{SW} = 2.1\text{ MHz}$ , AES17 filter, default I<sup>2</sup>C settings, see [Figure 10-2](#) and [Figure 10-3](#) (unless otherwise noted)



## 7.6 Typical Characteristics (continued)

$T_A = 25\text{ }^{\circ}\text{C}$ ,  $V_{VDD} = 3.3\text{ V}$ ,  $V_{BAT} = P_{VDD} = 14.4\text{ V}$ ,  $R_L = 4\text{ }\Omega$ ,  $f_{IN} = 1\text{ kHz}$ ,  $f_s = 48\text{ kHz}$ ,  $f_{SW} = 2.1\text{ MHz}$ , AES17 filter, default I<sup>2</sup>C settings, see [Figure 10-2](#) and [Figure 10-3](#) (unless otherwise noted)



**Figure 7-25. Power Dissipation vs Total Output Power**

## 8 Parameter Measurement Information

The parameters for the TAS6424MS-Q1 device were measured using the circuit in [Figure 10-2](#).

For measurements with 2.1 MHz switching frequency the 3.3  $\mu$ H inductor from the TAS6424MS-Q1 EVM is used.

For measurements with 384 kHz switching frequency a 10  $\mu$ H inductor was used.

## 9 Detailed Description

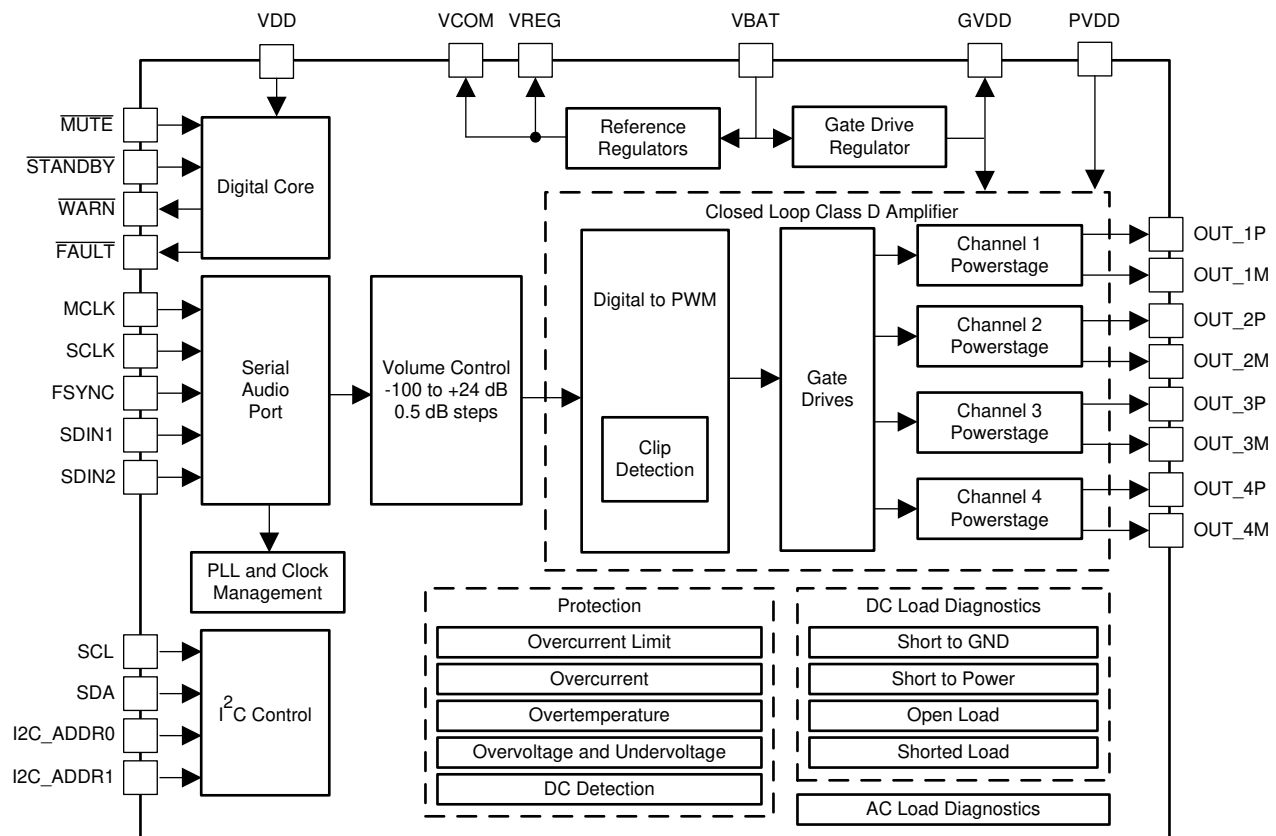
### 9.1 Overview

The TAS6424MS-Q1 is a four-channel digital-input Class-D audio amplifier specifically tailored for use in the automotive industry. The device is designed for vehicle battery operation. This ultra-efficient Class-D technology allows for reduced power consumption, reduced PCB area and reduced heat. The device realizes an audio sound-system design with smaller size and lower weight than traditional Class-AB solutions.

The core design blocks are as follows:

- Serial audio port
- Clock management
- High-pass filter and volume control
- Pulse width modulator (PWM) with output stage feedback
- Gate drive
- Power FETs
- Diagnostics
- Protection
- Power supply
- I<sup>2</sup>C serial communication bus

### 9.2 Functional Block Diagram



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## 9.3 Feature Description

### 9.3.1 Serial Audio Port

The serial audio port (SAP) receives audio in either I<sup>2</sup>S, left justified, right justified, or TDM formats.

Settings for the serial audio port are programmed in the SAP control register (address 0x03), see the [セクション 9.6.4](#) section.

図 9-1 shows the digital audio data connections for I<sup>2</sup>S and TDM8 mode for an eight channel system.

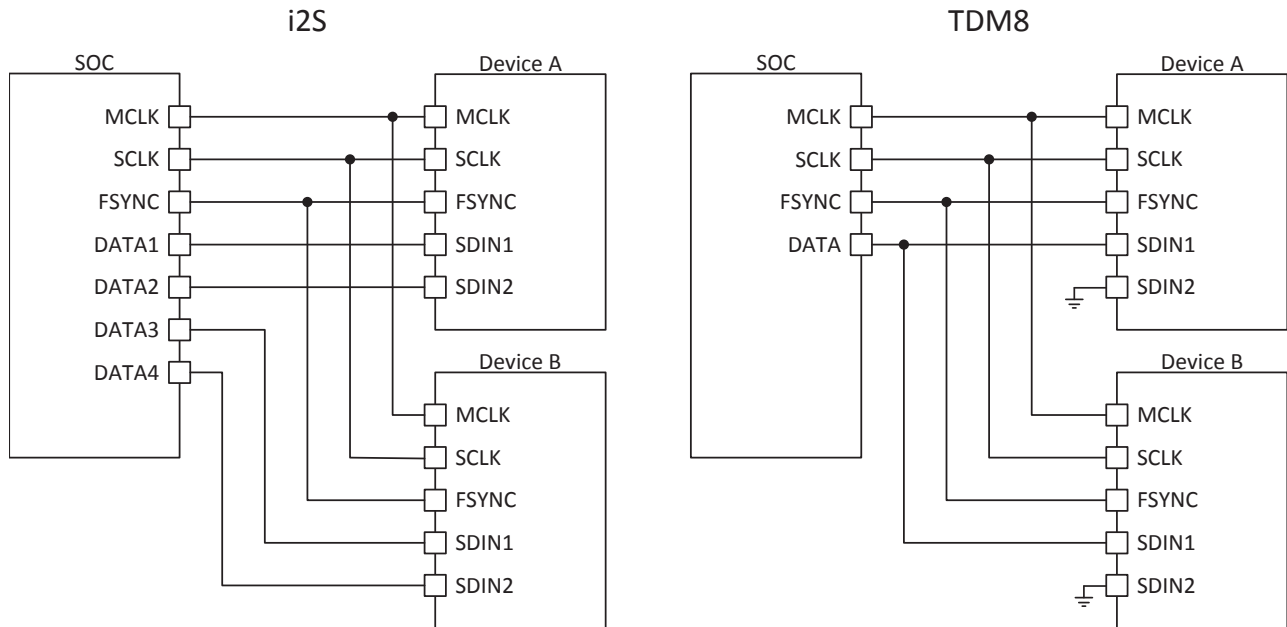


図 9-1. Digital-Audio Data Connection

#### 9.3.1.1 I<sup>2</sup>S Mode

I<sup>2</sup>S timing uses the FSYNC pin to define when the data being transmitted is for the left channel and when the data is for the right channel. The FSYNC pin is low for the left channel and high for the right channel. The bit clock, SCLK, runs at  $32 \times f_s$  or  $64 \times f_s$  and is used to clock in the data. A delay of one bit clock occurs from the time the FSYNC signal changes state to the first bit of data on the data lines. The data is presented in 2s-complement form (MSB-first). The data is valid on the rising edge of the bit clock and is used to clock in the data.

#### 9.3.1.2 Left-Justified Timing

Left-justified (LJ) timing also uses the FSYNC pin to define when the data being transmitted is for the left channel and when the data is for the right channel. The FSYNC pin is high for the left channel and low for the right channel. A bit clock running at  $32 \times f_s$  or  $64 \times f_s$  is used to clock in the data. The first bit of data appears on the data lines at the same time FSYNC toggles. The data is written MSB-first and is valid on the rising edge of the bit clock. Digital words can be 16-bits or 24-bits wide and pad any unused trailing data-bit positions in the left-right (L/R) frame with zeros.

#### 9.3.1.3 Right-Justified Timing

Right-justified (RJ) timing also uses the FSYNC pin to define when the data being transmitted is for the left channel and when the data is for the right channel. The FSYNC pin is high for the left channel and low for the right channel. A bit clock running at  $32 \times f_s$  or  $64 \times f_s$  is used to clock in the data. The first bit of data appears on the data 8-bit clock periods (for 24-bit data) after the FSYNC pin toggles. In RJ mode the LSB of data is always

clocked by the last bit clock before the FSYNC pin transitions. The data is written MSB-first and is valid on the rising edge of bit clock. The device pads the unused leading data-bit positions in the L/R frame with zeros.

### 9.3.1.4 TDM Mode

TDM mode supports 4 or 8 channels of audio data. The TDM mode is automatically selected when the TDM clocks are present. The device can be configured through I<sup>2</sup>C to use different stereo pairs in the TDM data stream. The TDM mode supports 16-bit, 24-bit, and 32-bit input data lengths

In TDM mode, SCLK must be  $128 \times f_s$  or  $256 \times f_s$ , depending on the TDM slot size. In TDM mode SCLK and MCLK can be connected together. If SCLK and MCLK are connected together or the frequency of SCLK and MCLK is equal, FSYNC should be minimum 2 MCLK pulses long.

In TDM mode, the SDIN1 pin (pin 15) is used for digital audio data. TI recommends to connect the unused SDIN2 pin (pin 16) to ground. 表 9-1 lists register settings for the TDM channel selection.

**表 9-1. TDM Channel Selection**

| REGISTER SETTING |               | TDM8 CHANNEL SLOT |     |     |     |     |     |     |     |
|------------------|---------------|-------------------|-----|-----|-----|-----|-----|-----|-----|
| 0x03<br>BIT 5    | 0x03<br>BIT 3 | 1                 | 2   | 3   | 4   | 5   | 6   | 7   | 8   |
| 0                | 0             | CH1               | CH2 | CH3 | CH4 | —   | —   | —   | —   |
| 1                | 0             | —                 | —   | —   | —   | CH1 | CH2 | CH3 | CH4 |
| 0                | 1             | CH3               | CH4 | CH1 | CH2 | —   | —   | —   | —   |
| 1                | 1             | —                 | —   | —   | —   | CH3 | CH4 | CH1 | CH2 |

If PBTL mode is programmed for channel 1/2 or channel 3/4 the datasource can be set according to 表 9-2.

**表 9-2. TDM Channel Selection in PBTL Mode**

| REGISTER SETTING |               |               | TDM8 CHANNEL SLOT |               |               |               |               |               |               |               |
|------------------|---------------|---------------|-------------------|---------------|---------------|---------------|---------------|---------------|---------------|---------------|
| 0x03<br>BIT 5    | 0x03<br>BIT 3 | 0x21<br>BIT 6 | 1                 | 2             | 3             | 4             | 5             | 6             | 7             | 8             |
| 0                | 0             | 0             | PBTL<br>CH1/2     | —             | PBTL<br>CH3/4 | —             | —             | —             | —             | —             |
| 1                | 0             | 0             | —                 | —             | —             | —             | PBTL<br>CH1/2 | —             | PBTL<br>CH3/4 | —             |
| 0                | 0             | 1             | —                 | PBTL<br>CH1/2 | —             | PBTL<br>CH3/4 | —             | —             | —             | —             |
| 1                | 0             | 1             | —                 | —             | —             | —             | —             | PBTL<br>CH1/2 | —             | PBTL<br>CH3/4 |
| 0                | 1             | 0             | PBTL<br>CH3/4     | —             | PBTL<br>CH1/2 | —             | —             | —             | —             | —             |
| 1                | 1             | 0             | —                 | —             | —             | —             | PBTL<br>CH3/4 | —             | PBTL<br>CH1/2 | —             |
| 0                | 1             | 1             | —                 | PBTL<br>CH3/4 | —             | PBTL<br>CH1/2 | —             | —             | —             | —             |
| 1                | 1             | 1             | —                 | —             | —             | —             | —             | PBTL<br>CH3/4 | —             | PBTL<br>CH1/2 |

### 9.3.1.5 Supported Clock Rates

The device supports MCLK rates of  $128 \times f_s$ ,  $256 \times f_s$ , or  $512 \times f_s$ .

The device supports SCLK rates of  $32 \times f_s$  or  $64 \times f_s$  in I<sup>2</sup>S, LJ or RJ modes or  $128 \times f_s$ , or  $256 \times f_s$  in TDM mode.

The device supports FSYNC rates of 44.1 kHz, 48 kHz, or 96 kHz.

The maximum clock frequency is 25 MHz. Therefore, for a 96 kHz FSYNC rate, the maximum MCLK rate is  $256 \times f_s$ .

Duty cycle of 50% is required for 128x FSYNC, for 256x and 512x 50% duty cycle is not required.

### 9.3.1.6 Audio-Clock Error Handling

When any kind of clock error, MCLK-FSYNC or SCLK-FSYNC ratio, or clock halt is detected, the device puts all channels into the Hi-Z state. When all audio clocks are within the expected range, the device automatically returns to the state it was in. See the *Electrical Characteristics* table for timing requirements.

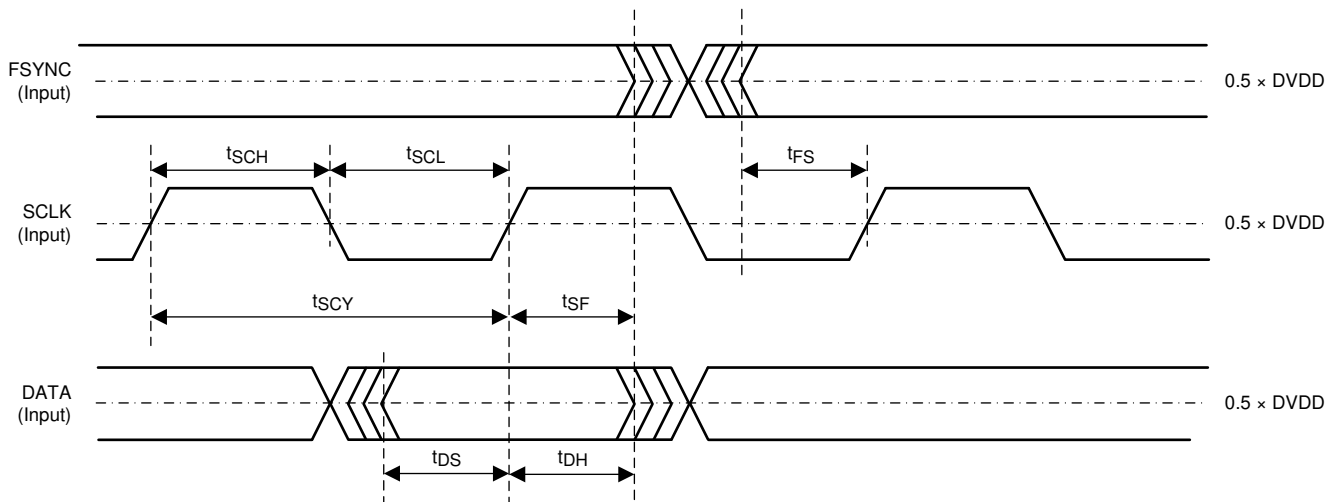


Figure 9-2. Serial Audio Timing

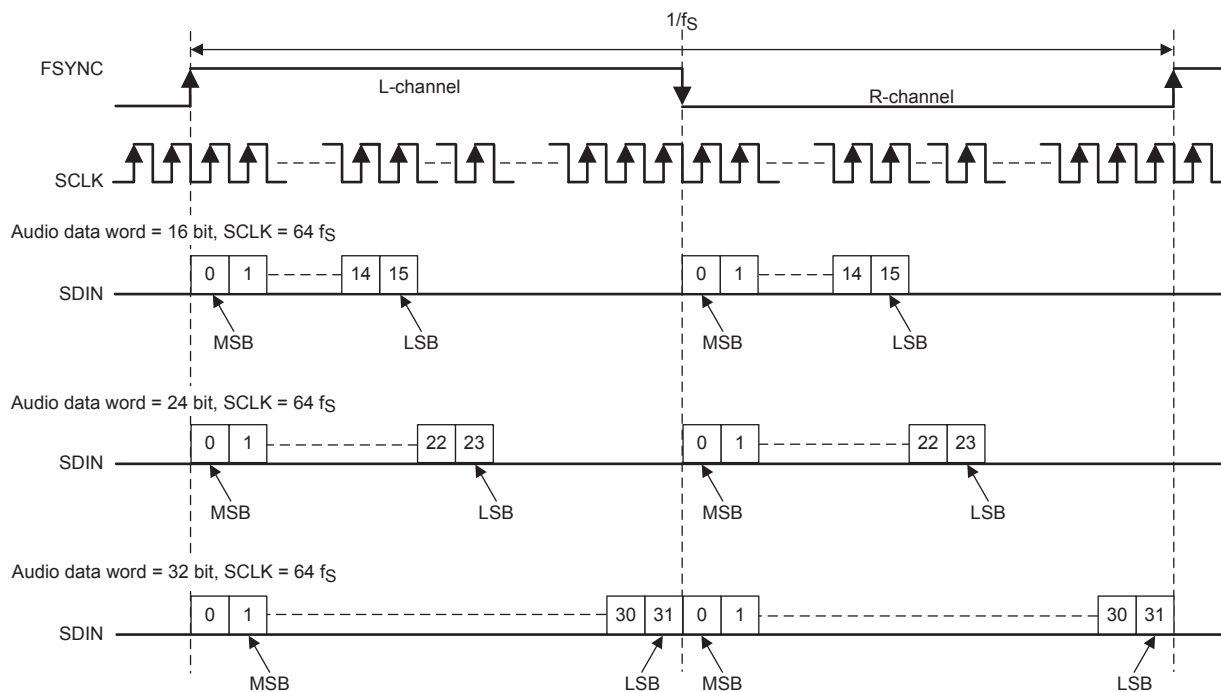


Figure 9-3. Left-Justified Audio Data Format

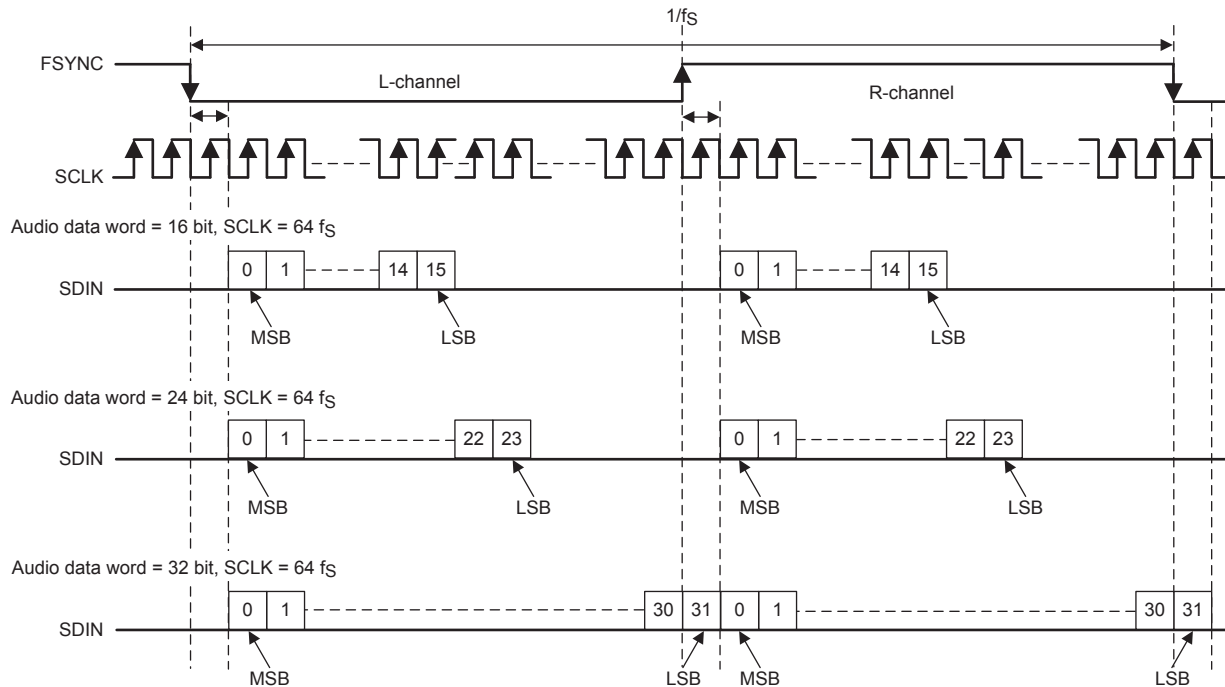
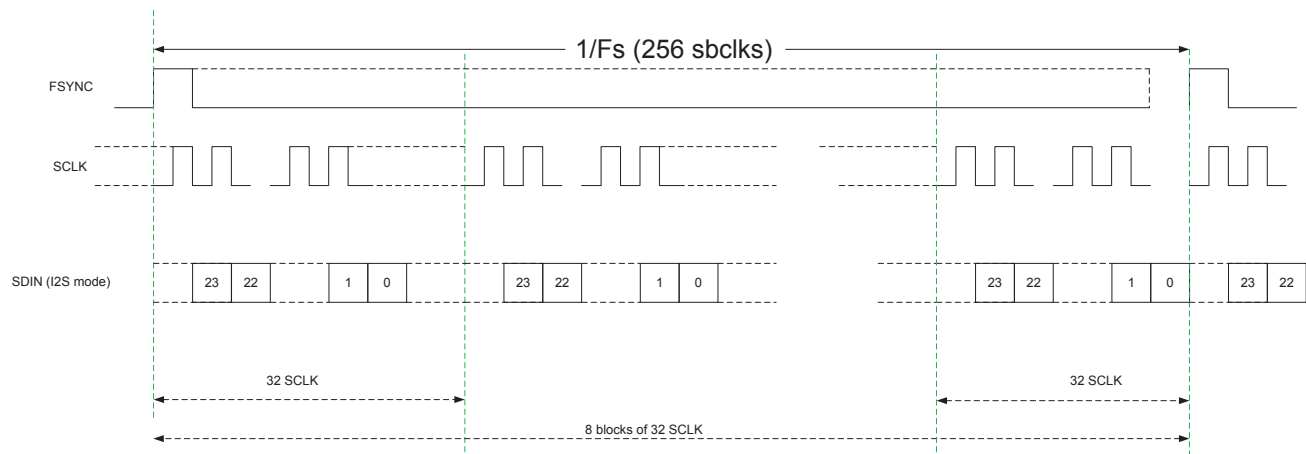


Figure 9-4. I²S Audio Data Format



Audio Data Format: TDM8 mode

Figure 9-5. TDM8 Audio Data Format

### 9.3.2 High-Pass Filter

Direct-current (DC) content in the audio signal can damage speakers. The data path has a high-pass filter to remove any DC from the input signal. The corner frequency is selectable from 4 Hz, 8 Hz, or 15 Hz to 30 Hz with bits 0 through 3 in register 0x26. The default value of –3 dB is approximately 4 Hz for 44.1 kHz or 48 kHz and approximately 8 Hz for 96 kHz sampling rates.

### 9.3.3 Volume Control and Gain

Each channel has an independent digital-volume control with a range from –100 dB to +24 dB with 0.5-dB steps. The volume control is set through I²C. The gain-ramp rate is programmable through I²C to take one step every 1, 2, 4, or 8 FSYNC cycles.

The peak output-voltage swing is also configurable in the gain control register through I<sup>2</sup>C. The four gain settings are 7.5 V, 15 V, 21 V, and 29 V. TI recommends selecting the lowest possible for the expected PVDD operation to optimize output noise and dynamic range performance.

### 9.3.4 High-Frequency Pulse-Width Modulator (PWM)

The PWM converts the PCM input data into a switched signal of varying duty cycle. The PWM modulator is an advanced design with high bandwidth, low noise, low distortion, and excellent stability. The output switching rate is synchronous to the serial audio-clock input and is programmed through I<sup>2</sup>C to be between 8× and 48× the input-sample rate. The option to switch at high frequency allows the use of smaller and lower cost external filtering components. 表 9-3 lists the switch frequency options for bits 4 through 6 in the [Miscellaneous Control 2 Register \(address 0x02\)](#).

**表 9-3. Output Switch Frequency Option**

| INPUT SAMPLE RATE | BIT 6:4 SETTINGS |         |            |          |          |               |
|-------------------|------------------|---------|------------|----------|----------|---------------|
|                   | 000              | 001     | 010 to 100 | 101      | 110      | 111           |
| 44.1 kHz          | 352.8 kHz        | 441 kHz | RESERVED   | 1.68 MHz | 1.94 MHz | 2.12 MHz      |
| 48 kHz            | 384 kHz          | 480 kHz | RESERVED   | 1.82 MHz | 2.11 MHz | Not supported |
| 96 kHz            | 384 kHz          | 480 kHz | RESERVED   | 1.82 MHz | 2.11 MHz | Not supported |

### 9.3.5 Channel-to-Channel Phase Control

The TAS6424MS-Q1 has configurable output PWM phase control to manage conducted and radiated emissions. This feature allows the channel output PWM phase offset, relative to other channels, to be changed..

When the connected output loads have an impedance of 4 Ω or larger, a channel phase offset of 180 degrees, 210 degrees, 225 degrees or 240 degrees can be selected. For loads with an impedance of less than 4 Ω, only the channel phase offsets of 210 degrees, 225 degrees or 240 degrees should be selected and the default value of 180 degree needs to be adjusted.

The phase options available can be found in [Miscellaneous Control 2 Register \(address = 0x02\) \[default = 0x62\]](#).

### 9.3.6 Gate Drive

The gate driver accepts the low-voltage PWM signal and level shifts it to drive a high-current, full-bridge, power-FET stage. The device uses proprietary techniques to optimize EMI and audio performance.

The gate-driver power-supply voltage, GVDD, is internally generated and a decoupling capacitor is connected at pin 9 and pin 10.

The full H-bridge output stages use only NMOS transistors. Therefore, bootstrap capacitors are required for the proper operation of the high side NMOS transistors. A 1-μF ceramic capacitor of quality X7R or better, rated for at least 16 V, must be connected from each output to the corresponding bootstrap input (see the application circuit diagram in [図 10-2](#)).

The bootstrap capacitors connected between the BST pins and corresponding output function as a floating power supply for the high-side N-channel power MOSFET gate drive circuitry. During each high-side switching cycle, the bootstrap capacitors hold the gate-to-source voltage high keeping the high-side MOSFETs turned on.

### 9.3.7 Power FETs

The BTL output for each channel comprises four N-channel 90 mΩ FETs for high efficiency and maximum power transfer to the load. These FETs are designed to handle the fast switching frequency and large voltage transients during load dump.

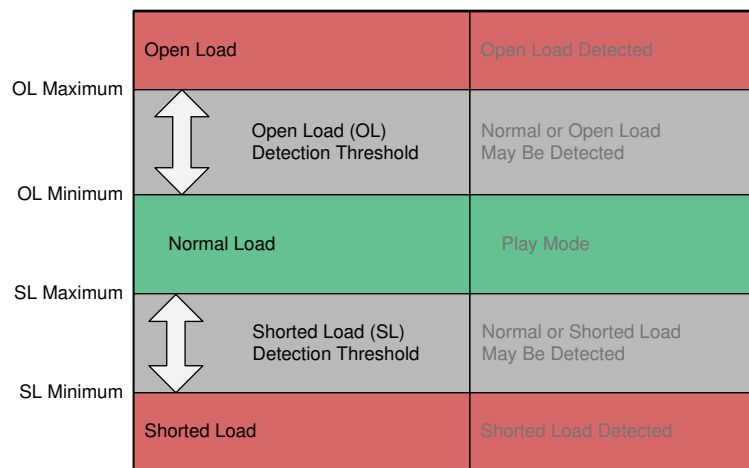
### 9.3.8 Load Diagnostics

The device incorporates both DC-load and AC-load diagnostics, which are used to determine the status of the load. The DC diagnostics are turned on by default, but if a fast startup without diagnostics is required, the DC diagnostics can be bypassed through I<sup>2</sup>C. The DC diagnostics runs when any channel is directed to leave the Hi-Z state and enter the MUTE or PLAY state. The DC diagnostics can also be enabled manually to

run on any or all channels, even if the other channels are playing audio. DC Diagnostics can be started from any operating condition, but if the channel is in PLAY state, then the time to complete the diagnostic is longer because the device must ramp down the audio signal of that channel before transitioning to the Hi-Z state. The DC diagnostics are available as soon as the device supplies are within the recommended operating range. The DC diagnostics do not rely on the audio input clocks to be available to function. DC Diagnostic results are reported for each channel separately through the I<sup>2</sup>C registers.

### 9.3.8.1 DC Load Diagnostics

The DC load diagnostics are used to verify the load connected. The DC diagnostics consists of four tests: short-to-power (S2P), short-to-ground (S2G), open-load (OL), and shorted-load (SL). The S2P and S2G tests trigger if the impedance to GND or a power rail is below that specified in the *Electrical Characteristics* section. The diagnostic detects a short to vehicle battery, even when the supply is boosted. The SL test has an I<sup>2</sup>C-configurable threshold depending on the expected load to be connected. Because the speakers connected to each channel might be different, each channel can be assigned a unique threshold value. The OL test reports if the select channel has a load impedance greater than the limits in the *Electrical Characteristics* section.



✎ 9-6. DC Load Diagnostic Reporting Thresholds

### 9.3.8.2 Line Output Diagnostics

The device also includes an optional test to detect a line-output load. A line-output load is a high-impedance load that is above the open-load (OL) threshold such that the DC-load diagnostics report an OL condition. After an OL condition is detected on a channel, if the line output detection bit is also set, the channel checks if a line-output load is present as well. This test is not pop free, so if an external amplifier is connected it should be muted.

### 9.3.8.3 AC Load Diagnostics

The AC load diagnostic is used to determine the proper connection of a capacitively-coupled speaker or tweeter when used with a passive crossover. The AC load diagnostic is controlled through I<sup>2</sup>C. The AC diagnostics requires an external input signal and reports the approximate load impedance and phase. The selected signal frequency should create current flow through the desired speaker for proper detection. If multiple channels must be tested, the diagnostics should be run in series. The AC load-diagnostic test procedure is as follows.

#### 9.3.8.3.1 Impedance Magnitude Measurement

For load-impedance detection, use the following test procedure:

1. Set the channels to be tested into the Hi-Z state.
2. Set the AC\_DIAGS\_LOOPBACK bit (bit 7 in [register 0x16](#)) to 0.
3. Apply a full-scale input signal from the DSP for the tested channels with the desired frequency (recommended 10 kHz to 20 kHz).

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The device ramps the signal up and down automatically to prevent pops and clicks.

4. Set the device into the AC diagnostic mode (set bit 3 through bit 0 as needed in [register 0x15](#) to 1 for CH1 to CH4. (For PBTL mode, test channel 1 for PBTL12 and channel 3 for PBTL34))
5. Read back the AC impedance ([register 0x17](#) through [register 0x1A](#)).

When the test is complete, the channel reporting register indicates the status change from the AC diagnostic mode to the Hi-Z state. The detected impedance is stored in the appropriate I<sup>2</sup>C register.

The hexadecimal register value must be converted to decimal and used to calculate the impedance magnitude using the following equation:

#### AC Magnitude Calculation

$$\text{Channel } x \text{ Impedance} = \frac{\text{Impedance}_{CHx} \times 2.371 \text{ mV}}{(\text{Gain})(I \text{ mA})} \quad (\text{Ohms}) \quad (1)$$

#### 9.3.8.3.2 Impedance Phase Reference Measurement

The first stage to determine the AC phase is to utilize the built-in loopback mode to determine the reference value for the phase measurement. This reference nullifies any phase offset in the device and measure only the phase of the load. This is measured for channel 1 and 3 only. Channel 2 uses the results of channel 1 for the calculations. Channel 4 uses the results of channel 3 for the calculations. Measure channel 1 and channel 3 sequentially, they cannot be measured at the same time.

For loopback delay detection, use the following test procedure for either BTL mode or PBTL mode:

- BTL mode
  1. Set the AC\_DIAGS\_LOOPBACK bit (bit 7 in [register 0x16](#)) to 1 to enable AC loopback mode.
  2. Apply a 0-dBFS 19 kHz signal and enable AC load diagnostics. CH1 and CH2 reuse the AC sensing loop of CH1 (set bit 3 in [register 0x15](#) to 1). CH3, CH4 reuse the AC sensing loop of CH3 (set bit 1 in [register 0x15](#) to 1).
  3. Read back the 16bit hexadecimal, AC\_LDГ\_PHASE1 value. [Register 0x1B](#) holds the MSB and [register 0x1C](#) holds the LSB.
  4. For channel 1/2 set bit 3 in [register 0x15](#) to 0. For channel 3/4 set bit 1 in [register 0x15](#) to 0.
- PBTL mode
  1. Set the AC\_DIAGS\_LOOPBACK bit (bit 7 in [register 0x16](#)) to 1 to enable AC loopback mode.
  2. Set the PBTL CH12 and PBTL CH34 bits (see [register 0x00](#)) to 0 without toggling SDz pin to enter BTL mode only for load diagnostics.
  3. Apply a 0 dBFS 19 kHz signal and enable AC load diagnostics. For PBTL\_12, enable the AC sensing loop of CH1 (set bit 3 in [register 0x15](#) to 1). For PBTL\_34, enable the AC sensing loop of CH3 (set bit 1 in [register 0x15](#) to 1).
  4. Read back the AC\_LDГ\_PHASE1 value. [Register 0x1B](#) holds the MSB and [register 0x1C](#) holds the LSB.
  5. Set the PBTL CH12 and PBTL CH34 bits (see [register 0x00](#)) to 1 to go back to PBTL mode for load diagnostics.
  6. For PBTL\_12 set bit 3 in [register 0x15](#) to 0. For PBTL\_34 set bit 1 in [register 0x15](#) to 0.

When the test is complete, the channel reporting register indicates the status change from the AC diagnostic mode to the Hi-Z state. The detected impedance is stored in the appropriate I<sup>2</sup>C register.

#### 9.3.8.3.3 Impedance Phase Measurement

After performing the phase reference measurements, measure the phase of the speaker load. This is performed in the same manner as the reference measurements, except the loopback is disabled in bit 7 [register 0x16](#). Previously, the phase reference is measured on channel 1 and channel 3. In this test stage all four channels are measured. Measure the channels sequentially as they cannot be measured at the same time.

For loopback delay detection, use the following test procedure for either BTL mode or PBTL mode:

- BTL mode
  1. Set the AC\_DIAGS\_LOOPBACK bit (bit 7 in [register 0x16](#)) to 0 to disable AC loopback mode.
  2. Apply a 0-dBFS 19 kHz signal and enable AC load diagnostics. CH1 and CH2 reuse the AC sensing loop of CH1 (set bit 3 in [register 0x15](#) to 1). CH3, CH4 reuse the AC sensing loop of CH3 (set bit 1 in [register 0x15](#) to 1).
  3. Read back the 16 bit hexadecimal, AC\_LDГ\_PHASE1 value. [Register 0x1B](#) holds the MSB and [register 0x1C](#) holds the LSB.
  4. Read back the hexadecimal stimulus value, STI. [register 0x1D](#) holds the MSB and [register 0x1E](#) holds the LSB.
  5. For channel 1/2 set bit 3 in [register 0x15](#) to 0. For channel 3/4 set bit 1 in [register 0x15](#) to 0.

When the test is complete, the channel reporting register indicates the status change from the AC diagnostic mode to the Hi-Z state. The detected impedance is stored in the appropriate I<sup>2</sup>C register.

- PBTL mode
  1. Set the AC\_DIAGS\_LOOPBACK bit (bit 7 in [register 0x16](#)) to 0 to disable AC loopback mode.
  2. Set the PBTL CH12 and PBTL CH34 bits (see [register 0x00](#)) to 0 without toggling SDz pin to enter BTL mode only for load diagnostics.
  3. Apply a 0 dBFS 19 kHz signal and enable AC load diagnostics. For PBTL\_12, enable the AC sensing loop of CH1 (set bit 3 in [register 0x15](#) to 1). For PBTL\_34, enable the AC sensing loop of CH3 (set bit 1 in [register 0x15](#) to 1).
  4. Read back the AC\_LDГ\_PHASE1 value. [register 0x1B](#) holds the MSB and [register 0x1C](#) holds the LSB.
  5. Read back the hexadecimal stimulus value, STI. [register 0x1D](#) holds the MSB and [register 0x1E](#) holds the LSB.
  6. Set the PBTL CH12 and PBTL CH34 bits (see [register 0x00](#)) to 1 to go back to PBTL mode for load diagnostics.
  7. For PBTL\_12 set bit 3 in [register 0x15](#) to 0. For PBTL\_34 set bit 1 in [register 0x15](#) to 0.

The AC phase in degrees is calculated with the *AC Phase Calculation* equation:

$$Phase\_CHx = 360 \left( \frac{Phase\_CHx(LBK) - Phase\_CHx(LDM)}{STI\_CHx(LDM)} \right) \quad (2)$$

Where:

- Phase\_CHx(LBK) is the reference phase measurement. LBK stands for loopback mode
- Phase\_CHx(LDM) is the phase measure of the load. LDM stands for load mode
- STI\_CHx(LDM) is the stimulus value

**表 9-4. AC Impedance Code to Magnitude**

| SETTING                           | GAIN AT 19 kHz | I(A)  | MEASUREMENT RANGE (Ω) | MAPPING FROM CODE TO MAGNITUDE (Ω/Code) |
|-----------------------------------|----------------|-------|-----------------------|---|
| Gain = 4, I = 10 mA (recommended) | 4.28           | 0.01  | 12                    | 0.05832                                 |
| Gain = 4, I = 19 mA               | 4.28           | 0.019 | 6                     | 0.0307                                  |
| Gain = 1, I = 10 mA (recommended) | 1              | 0.01  | 48                    | 0.2496                                  |
| Gain = 1, I = 19 mA               | 1              | 0.019 | 24                    | 0.1314                                  |

### 9.3.9 Protection and Monitoring

#### 9.3.9.1 Overcurrent Limit ( $I_{LIMIT}$ )

The overcurrent limit terminates each PWM pulse to limit the output current flow when the current limit ( $I_{LIMIT}$ ) is exceeded. Power is limited, but operation continues without disruption and prevents undesired shutdown for transient music events.  $I_{LIMIT}$  is not reported as a fault condition to either registers or the  $\overline{FAULT}$  pin but as warning condition to the  $\overline{WARN}$  pin and [ILIMIT Status Register \(address = 0x25\)](#). Each channel is independently monitored and limited. The two programmable levels can be set by bit 4 in the [Miscellaneous Control 1 register \(address 0x01\)](#).

#### 9.3.9.2 Overcurrent Shutdown ( $I_{SD}$ )

If the output load current reaches  $I_{SD}$ , such as an output short to GND, then a peak current limit occurs, which shuts down the channel. The time to shutdown the channel varies depending on the severity of the short condition. The affected channel is placed into the Hi-Z state, the fault is reported to the register, and the  $\overline{FAULT}$  pin is asserted. The device remains in this state until the CLEAR FAULT bit is set in [Miscellaneous Control 3 Register, 0x21](#) bit 7. After clearing this bit and if the diagnostics are enabled, the device automatically starts diagnostics on the channel and, if no load failure is found, the device restarts. If a load fault is found the device continues to rerun the diagnostics once per second. Because this hiccup mode uses the diagnostics, no high current is created. If the diagnostics are disabled, the device sets the state for that channel to Hi-Z and requires the MCU to take the appropriate action, setting the CLEAR FAULT bit after the fault got removed, in order to return to Play state.

Two programmable levels can be set by bit 4 in the [Miscellaneous Control 1 register \(address 0x01\)](#).

#### 9.3.9.3 DC Detect

This circuit detects a DC offset continuously during normal operation at the output of the amplifier. If the DC offset exceeds the threshold, that channel is placed in the Hi-Z state, the fault is reported to the I<sup>2</sup>C register, and the  $\overline{FAULT}$  pin is asserted. A register bit can be used to mask reporting to the  $\overline{FAULT}$  pin if required.

#### 9.3.9.4 Clip Detect

The clip detect is reported on the  $\overline{WARN}$  pin if 100% duty-cycle PWM is reached for a minimum number of PWM cycles set by the [Clip Window Register \(address 0x23\)](#). The default is 20 PWM cycles. If any channel is clipping, the clipping is reported to the pin. The clip detect is latched and can be cleared by I<sup>2</sup>C. Masking the clip reporting to the pin is possible through I<sup>2</sup>C. If desired, the Clip Detect can be configured to be non-latching in [Clip Control Register \(address = 0x22\)](#). In non-latching mode, Clip Detect is reported when the PWM duty cycle reaches 100%, and deasserted once the PWM duty cycle falls below 100%.

#### 9.3.9.5 Global Overtemperature Warning (OTW), Overtemperature Shutdown (OTSD)

Four overtemperature warning levels are available in the device (see the [Register Maps](#) section for thresholds). When the junction temperature exceeds the warning level, the  $\overline{WARN}$  pin is asserted, unless the mask bit has been set to disable reporting. The device functions until the OTSD value is reached at which point all channels are placed in the Hi-Z state, and the  $\overline{FAULT}$  pin is asserted. By default, the device remains shut down after the temperature drops to normal levels. This configuration can be changed in bit 3 of the [Miscellaneous Control 3 Register \(address = 0x21\)](#) to auto-recovery: When the junction temperature returns to normal levels, the device

automatically recovers and places the channel into the state indicated by the state control register. Note that even in auto-recovery configuration the FAULT pin remains asserted until the CLEAR FAULT bit (bit 7) is set in [register 0x21](#).

#### 9.3.9.6 Channel Overtemperature Warning [OTW(i)] and Shutdown [OTSD(i)]

In addition to the global OTW, each channel also has an individual overtemperature warning and shutdown. If a channel exceeds the OTW(i) threshold, the warning register bit is set as the WARN pin is asserted, unless the mask bit has been set to disable reporting. If the channel temperature exceeds the OTSD(i) threshold then the channel goes to the Hi-Z state and either remains there or auto-recovers to the state indicated by the state control register when the temperature drops below the OTW(i) threshold, depending on the setting of bit 3 of the [Miscellaneous Control 3 Register \(address = 0x21\)](#).

#### 9.3.9.7 Undervoltage (UV) and Power-On-Reset (POR)

The undervoltage (UV) protection detects low voltages on the PVDD and VBAT pins. In the event of an UV condition, the FAULT pin is asserted, and the I<sup>2</sup>C register is updated. A power-on reset (POR) on the VDD pin causes the I<sup>2</sup>C to go to the high-impedance (Hi-Z) state, and all registers are reset to default values. At power-on or after a POR event, the POR warning bit and WARN pin are asserted.

#### 9.3.9.8 Overvoltage (OV) and Load Dump

The overvoltage (OV) protection detects high voltages on the PVDD pin. If the PVDD pin reaches the OV threshold, the FAULT pin is asserted and the I<sup>2</sup>C register is updated. The device can withstand 40 V load-dump voltage spikes.

#### 9.3.10 Power Supply

The device has three power supply inputs, VDD, PVDD, and VBAT, which are described as follows:

**VDD** This pin is a 3.3V supply pin that provides power to the low voltage circuitry.

**VBAT** This pin is a higher voltage supply that can be connected to the vehicle battery or the regulated voltage rail in a boosted system within the recommended limits. For best performance, this rail should be 10 V or higher. See the *Recommended Operating Conditions* table for the maximum supply voltage. This supply rail is used for higher voltage analog circuits but not the output FETs.

**PVDD** This pin is a high-voltage supply that can either be connected to the vehicle battery or to another voltage rail in a boosted system. The PVDD pin supplies the power to the output FETs and can be within the recommended operating limits, even if that is below the VBAT supply, to allow for dynamic voltage systems.

Several on-chip regulators are included for generating the voltages necessary for the internal circuitry. The external pins are provided only for bypass capacitors to filter the supply and should not be used to power other circuits.

The device can withstand fortuitous open ground and power conditions within the absolute maximum ratings for the device. Fortuitous open ground usually occurs when a speaker wire is shorted to ground, allowing for a second ground path through the body diode in the output FETs.

##### 9.3.10.1 Vehicle-Battery Power-Supply Sequence

###### Power-Up Sequence

In a typical system, the VBAT and PVDD supplies are both connected to the vehicle battery and power up at the same time. The VDD supply should be applied after the VBAT and PVDD supplies are within the recommended operating range.

###### 9.3.10.2 Power-Down Sequence

To power-down the device, first set the  $\overline{\text{STANDBY}}$  pin low for at least 15ms before removing PVDD, VBAT or VDD. After 15ms, the power supplies can be removed.

### 9.3.10.3 Boosted Power-Supply Sequence

In this case, the VBAT and PVDD inputs are not connected to the same supply.

When powering up, apply the VBAT supply first, the VDD supply second, and the PVDD supply last.

When powering down, first set the  $\overline{\text{STANDBY}}$  pin low for at least 15ms before removing PVDD, VBAT or VDD. After 15 ms, the power supplies can be removed.

### 9.3.11 Hardware Control Pins

The device has four pins for control and device status:  $\overline{\text{FAULT}}$ ,  $\overline{\text{MUTE}}$ ,  $\overline{\text{WARN}}$ , and  $\overline{\text{STANDBY}}$ .

#### 9.3.11.1 $\overline{\text{FAULT}}$

The  $\overline{\text{FAULT}}$  pin reports faults and is active low under any of the following conditions:

- Any channel faults (overcurrent or DC detection)
- Overtemperature shutdown
- Overvoltage or undervoltage conditions on the VBAT or PVDD pins
- Clock errors

For all listed faults, the  $\overline{\text{FAULT}}$  pin remains asserted after the fault condition is rectified. Deassert the  $\overline{\text{FAULT}}$  pin by writing the CLEAR FAULT bit (bit 7) in [register 0x21](#).

The register reports for all fault reports remain asserted until they are cleared by writing the CLEAR FAULT bit (bit 7) in [register 0x21](#).

Register bits are available to mask fault categories from reporting to the  $\overline{\text{FAULT}}$  pin. These bits only mask the setting of the pin and do not affect the register reporting or protection of the device. By default all faults are reported to the pin. See the [Register Maps](#) section for a description of the mask settings.

This pin is an open-drain output with an internal 100 k $\Omega$  pull-up resistor to VDD.

#### 9.3.11.2 $\overline{\text{WARN}}$

This active-low output pin reports audio clipping, overtemperature warnings, overcurrent limit warnings and POR events.

Clipping is reported if any channel is at the maximum modulation for 20 consecutive PWM clocks (default value) which results in a 10- $\mu$ s delay to report the onset of clipping. Changing the number of required consecutive PWM clocks in the [Clip Window Register \(address = 0x23\)](#) impacts the report delay time. The Clip Detect warning bit is sticky in latching mode and can be cleared by the CLEAR FAULT bit (bit 7) in [register 0x21](#).

An overtemperature warning (OTW) is reported if the general temperature or any of the channel temperature warnings are set. The warning temperature can be set through bits 5 and 6 in [Miscellaneous Control 1 Register \(address = 0x01\)](#).

Register bits are available to mask either clipping or OTW reporting to the pin. These bits only mask the setting of the pin and do not affect the register reporting. By default clipping,  $I_{\text{LIMIT}}$  and OTW are reported.

The  $\overline{\text{WARN}}$  pin is latched and can be cleared by writing the CLEAR FAULT bit (bit 7) in [register 0x21](#).

This pin is an open-drain output with an internal 100 k $\Omega$  pull-up resistor to VDD.

#### 9.3.11.3 $\overline{\text{MUTE}}$

This active-low input pin is used for hardware control of the mute and unmute function for all channels.

This pin has a 100 k $\Omega$  internal pull-down resistor.

#### 9.3.11.4 $\overline{\text{STANDBY}}$

When this active-low input pin is asserted, the device goes into shutdown and current draw is limited. This pin can be used to shut down the device rapidly. The outputs are ramped down in less than 5 ms if the device is not already in the Hi-Z state.

This pin has a 100 k $\Omega$  internal pull-down resistor.

## 9.4 Device Functional Modes

### 9.4.1 Operating Modes and Faults

The operating modes and faults are listed in the following tables.

**表 9-5. Operating Modes**

| STATE NAME | OUTPUT FETS          | OSCILLATOR | I <sup>2</sup> C |
|------------|----------------------|------------|------------------|
| STANDBY    | Hi-Z                 | Stopped    | Active           |
| Hi-Z       | Hi-Z                 | Active     | Active           |
| MUTE       | Switching at 50%     | Active     | Active           |
| PLAY       | Switching with audio | Active     | Active           |

**表 9-6. Global Faults and Actions**

| FAULT/<br>EVENT | FAULT/EVENT<br>CATEGORY | MONITORING<br>MODES | REPORTING<br>METHOD                              | ACTION<br>RESULT |
|-----------------|-------------------------|---------------------|--|------------------|
| POR             | Voltage fault           | All                 | I <sup>2</sup> C + $\overline{\text{WARN}}$ pin  | Standby          |
| VBAT UV         |                         | Hi-Z, mute, normal  | I <sup>2</sup> C + $\overline{\text{FAULT}}$ pin | Hi-Z             |
| PVDD UV         |                         |                     |  |                  |
| VBAT or PVDD OV |                         |                     |  |                  |
| OTW             | Thermal warning         | Hi-Z, mute, normal  | I <sup>2</sup> C + $\overline{\text{WARN}}$ pin  | None             |
| OTSD            | Thermal shutdown        | Hi-Z, mute, normal  | I <sup>2</sup> C + $\overline{\text{FAULT}}$ pin | Hi-Z             |

**表 9-7. Channel Faults and Actions**

| FAULT/<br>EVENT      | FAULT/EVENT<br>CATEGORY | MONITORING<br>MODES | REPORTING<br>METHOD                              | ACTION<br>TYPE |
|----------------------|-------------------------|---------------------|--|----------------|
| Clipping             | Warning                 | Mute and play       | I <sup>2</sup> C + $\overline{\text{WARN}}$ pin  | None           |
| Overcurrent limiting | Protection              |                     |  | Current limit  |
| Overcurrent fault    | Output channel fault    |                     | I <sup>2</sup> C + $\overline{\text{FAULT}}$ pin | Hi-Z           |
| DC detect            |                         |                     |  |                |

## 9.5 Programming

### 9.5.1 I<sup>2</sup>C Serial Communication Bus

The device communicates with the system processor through the I<sup>2</sup>C serial communication bus as an I<sup>2</sup>C slave-only device. The processor can poll the device through I<sup>2</sup>C to determine the operating status, configure settings, or run diagnostics. For a complete list and description of all I<sup>2</sup>C controls, see the [Register Maps](#) section.

The device includes two I<sup>2</sup>C address pins, so up to four devices can be used together in a system with no additional bus switching hardware. The I<sup>2</sup>C ADDR<sub>x</sub> pins set the slave address of the device as listed in [表 9-8](#).

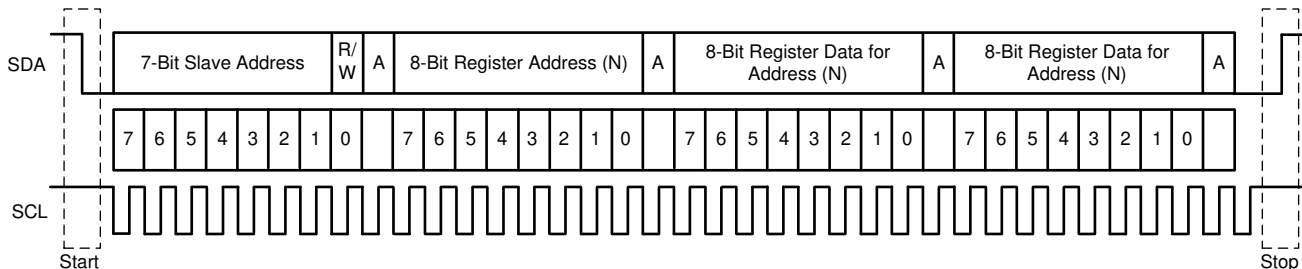
**表 9-8. I<sup>2</sup>C Addresses**

| DESCRIPTION | I <sup>2</sup> C ADDR1 | I <sup>2</sup> C ADDR0 | I <sup>2</sup> C Write | I <sup>2</sup> C Read |
|-------------|------------------------|------------------------|------------------------|-----------------------|
| Device 0    | 0                      | 0                      | 0xD4                   | 0xD5                  |
| Device 1    | 0                      | 1                      | 0xD6                   | 0xD7                  |
| Device 2    | 1                      | 0                      | 0xD8                   | 0xD9                  |
| Device 3    | 1                      | 1                      | 0xDA                   | 0xDB                  |

### 9.5.2 I<sup>2</sup>C Bus Protocol

The device has a bidirectional serial-control interface that is compatible with the Inter IC (I<sup>2</sup>C) bus protocol and supports 100 kbps and 400 kbps data transfer rates for random and sequential write and read operations. The TAS6424MS-Q1 device is a slave-only device that does not support a multimaster bus environment or wait-state insertion. The control interface is used to program the registers of the device and to read device status.

The I<sup>2</sup>C bus uses two signals, SDA (data) and SCL (clock), to communicate between integrated circuits in a system. Data is transferred on the bus serially, one bit at a time. The address and data are transferred in byte (8-bit) format with the most-significant bit (MSB) transferred first. In addition, each byte transferred on the bus is acknowledged by the receiving device with an acknowledge bit. Each transfer operation begins with the master device driving a start condition on the bus and ends with the master device driving a stop condition on the bus. The bus uses transitions on the data terminal (SDA) while the clock is HIGH to indicate a start and stop conditions. A HIGH-to-LOW transition on SDA indicates a start, and a LOW-to-HIGH transition indicates a stop. Normal data bit transitions must occur within the low time of the clock period. The master generates the 7-bit slave address and the read/write (R/W) bit to open communication with another device and then wait for an acknowledge condition. The device holds SDA LOW during the acknowledge-clock period to indicate an acknowledgment. When this occurs, the master transmits the next byte of the sequence. Each device is addressed by a unique 7-bit slave address plus a R/W bit (1 byte). All compatible devices share the same signals via a bidirectional bus using a wired-AND connection. An external pullup resistor must be used for the SDA and SCL signals to set the HIGH level for the bus. The number of bytes that can be transmitted between start and stop conditions is unlimited. When the last word transfers, the master generates a stop condition to release the bus.



**図 9-7. Typical I<sup>2</sup>C Sequence**

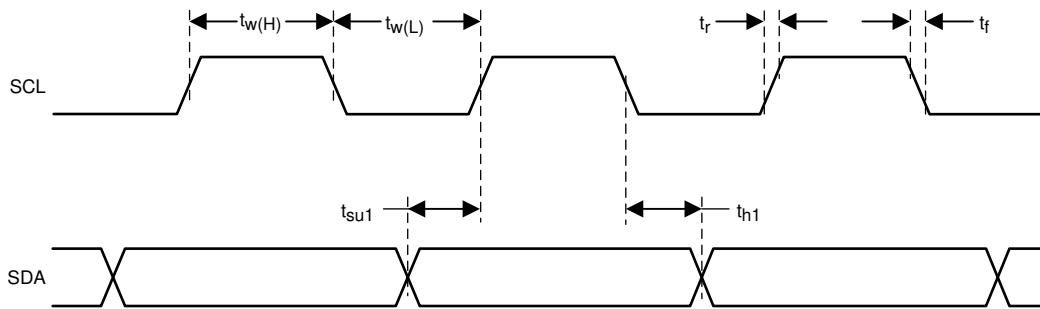


FIG 9-8. SCL and SDA Timing

Use the I<sup>2</sup>C ADDR<sub>x</sub> pins to program the device slave address. Read and write data can be transmitted using single-byte or multiple-byte data transfers.

### 9.5.3 Random Write

As shown in FIG 9-9, a single-byte data-write transfer begins with the master device transmitting a start condition followed by the I<sup>2</sup>C device address and the R/W bit. The R/W bit determines the direction of the data transfer. For a write data transfer, the R/W bit is a 0. After receiving the correct I<sup>2</sup>C device address and the R/W bit, the device responds with an acknowledge bit. Next, the master transmits the address byte or bytes corresponding to the internal memory address being accessed. After receiving the address byte, the device again responds with an acknowledge bit. Next, the master device transmits the data byte to be written to the memory address being accessed. After receiving the data byte, the device again responds with an acknowledge bit. Finally, the master device transmits a stop condition to complete the single-byte data-write transfer.

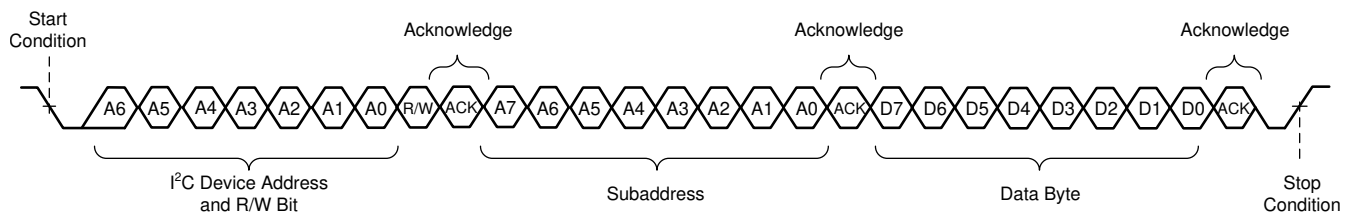


FIG 9-9. Random Write Transfer

### 9.5.4 Sequential Write

A sequential data-write transfer is identical to a single-byte data-write transfer except that multiple data bytes are transmitted by the master to the device as shown in FIG 9-10. After receiving each data byte, the device responds with an acknowledge bit and the I<sup>2</sup>C subaddress is automatically incremented by one.

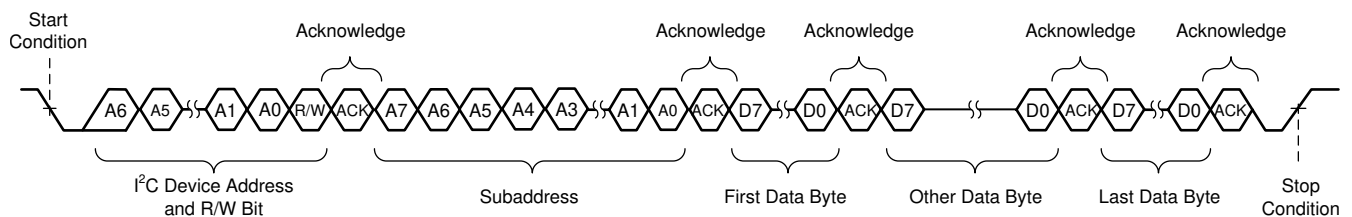
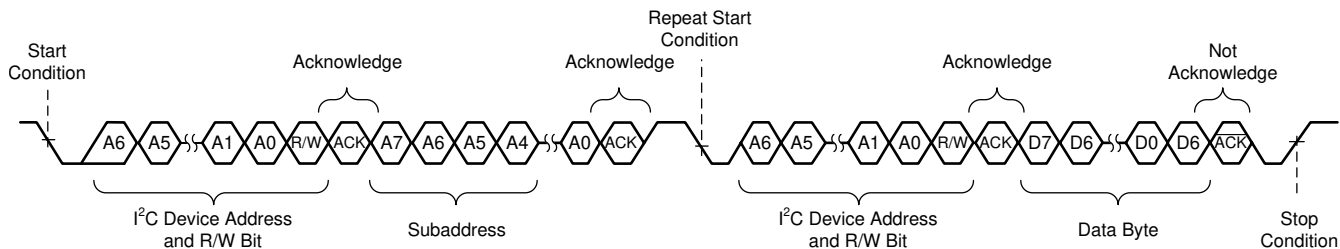


FIG 9-10. Sequential Write Transfer

### 9.5.5 Random Read

As shown in FIG 9-11, a single-byte data-read transfer begins with the master device transmitting a start condition followed by the I<sup>2</sup>C device address and the R/W bit. For the data-read transfer, both a write followed by a read occur. Initially, a write occurs to transfer the address byte or bytes of the internal memory address to be read. As a result, the R/W bit is a 0. After receiving the address and the R/W bit, the device responds with an acknowledge bit. In addition, after sending the internal memory address byte or bytes, the master device transmits another start condition followed by the address and the R/W bit again. This time the R/W bit is a

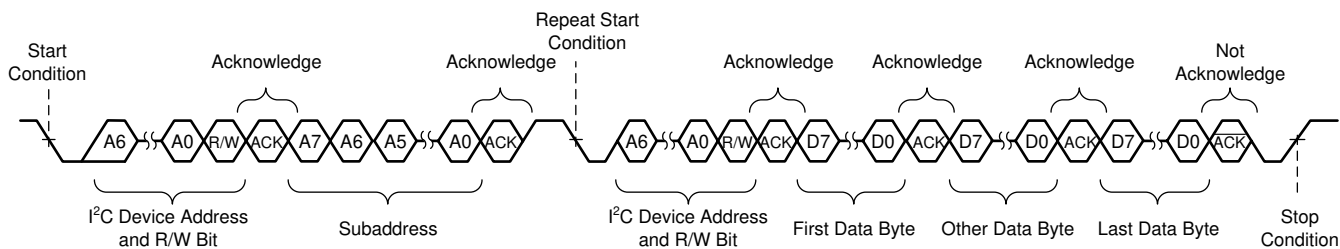
1, indicating a read transfer. After receiving the address and the R/W bit, the device again responds with an acknowledge bit. Next, the device transmits the data byte from the memory address being read. After receiving the data byte, the master device transmits a not-acknowledge followed by a stop condition to complete the single-byte data-read transfer.



**図 9-11. Random Read Transfer**

### 9.5.6 Sequential Read

A sequential data-read transfer is identical to a single-byte data-read transfer except that multiple data bytes are transmitted by the device to the master device as shown in 図 9-12. Except for the last data byte, the master device responds with an acknowledge bit after receiving each data byte and automatically increments the I²C subaddress by one. After receiving the last data byte, the master device transmits a not-acknowledge bit followed by a stop condition to complete the transfer.



**図 9-12. Sequential Read Transfer**

## 9.6 Register Maps

表 9-9. I<sup>2</sup>C Address Register Definitions

| Address | Type | Register Description                           | Section            |
|---------|------|--|--------------------|
| 0x00    | R/W  | Mode Control                                   | <a href="#">Go</a> |
| 0x01    | R/W  | Miscellaneous Control 1                        | <a href="#">Go</a> |
| 0x02    | R/W  | Miscellaneous Control 2                        | <a href="#">Go</a> |
| 0x03    | R/W  | SAP Control (Serial Audio-Port Control)        | <a href="#">Go</a> |
| 0x04    | R/W  | Channel State Control                          | <a href="#">Go</a> |
| 0x05    | R/W  | Channel 1 Volume Control                       | <a href="#">Go</a> |
| 0x06    | R/W  | Channel 2 Volume Control                       | <a href="#">Go</a> |
| 0x07    | R/W  | Channel 3 Volume Control                       | <a href="#">Go</a> |
| 0x08    | R/W  | Channel 4 Volume Control                       | <a href="#">Go</a> |
| 0x09    | R/W  | DC Diagnostic Control 1                        | <a href="#">Go</a> |
| 0x0A    | R/W  | DC Diagnostic Control 2                        | <a href="#">Go</a> |
| 0x0B    | R/W  | DC Diagnostic Control 3                        | <a href="#">Go</a> |
| 0x0C    | R    | DC Load Diagnostic Report 1 (Channels 1 and 2) | <a href="#">Go</a> |
| 0x0D    | R    | DC Load Diagnostic Report 2 (Channels 3 and 4) | <a href="#">Go</a> |
| 0x0E    | R    | DC Load Diagnostic Report 3-Line Output        | <a href="#">Go</a> |
| 0x0F    | R    | Channel State Reporting                        | <a href="#">Go</a> |
| 0x10    | R    | Channel Faults (Overcurrent, DC Detection)     | <a href="#">Go</a> |
| 0x11    | R    | Global Faults 1                                | <a href="#">Go</a> |
| 0x12    | R    | Global Faults 2                                | <a href="#">Go</a> |
| 0x13    | R    | Warnings                                       | <a href="#">Go</a> |
| 0x14    | R/W  | Pin Control                                    | <a href="#">Go</a> |
| 0x15    | R/W  | AC Load Diagnostic Control 1                   | <a href="#">Go</a> |
| 0x16    | R/W  | AC Load Diagnostic Control 2                   | <a href="#">Go</a> |
| 0x17    | R    | AC Load Diagnostic Report Channel 1            | <a href="#">Go</a> |
| 0x18    | R    | AC Load Diagnostic Report Channel 2            | <a href="#">Go</a> |
| 0x19    | R    | AC Load Diagnostic Report Channels 3           | <a href="#">Go</a> |
| 0x1A    | R    | AC Load Diagnostic Report Channels 4           | <a href="#">Go</a> |
| 0x1B    | R    | AC Load Diagnostic Phase Report High           | <a href="#">Go</a> |
| 0x1C    | R    | AC Load Diagnostic Phase Report Low            | <a href="#">Go</a> |
| 0x1D    | R    | AC Load Diagnostic STI Report High             | <a href="#">Go</a> |
| 0x1E    | R    | AC Load Diagnostic STI Report Low              | <a href="#">Go</a> |
| 0x1F    | R    | RESERVED                                       |                    |
| 0x20    | R    | RESERVED                                       |                    |
| 0x21    | R/W  | Miscellaneous Control 3                        | <a href="#">Go</a> |
| 0x22    | R/W  | Clip Control                                   | <a href="#">Go</a> |
| 0x23    | R/W  | Clip Window                                    | <a href="#">Go</a> |
| 0x24    | R/W  | Clip Warning                                   | <a href="#">Go</a> |
| 0x25    | R/W  | ILIMIT Status                                  | <a href="#">Go</a> |
| 0x26    | R/W  | Miscellaneous Control 4                        | <a href="#">Go</a> |
| 0x27    | R    | RESERVED                                       |                    |

### 9.6.1 Mode Control Register (address = 0x00) [default = 0x00]

The Mode Control register is shown in [図 9-13](#) and described in [表 9-10](#).

**図 9-13. Mode Control Register**

| 7     | 6        | 5         | 4         | 3           | 2           | 1           | 0           |
|-------|----------|-----------|-----------|-------------|-------------|-------------|-------------|
| RESET | RESERVED | PBTL CH34 | PBTL CH12 | CH1 LO MODE | CH2 LO MODE | CH3 LO MODE | CH4 LO MODE |
| R/W-0 | R/W-0    | R/W-0     | R/W-0     | R/W-0       | R/W-0       | R/W-0       | R/W-0       |

**表 9-10. Mode Control Field Descriptions**

| Bit | Field       | Type | Reset | Description  |
|-----|-------------|------|-------|--|
| 7   | RESET       | R/W  | 0     | <b>0: Normal operation</b><br>1: Resets the device. Self-clearing, reads back 0.           |
| 6   | RESERVED    | R/W  | 0     | RESERVED   |
| 5   | PBTL CH34   | R/W  | 0     | <b>0: Channels 3 and 4 are in BTL mode</b><br>1: Channels 3 and 4 are in parallel BTL mode |
| 4   | PBTL CH12   | R/W  | 0     | <b>0: Channels 1 and 2 are in BTL mode</b><br>1: Channels 1 and 2 are in parallel BTL mode |
| 3   | CH1 LO MODE | R/W  | 0     | <b>0: Channel 1 is in normal/speaker mode</b><br>1: Channel 1 is in line output mode       |
| 2   | CH2 LO MODE | R/W  | 0     | <b>0: Channel 2 is in normal/speaker mode</b><br>1: Channel 2 is in line output mode       |
| 1   | CH3 LO MODE | R/W  | 0     | <b>0: Channel 3 is in normal/speaker mode</b><br>1: Channel 3 is in line output mode       |
| 0   | CH4 LO MODE | R/W  | 0     | <b>0: Channel 4 is in normal/speaker mode</b><br>1: Channel 4 is in line output mode       |

### 9.6.2 Miscellaneous Control 1 Register (address = 0x01) [default = 0x32]

The Miscellaneous Control 1 register is shown in [図 9-14](#) and described in [表 9-11](#).

**図 9-14. Miscellaneous Control 1 Register**

| 7          | 6           | 5 | 4          | 3           | 2 | 1      | 0 |
|------------|-------------|---|------------|-------------|---|--------|---|
| HPF BYPASS | OTW CONTROL |   | OC CONTROL | VOLUME RATE |   | GAIN   |   |
| R/W-0      | R/W-01      |   | R/W-1      | R/W-00      |   | R/W-10 |   |

**表 9-11. Misc Control 1 Field Descriptions**

| Bit | Field       | Type | Reset | Description   |
|-----|-------------|------|-------|---|
| 7   | HPF BYPASS  | R/W  | 0     | <b>0: High pass filter enabled</b><br>1: High pass filter disabled  |
| 6–5 | OTW CONTROL | R/W  | 01    | 00: Global overtemperature warning set to 140°C<br><b>01: Global overtemperature warning set to 130°C</b><br>10: Global overtemperature warning set to 120°C<br>11: Global overtemperature warning set to 110°C |
| 4   | OC CONTROL  | R/W  | 1     | 0: Overcurrent is level 1<br><b>1: Overcurrent is level 2</b>   |
| 3–2 | VOLUME RATE | R/W  | 00    | <b>00: Volume update rate is 1 step / FSYNC</b><br>01: Volume update rate is 1 step / 2 FSYNCS<br>10: Volume update rate is 1 step / 4 FSYNCS<br>11: Volume update rate is 1 step / 8 FSYNCS                    |

**表 9-11. Misc Control 1 Field Descriptions (continued)**

| Bit | Field | Type | Reset | Description  |
|-----|-------|------|-------|--|
| 1–0 | GAIN  | R/W  | 10    | 00: Gain level 1 = 7.5 V peak output voltage<br>01: Gain Level 2 = 15 V peak output voltage<br><b>10: Gain Level 3 = 21 V peak output voltage</b><br>11: Gain Level 4 = 29 V peak output voltage |

**9.6.3 Miscellaneous Control 2 Register (address = 0x02) [default = 0x62]**

The Miscellaneous Control 2 register is shown in [図 9-15](#) and described in [表 9-12](#).

**図 9-15. Miscellaneous Control 2 Register**

|          |               |   |   |          |         |              |   |
|----------|---------------|---|---|----------|---------|--------------|---|
| 7        | 6             | 5 | 4 | 3        | 2       | 1            | 0 |
| RESERVED | PWM FREQUENCY |   |   | RESERVED | SDM_OSR | OUTPUT PHASE |   |
| R/W-0    | R/W-110       |   |   | R/W-0    | R/W-0   | R/W-10       |   |

**表 9-12. Misc Control 2 Field Descriptions**

| Bit | Field         | Type | Reset | Description   |
|-----|---------------|------|-------|---|
| 7   | RESERVED      | R/W  | 0     | RESERVED  |
| 6–4 | PWM FREQUENCY | R/W  | 110   | 000: $8 \times f_S$ (352.8 kHz / 384 kHz)<br>001: $10 \times f_S$ (441 kHz / 480 kHz)<br>010: RESERVED<br>011: RESERVED<br>100: RESERVED<br>101: $38 \times f_S$ (1.68 MHz / 1.82 MHz)<br><b>110: <math>44 \times f_S</math> (1.94 MHz / 2.11 MHz)</b><br>111: $48 \times f_S$ (2.12 MHz / not supported) |
| 3   | RESERVED      | R/W  | 0     | RESERVED  |
| 2   | SDM_OSR       | R/W  | 0     | <b>0: 64x OSR</b><br>1: 128x OSR  |
| 1–0 | OUTPUT PHASE  | R/W  | 10    | 00: 0 degrees output-phase switching offset<br>01: 30 degrees output-phase switching offset<br><b>10: 45 degrees output-phase switching offset</b><br>11: 60 degrees output-phase switching offset  |

**9.6.4 SAP Control (Serial Audio-Port Control) Register (address = 0x03) [default = 0x04]**

The SAP Control (serial audio-port control) register is shown in [図 9-16](#) and described in [表 9-13](#).

**図 9-16. SAP Control Register**

|                     |   |                      |               |                   |              |   |   |
|---------------------|---|----------------------|---------------|-------------------|--------------|---|---|
| 7                   | 6 | 5                    | 4             | 3                 | 2            | 1 | 0 |
| INPUT SAMPLING RATE |   | 8 Ch TDM SLOT SELECT | TDM SLOT SIZE | TDM SLOT SELECT 2 | INPUT FORMAT |   |   |
| R/W-00              |   | R/W-0                | R/W-0         | R/W-0             | R/W-100      |   |   |

**表 9-13. SAP Control Field Descriptions**

| Bit | Field                | Type | Reset | Description   |
|-----|----------------------|------|-------|---|
| 7–6 | INPUT SAMPLING RATE  | R/W  | 00    | <b>00: 44.1 kHz</b><br>01: 48 kHz<br>10: 96 kHz<br>11: RESERVED |
| 5   | 8 Ch TDM SLOT SELECT | R/W  | 0     | <b>0: First four TDM slots</b><br>1: Last four TDM slots        |

**表 9-13. SAP Control Field Descriptions (continued)**

| Bit | Field             | Type | Reset | Description  |
|-----|-------------------|------|-------|--|
| 4   | TDM SLOT SIZE     | R/W  | 0     | <b>0: TDM slot size is 24-bit or 32-bit</b><br>1: TDM slot size is 16-bit  |
| 3   | TDM SLOT SELECT 2 | R/W  | 0     | <b>0: Normal</b><br>1: swap channel 1/2 with channel 3/4   |
| 2–0 | INPUT FORMAT      | R/W  | 100   | 000: 24-bit right justified<br>001: 20-bit right justified<br>010: 18-bit right justified<br>011: 16-bit right justified<br><b>100: I<sup>2</sup>S (16-bit or 24-bit)</b><br>101: Left justified (16-bit or 24-bit)<br>110: DSP mode (16-bit or 24-bit)<br>111: RESERVED |

### 9.6.5 Channel State Control Register (address = 0x04) [default = 0x55]

The Channel State Control register is shown in [図 9-17](#) and described in [表 9-14](#).

**図 9-17. Channel State Control Register**

|                   |   |                   |   |                   |   |                   |   |
|-------------------|---|-------------------|---|-------------------|---|-------------------|---|
| 7                 | 6 | 5                 | 4 | 3                 | 2 | 1                 | 0 |
| CH1 STATE CONTROL |   | CH2 STATE CONTROL |   | CH3 STATE CONTROL |   | CH4 STATE CONTROL |   |
| R/W-01            |   | R/W-01            |   | R/W-01            |   | R/W-01            |   |

**表 9-14. Channel State Control Field Descriptions**

| Bit | Field             | Type | Reset | Description  |
|-----|-------------------|------|-------|--|
| 7–6 | CH1 STATE CONTROL | R/W  | 01    | 00: PLAY<br><b>01: Hi-Z</b><br>10: MUTE<br>11: DC load diagnostics |
| 5–4 | CH2 STATE CONTROL | R/W  | 01    | 00: PLAY<br><b>01: Hi-Z</b><br>10: MUTE<br>11: DC load diagnostics |
| 3–2 | CH3 STATE CONTROL | R/W  | 01    | 00: PLAY<br><b>01: Hi-Z</b><br>10: MUTE<br>11: DC load diagnostics |
| 1–0 | CH4 STATE CONTROL | R/W  | 01    | 00: PLAY<br><b>01: Hi-Z</b><br>10: MUTE<br>11: DC load diagnostics |

### 9.6.6 Channel 1 Through 4 Volume Control Registers (address = 0x05–0x08) [default = 0xCF]

The Channel 1 Through 4 Volume Control registers are shown in 图 9-18 and described in 表 9-15.

图 9-18. Channel x Volume Control Register

| 7           | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|-------------|---|---|---|---|---|---|---|
| CH x VOLUME |   |   |   |   |   |   |   |
| R/W-CF      |   |   |   |   |   |   |   |

表 9-15. Ch x Volume Control Field Descriptions

| Bit | Field       | Type | Reset | Description  |
|-----|-------------|------|-------|--|
| 7–0 | CH x VOLUME | R/W  | 0xCF  | 8-Bit Volume Control for each channel, register address for Ch1 is 0x05, Ch2 is 0x06, Ch3 is 0x07 and Ch4 is 0x08, 0.5 dB/step:<br>0xFF: 24 dB<br><b>0xCF: 0 dB</b><br>0x07: –100 dB<br>< 0x07: MUTE |

### 9.6.7 DC Load Diagnostic Control 1 Register (address = 0x09) [default = 0x00]

The DC Diagnostic Control 1 register is shown in 图 9-19 and described in 表 9-16.

图 9-19. DC Load Diagnostic Control 1 Register

| 7            | 6       | 5         | 4        | 3 | 2 | 1             | 0          |
|--------------|---------|-----------|----------|---|---|---------------|------------|
| DC LDG ABORT | 2x_RAMP | 2x_SETTLE | RESERVED |   |   | LDG LO ENABLE | LDG BYPASS |
| R/W-0        | R/W-0   | R/W-0     |          |   |   | R/W-0         | R/W-0      |

表 9-16. DC Load Diagnostics Control 1 Field Descriptions

| Bit | Field         | Type | Reset | Description   |
|-----|---------------|------|-------|---|
| 7   | DC LDG ABORT  | R/W  | 0     | <b>0: Default state, clear after abort</b><br>1: Aborts the load diagnostics in progress                              |
| 6   | 2x_RAMP       | R/W  | 0     | <b>0: Normal ramp time</b><br>1: Double ramp time   |
| 5   | 2x_SETTLE     | R/W  | 0     | <b>0: Normal Settle time</b><br>1: Double settling time   |
| 4–2 | RESERVED      | R/W  | 000   | RESERVED  |
| 1   | LDG LO ENABLE | R/W  | 0     | <b>0: Line output diagnostics are disabled</b><br>1: Line output diagnostics are enabled                              |
| 0   | LDG BYPASS    | R/W  | 0     | <b>0: Automatic diagnostics when leaving Hi-Z and after channel fault</b><br>1: Diagnostics are not run automatically |

### 9.6.8 DC Load Diagnostic Control 2 Register (address = 0x0A) [default = 0x11]

The DC Diagnostic Control 2 register is shown in 图 9-20 and described in 表 9-17.

图 9-20. DC Load Diagnostic Control 2 Register

| 7             | 6 | 5 | 4 | 3             | 2 | 1 | 0 |
|---------------|---|---|---|---------------|---|---|---|
| CH1 DC LDG SL |   |   |   | CH2 DC LDG SL |   |   |   |
| R/W-0001      |   |   |   | R/W-0001      |   |   |   |

**表 9-17. DC Load Diagnostics Control 2 Field Descriptions**

| Bit | Field         | Type | Reset | Description   |
|-----|---------------|------|-------|---|
| 7–4 | CH1 DC LDG SL | R/W  | 0001  | DC load diagnostics shorted-load threshold<br>0000: 0.5 $\Omega$<br><b>0001: 1 <math>\Omega</math></b><br>0010: 1.5 $\Omega$<br>...<br>1001: 5 $\Omega$ |
| 3–0 | CH2 DC LDG SL | R/W  | 0001  | DC load diagnostics shorted-load threshold<br>0000: 0.5 $\Omega$<br><b>0001: 1 <math>\Omega</math></b><br>0010: 1.5 $\Omega$<br>...<br>1001: 5 $\Omega$ |

### 9.6.9 DC Load Diagnostic Control 3 Register (address = 0x0B) [default = 0x11]

The DC Diagnostic Control 3 register is shown in [図 9-21](#) and described in [表 9-18](#).

**図 9-21. DC Load Diagnostic Control 3 Register**

|               |   |   |   |               |   |   |   |
|---------------|---|---|---|---------------|---|---|---|
| 7             | 6 | 5 | 4 | 3             | 2 | 1 | 0 |
| CH3 DC LDG SL |   |   |   | CH4 DC LDG SL |   |   |   |
| R/W-0001      |   |   |   | R/W-0001      |   |   |   |

**表 9-18. DC Load Diagnostics Control 3 Field Descriptions**

| Bit | Field         | Type | Reset | Description   |
|-----|---------------|------|-------|---|
| 7–4 | CH3 DC LDG SL | R/W  | 0001  | DC load diagnostics shorted-load threshold<br>0000: 0.5 $\Omega$<br><b>0001: 1 <math>\Omega</math></b><br>0010: 1.5 $\Omega$<br>...<br>1001: 5 $\Omega$ |
| 3–0 | CH4 DC LDG SL | R/W  | 0001  | DC load diagnostics shorted-load threshold<br>0000: 0.5 $\Omega$<br><b>0001: 1 <math>\Omega</math></b><br>0010: 1.5 $\Omega$<br>...<br>1001: 5 $\Omega$ |

### 9.6.10 DC Load Diagnostic Report 1 Register (address = 0x0C) [default = 0x00]

DC Load Diagnostic Report 1 register is shown in [図 9-22](#) and described in [表 9-19](#).

**図 9-22. DC Load Diagnostic Report 1 Register**

|         |         |        |        |         |         |        |        |
|---------|---------|--------|--------|---------|---------|--------|--------|
| 7       | 6       | 5      | 4      | 3       | 2       | 1      | 0      |
| CH1 S2G | CH1 S2P | CH1 OL | CH1 SL | CH2 S2G | CH2 S2P | CH2 OL | CH2 SL |
| R-0     | R-0     | R-0    | R-0    | R-0     | R-0     | R-0    | R-0    |

**表 9-19. DC Load Diagnostics Report 1 Field Descriptions**

| Bit | Field   | Type | Reset | Description  |
|-----|---------|------|-------|--|
| 7   | CH1 S2G | R    | 0     | <b>0: No short-to-GND detected</b><br>1: Short-To-GND Detected |

**表 9-19. DC Load Diagnostics Report 1 Field Descriptions (continued)**

| Bit | Field   | Type | Reset | Description  |
|-----|---------|------|-------|--|
| 6   | CH1 S2P | R    | 0     | <b>0: No short-to-power detected</b><br>1: Short-to-power detected |
| 5   | CH1 OL  | R    | 0     | <b>0: No open load detected</b><br>1: Open load detected           |
| 4   | CH1 SL  | R    | 0     | <b>0: No shorted load detected</b><br>1: Shorted load detected     |
| 3   | CH2 S2G | R    | 0     | <b>0: No short-to-GND detected</b><br>1: Short-to-GND detected     |
| 2   | CH2 S2P | R    | 0     | <b>0: No short-to-power detected</b><br>1: Short-to-power detected |
| 1   | CH2 OL  | R    | 0     | <b>0: No open load detected</b><br>1: Open load detected           |
| 0   | CH2 SL  | R    | 0     | <b>0: No shorted load detected</b><br>1: Shorted load detected     |

**9.6.11 DC Load Diagnostic Report 2 Register (address = 0x0D) [default = 0x00]**

The DC Load Diagnostic Report 2 register is shown in [图 9-23](#) and described in [表 9-20](#).

**图 9-23. DC Load Diagnostic Report 2 Register**

| 7       | 6       | 5      | 4      | 3       | 2       | 1      | 0      |
|---------|---------|--------|--------|---------|---------|--------|--------|
| CH3 S2G | CH3 S2P | CH3 OL | CH3 SL | CH4 S2G | CH4 S2P | CH4 OL | CH4 SL |
| R-0     | R-0     | R-0    | R-0    | R-0     | R-0     | R-0    | R-0    |

**表 9-20. DC Load Diagnostics Report 2 Field Descriptions**

| Bit | Field   | Type | Reset | Description  |
|-----|---------|------|-------|--|
| 7   | CH3 S2G | R    | 0     | <b>0: No short-to-GND detected</b><br>1: Short-to-GND detected     |
| 6   | CH3 S2P | R    | 0     | <b>0: No short-to-power detected</b><br>1: Short-to-power detected |
| 5   | CH3 OL  | R    | 0     | <b>0: No open load detected</b><br>1: Open load detected           |
| 4   | CH3 SL  | R    | 0     | <b>0: No shorted load detected</b><br>1: Shorted load detected     |
| 3   | CH4 S2G | R    | 0     | <b>0: No short-to-GND detected</b><br>1: Short-to-GND detected     |
| 2   | CH4 S2P | R    | 0     | <b>0: No short-to-power detected</b><br>1: Short-to-power detected |
| 1   | CH4 OL  | R    | 0     | <b>0: No open load detected</b><br>1: Open load detected           |
| 0   | CH4 SL  | R    | 0     | <b>0: No shorted load detected</b><br>1: Shorted load detected     |

### 9.6.12 DC Load Diagnostics Report 3 Line Output Register (address = 0x0E) [default = 0x00]

The DC Load Diagnostic Report, Line Output, register is shown in [図 9-24](#) and described in [表 9-21](#).

**図 9-24. DC Load Diagnostics Report 3 Line Output Register**

| 7        | 6 | 5 | 4 | 3          | 2          | 1          | 0          |
|----------|---|---|---|------------|------------|------------|------------|
| RESERVED |   |   |   | CH1 LO LDG | CH2 LO LDG | CH3 LO LDG | CH4 LO LDG |
| R-0000   |   |   |   | R-0        | R-0        | R-0        | R-0        |

**表 9-21. DC Load Diagnostics Report 3 Line Output Field Descriptions**

| Bit | Field      | Type | Reset | Description  |
|-----|------------|------|-------|--|
| 7–4 | RESERVED   | R    | 0000  | RESERVED   |
| 3   | CH1 LO LDG | R    | 0     | <b>0: No line output detected on channel 1</b><br>1: Line output detected on channel 1 |
| 2   | CH2 LO LDG | R    | 0     | <b>0: No line output detected on channel 2</b><br>1: Line output detected on channel 2 |
| 1   | CH3 LO LDG | R    | 0     | <b>0: No line output detected on channel 3</b><br>1: Line output detected on channel 3 |
| 0   | CH4 LO LDG | R    | 0     | <b>0: No line output detected on channel 4</b><br>1: Line output detected on channel 4 |

### 9.6.13 Channel State Reporting Register (address = 0x0F) [default = 0x55]

The Channel State Reporting register is shown in [図 9-25](#) and described in [表 9-22](#).

**図 9-25. Channel State-Reporting Register**

| 7                | 6 | 5                | 4 | 3                | 2 | 1                | 0 |
|------------------|---|------------------|---|------------------|---|------------------|---|
| CH1 STATE REPORT |   | CH2 STATE REPORT |   | CH3 STATE REPORT |   | CH4 STATE REPORT |   |
| R-01             |   | R-01             |   | R-01             |   | R-01             |   |

**表 9-22. State-Reporting Field Descriptions**

| Bit | Field            | Type | Reset | Description  |
|-----|------------------|------|-------|--|
| 7–6 | CH1 STATE REPORT | R    | 01    | 00: PLAY<br><b>01: Hi-Z</b><br>10: MUTE<br>11: DC load diagnostics |
| 5–4 | CH2 STATE REPORT | R    | 01    | 00: PLAY<br><b>01: Hi-Z</b><br>10: MUTE<br>11: DC load diagnostics |
| 3–2 | CH3 STATE REPORT | R    | 01    | 00: PLAY<br><b>01: Hi-Z</b><br>10: MUTE<br>11: DC load diagnostics |
| 1–0 | CH4 STATE REPORT | R    | 01    | 00: PLAY<br><b>01: Hi-Z</b><br>10: MUTE<br>11: DC load diagnostics |

### 9.6.14 Channel Faults (Overcurrent, DC Detection) Register (address = 0x10) [default = 0x00]

The Channel Faults (overcurrent, DC detection) register is shown in [図 9-26](#) and described in [表 9-23](#).

図 9-26. Channel Faults Register

| 7      | 6      | 5      | 4      | 3      | 2      | 1      | 0      |
|--------|--------|--------|--------|--------|--------|--------|--------|
| CH1 OC | CH2 OC | CH3 OC | CH4 OC | CH1 DC | CH2 DC | CH3 DC | CH4 DC |
| R-0    | R-0    | R-0    | R-0    | R-0    | R-0    | R-0    | R-0    |

表 9-23. Channel Faults Field Descriptions

| Bit | Field  | Type | Reset | Description  |
|-----|--------|------|-------|--|
| 7   | CH1 OC | R    | 0     | <b>0: No overcurrent fault detected</b><br>1: Overcurrent fault detected |
| 6   | CH2 OC | R    | 0     | <b>0: No overcurrent fault detected</b><br>1: Overcurrent fault detected |
| 5   | CH3 OC | R    | 0     | <b>0: No overcurrent fault detected</b><br>1: Overcurrent fault detected |
| 4   | CH4 OC | R    | 0     | <b>0: No overcurrent fault detected</b><br>1: Overcurrent fault detected |
| 3   | CH1 DC | R    | 0     | <b>0: No DC fault detected</b><br>1: DC fault detected                   |
| 2   | CH2 DC | R    | 0     | <b>0: No DC fault detected</b><br>1: DC fault detected                   |
| 1   | CH3 DC | R    | 0     | <b>0: No DC fault detected</b><br>1: DC fault detected                   |
| 0   | CH4 DC | R    | 0     | <b>0: No DC fault detected</b><br>1: DC fault detected                   |

#### 9.6.15 Global Faults 1 Register (address = 0x11) [default = 0x00]

The Global Faults 1 register is shown in 図 9-27 and described in 表 9-24.

図 9-27. Global Faults 1 Register

| 7        | 6 | 5 | 4                | 3       | 2       | 1       | 0       |
|----------|---|---|------------------|---------|---------|---------|---------|
| RESERVED |   |   | INVALID<br>CLOCK | PVDD OV | VBAT OV | PVDD UV | VBAT UV |
| R-000    |   |   | R-0              | R-0     | R-0     | R-0     | R-0     |

表 9-24. Global Faults 1 Field Descriptions

| Bit | Field         | Type | Reset | Description  |
|-----|---------------|------|-------|--|
| 7–5 | RESERVED      | R    | 000   | RESERVED   |
| 4   | INVALID CLOCK | R    | 0     | <b>0: No clock fault detected</b><br>1: Clock fault detected                         |
| 3   | PVDD OV       | R    | 0     | <b>0: No PVDD overvoltage fault detected</b><br>1: PVDD overvoltage fault detected   |
| 2   | VBAT OV       | R    | 0     | <b>0: No VBAT overvoltage fault detected</b><br>1: VBAT overvoltage fault detected   |
| 1   | PVDD UV       | R    | 0     | <b>0: No PVDD undervoltage fault detected</b><br>1: PVDD undervoltage fault detected |
| 0   | VBAT UV       | R    | 0     | <b>0: No VBAT undervoltage fault detected</b><br>1: VBAT undervoltage fault detected |

### 9.6.16 Global Faults 2 Register (address = 0x12) [default = 0x00]

The Global Faults 2 register is shown in [図 9-28](#) and described in [表 9-25](#).

**図 9-28. Global Faults 2 Register**

| 7        | 6 | 5 | 4    | 3        | 2        | 1        | 0        |
|----------|---|---|------|----------|----------|----------|----------|
| RESERVED |   |   | OTSD | CH1 OTSD | CH2 OTSD | CH3 OTSD | CH4 OTSD |
| R-000    |   |   | R-0  | R-0      | R-0      | R-0      | R-0      |

**表 9-25. Global Faults 2 Field Descriptions**

| Bit | Field    | Type | Reset | Description  |
|-----|----------|------|-------|--|
| 7–5 | RESERVED | R    | 000   | RESERVED   |
| 4   | OTSD     | R    | 0     | <b>0: No global overtemperature shutdown</b><br>1: Global overtemperature shutdown |
| 3   | CH1 OTSD | R    | 0     | <b>0: No overtemperature shutdown on Ch1</b><br>1: Overtemperature shutdown on Ch1 |
| 2   | CH2 OTSD | R    | 0     | <b>0: No overtemperature shutdown on Ch2</b><br>1: Overtemperature shutdown on Ch2 |
| 1   | CH3 OTSD | R    | 0     | <b>0: No overtemperature shutdown on Ch3</b><br>1: Overtemperature shutdown on Ch3 |
| 0   | CH4 OTSD | R    | 0     | <b>0: No overtemperature shutdown on Ch4</b><br>1: Overtemperature shutdown on Ch4 |

### 9.6.17 Warnings Register (address = 0x13) [default = 0x20]

The Warnings register is shown in [図 9-29](#) and described in [表 9-26](#).

**図 9-29. Warnings Register**

| 7        | 6 | 5       | 4   | 3       | 2       | 1       | 0       |
|----------|---|---------|-----|---------|---------|---------|---------|
| RESERVED |   | VDD POR | OTW | OTW CH1 | OTW CH2 | OTW CH3 | OTW CH4 |
| R-00     |   | R-0     | R-0 | R-0     | R-0     | R-0     | R-0     |

**表 9-26. Warnings Field Descriptions**

| Bit | Field    | Type | Reset | Description  |
|-----|----------|------|-------|--|
| 7-6 | RESERVED | R    | 00    | RESERVED   |
| 5   | VDD POR  | R    | 0     | <b>0: No VDD POR has occurred</b><br><b>1 VDD POR occurred</b>                               |
| 4   | OTW      | R    | 0     | <b>0: No global overtemperature warning</b><br>1: Global overtemperature warning             |
| 3   | OTW CH1  | R    | 0     | <b>0: No overtemperature warning on channel 1</b><br>1: Overtemperature warning on channel 1 |
| 2   | OTW CH2  | R    | 0     | <b>0: No overtemperature warning on channel 2</b><br>1: Overtemperature warning on channel 2 |
| 1   | OTW CH3  | R    | 0     | <b>0: No overtemperature warning on channel 3</b><br>1: Overtemperature warning on channel 3 |
| 0   | OTW CH4  | R    | 0     | <b>0: No overtemperature warning on channel 4</b><br>1: Overtemperature warning on channel 4 |

### 9.6.18 Pin Control Register (address = 0x14) [default = 0x00]

The Pin Control register is shown in [図 9-30](#) and described in [表 9-27](#).

**图 9-30. Pin Control Register**

| 7       | 6         | 5       | 4       | 3       | 2        | 1         | 0        |
|---------|-----------|---------|---------|---------|----------|-----------|----------|
| MASK OC | MASK OTSD | MASK UV | MASK OV | MASK DC | RESERVED | MASK CLIP | MASK OTW |
| R/W-0   | R/W-0     | R/W-0   | R/W-0   | R/W-0   | R/W-0    | R/W-0     | R/W-0    |

**表 9-27. Pin Control Field Descriptions**

| Bit | Field     | Type | Reset | Description  |
|-----|-----------|------|-------|--|
| 7   | MASK OC   | R/W  | 0     | <b>0: Report overcurrent faults on the FAULT pin</b><br>1: Do not report overcurrent faults on the FAULT pin           |
| 6   | MASK OTSD | R/W  | 0     | <b>0: Report overtemperature faults on the FAULT pin</b><br>1: Do not report overtemperature faults on the FAULT pin   |
| 5   | MASK UV   | R/W  | 0     | <b>0: Report undervoltage faults on the FAULT pin</b><br>1: Do not report undervoltage faults on the FAULT pin         |
| 4   | MASK OV   | R/W  | 0     | <b>0: Report overvoltage faults on the FAULT pin</b><br>1: Do not report overvoltage faults on the FAULT pin           |
| 3   | MASK DC   | R/W  | 0     | <b>0: Report DC faults on the FAULT pin</b><br>1: Do not report DC faults on the FAULT pin                             |
| 2   | RESERVED  | R/W  | 0     | RESERVED   |
| 1   | MASK CLIP | R/W  | 0     | <b>0: Report clipping on the configured pin</b><br>1: Do not report clipping on the configured pin                     |
| 0   | MASK OTW  | R/W  | 0     | <b>0: Report overtemperature warnings on the WARN pin</b><br>1: Do not report overtemperature warnings on the WARN pin |

**9.6.19 AC Load Diagnostic Control 1 Register (address = 0x15) [default = 0x00]**

The AC Load Diagnostic Control 1 register is shown in 图 9-31 and described in 表 9-28.

**图 9-31. AC Load Diagnostic Control 1 Register**

| 7        | 6        | 5        | 4        | 3          | 2          | 1          | 0          |
|----------|----------|----------|----------|------------|------------|------------|------------|
| CH1 GAIN | CH2 GAIN | CH3 GAIN | CH4 GAIN | CH1 ENABLE | CH2 ENABLE | CH3 ENABLE | CH4 ENABLE |
| R/W-0    | R/W-0    | R/W-0    | R/W-0    | R/W-0      | R/W-0      | R/W-0      | R/W-0      |

**表 9-28. AC Load Diagnostic Control 1 Field Descriptions**

| Bit | Field                  | Type | Reset | Description   |
|-----|------------------------|------|-------|---|
| 7   | CH1, PBTL12: GAIN      | R/W  | 0     | <b>0: Gain 1</b><br>1: Gain 4                                 |
| 6   | CH2 GAIN               | R/W  | 0     | <b>0: Gain 1</b><br>1: Gain 4                                 |
| 5   | CH3, CH4, PBTL34: GAIN | R/W  | 0     | <b>0: Gain 1</b><br>1: Gain 4                                 |
| 4   | CH4 GAIN               | R/W  | 0     | <b>0: Gain 1</b><br>1: Gain 4                                 |
| 3   | CH1 ENABLE             | R/W  | 0     | <b>0: AC diagnostics disabled</b><br>1: Enable AC diagnostics |
| 2   | CH2 ENABLE             | R/W  | 0     | <b>0: AC diagnostics disabled</b><br>1: Enable AC diagnostics |
| 1   | CH3 ENABLE             | R/W  | 0     | <b>0: AC diagnostics disabled</b><br>1: Enable AC diagnostics |

**表 9-28. AC Load Diagnostic Control 1 Field Descriptions (continued)**

| Bit | Field      | Type | Reset | Description   |
|-----|------------|------|-------|---|
| 0   | CH4 ENABLE | R/W  | 0     | <b>0: AC diagnostics disabled</b><br>1: Enable AC diagnostics |

#### 9.6.20 AC Load Diagnostic Control 2 Register (address = 0x16) [default = 0x00]

The AC Load Diagnostic Control 2 register is shown in [図 9-32](#) and described in [表 9-29](#).

**図 9-32. AC Load Diagnostic Control 2 Register**

|                       |          |       |           |            |       |          |       |
|-----------------------|----------|-------|-----------|------------|-------|----------|-------|
| 7                     | 6        | 5     | 4         | 3          | 2     | 1        | 0     |
| AC_DIAGS_LO<br>OPBACK | RESERVED |       | AC TIMING | AC CURRENT |       | RESERVED |       |
| R/W-0                 | R/W-0    | R/W-0 | R/W-0     | R/W-0      | R/W-0 | R/W-0    | R/W-0 |

**表 9-29. AC Load Diagnostic Control 2 Field Descriptions**

| Bit | Field             | Type | Reset | Description  |
|-----|-------------------|------|-------|--|
| 7   | AC_DIAGS_LOOPBACK | R/W  | 0     | <b>0: Disable AC Diag loopback</b><br>1: Enable AC Diag loopback |
| 6-5 | RESERVED          | R/W  | 00    | RESERVED   |
| 4   | AC TIMING         | R/W  | 0     | <b>0: 32 Cycles</b><br>1: 64 Cycles                              |
| 3-2 | AC CURRENT        | R/W  | 00    | <b>00: 10mA</b><br>01: 19 mA<br>10: RESERVED<br>11: RESERVED     |
| 1-0 | RESERVED          | R/W  | 00    | RESERVED   |

#### 9.6.21 AC Load Diagnostic Impedance Report Ch1 through Ch4 Registers (address = 0x17–0x1A) [default = 0x00]

The AC Load Diagnostic Report Ch1 through Ch4 registers are shown in [図 9-33](#) and described in [表 9-30](#).

**図 9-33. AC Load Diagnostic Impedance Report Chx Register**

|               |   |   |   |   |   |   |   |
|---------------|---|---|---|---|---|---|---|
| 7             | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| CHx IMPEDANCE |   |   |   |   |   |   |   |
| R-00000000    |   |   |   |   |   |   |   |

**表 9-30. Chx AC LDG Impedance Report Field Descriptions**

| Bit | Field          | Type | Reset    | Description  |
|-----|----------------|------|----------|--|
| 7–0 | CH x IMPEDANCE | R    | 00000000 | 8-bit AC-load diagnostic report for each channel with a step size of 0.2496 Ω/bit (control by register 0x15 and register 0x16)<br><b>0x00: 0 Ω</b><br>0x01: 0.2496 Ω<br>...<br>0xFF: 63.65 Ω |

#### 9.6.22 AC Load Diagnostic Phase Report High Register (address = 0x1B) [default = 0x00]

The AC Load Diagnostic Phase High value registers are shown in [図 9-34](#) and described in [表 9-31](#).

**図 9-34. AC Load Diagnostic (LDG) Phase High Report Register**

|               |   |   |   |   |   |   |   |
|---------------|---|---|---|---|---|---|---|
| 7             | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| AC Phase High |   |   |   |   |   |   |   |

**図 9-34. AC Load Diagnostic (LDG) Phase High Report Register (continued)**

R-00000000

**表 9-31. AC LDG Phase High Report Field Descriptions**

| Bit | Field         | Type | Reset    | Description |
|-----|---------------|------|----------|-------------|
| 7–0 | AC Phase High | R    | 00000000 | Bit 15:8    |

**9.6.23 AC Load Diagnostic Phase Report Low Register (address = 0x1C) [default = 0x00]**

The AC Load Diagnostic Phase Low value registers are shown in [図 9-35](#) and described in [表 9-32](#).

**図 9-35. AC Load Diagnostic (LDG) Phase Low Report Register**

|              |   |   |   |   |   |   |   |
|--------------|---|---|---|---|---|---|---|
| 7            | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| AC Phase Low |   |   |   |   |   |   |   |
| R-00         |   |   |   |   |   |   |   |

**表 9-32. AC LDG Phase Low Report Field Descriptions**

| Bit | Field        | Type | Reset | Description |
|-----|--------------|------|-------|-------------|
| 7–0 | AC Phase Low | R    | 00    | Bit 7:0     |

**9.6.24 AC Load Diagnostic STI Report High Register (address = 0x1D) [default = 0x00]**

The AC Load Diagnostic STI High value registers are shown in [図 9-36](#) and described in [表 9-33](#).

**図 9-36. AC Load Diagnostic (LDG) STI High Report Register**

|             |   |   |   |   |   |   |   |
|-------------|---|---|---|---|---|---|---|
| 7           | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| AC STI High |   |   |   |   |   |   |   |
| R-00        |   |   |   |   |   |   |   |

**表 9-33. AC LDG STI High Report Field Descriptions**

| Bit | Field       | Type | Reset | Description |
|-----|-------------|------|-------|-------------|
| 7–0 | AC STI High | R    | 00    | Bit 15:8    |

### 9.6.25 AC Load Diagnostic STI Report Low Register (address = 0x1E) [default = 0x00]

The AC Load Diagnostic STI Low value registers are shown in [図 9-37](#) and described in [表 9-34](#).

**図 9-37. AC Load Diagnostic (LDG) STI Low Report Register**

| 7          | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|------------|---|---|---|---|---|---|---|
| AC STI Low |   |   |   |   |   |   |   |
| R-00       |   |   |   |   |   |   |   |

**表 9-34. Chx AC LDG STI Low Report Field Descriptions**

| Bit | Field      | Type | Reset | Description |
|-----|------------|------|-------|-------------|
| 7-0 | AC STI Low | R    | 00    | Bit 7:0     |

### 9.6.26 Miscellaneous Control 3 Register (address = 0x21) [default = 0x00]

The Miscellaneous Control 3 register is shown in [図 9-38](#) and described in [表 9-35](#).

**図 9-38. Miscellaneous Control 3 Register**

| 7           | 6           | 5        | 4        | 3                  | 2        | 1 | 0 |
|-------------|-------------|----------|----------|--------------------|----------|---|---|
| CLEAR FAULT | PBTL_CH_SEL | RESERVED | RESERVED | OTSD AUTO RECOVERY | RESERVED |   |   |
| R/W-0       | R/W-0       | R/W-0    | R/W-0    | R/W-0              |          |   |   |

**表 9-35. Misc Control 3 Field Descriptions**

| Bit | Field              | Type | Reset | Description   |
|-----|--------------------|------|-------|---|
| 7   | CLEAR FAULT        | R/W  | 0     | <b>0: Normal operation</b><br>1: Clear fault                      |
| 6   | PBTL_CH_SEL        | R/W  | 0     | <b>0: PBTL normal signal source</b><br>1: PBTL flip signal source |
| 5   | RESERVED           | R/W  | 0     | RESERVED  |
| 4   | RESERVED           | R/W  | 0     | RESERVED  |
| 3   | OTSD AUTO RECOVERY | R/W  | 0     | <b>0: OTSD is latched</b><br>1: OTSD is autorecovery              |
| 2-0 | RESERVED           |      | 0     | RESERVED  |

### 9.6.27 Clip Control Register (address = 0x22) [default = 0x01]

The Clip Detect register is shown in [図 9-39](#) and described in [表 9-36](#). To ensure the Clip Detect Warning is operating according to the expectation, the related bit values in the [Clip Window Register \(address = 0x23\)](#) and [Clip Warning Register \(address = 0x24\)](#) must be set accordingly.

**図 9-39. Clip Control Register**

| 7        | 6 | 5 | 4 | 3 | 2        | 1          | 0          |
|----------|---|---|---|---|----------|------------|------------|
| RESERVED |   |   |   |   | CLIP_PIN | CLIP_LATCH | CLIPDET_EN |
|          |   |   |   |   | R/W-0    | R/W-0      | R/W-1      |

**表 9-36. Clip Control Field Descriptions**

| Bit | Field    | Type | Reset | Description   |
|-----|----------|------|-------|---|
| 7-3 | RESERVED |      |       | RESERVED  |
| 2   | CLIP_PIN | R/W  | 0     | <b>0: CH1-4 Clip Detect report to <math>\overline{\text{WARN}}</math> pin</b><br>1: CH1-2 Clip Detect report to $\overline{\text{WARN}}$ pin, CH3-4 Clip Detect report to $\overline{\text{FAULT}}$ pin |

**表 9-36. Clip Control Field Descriptions (continued)**

| Bit | Field      | Type | Reset | Description   |
|-----|------------|------|-------|---|
| 1   | CLIP_LATCH | R/W  | 0     | <b>0: Pin latching</b><br>1: Pin non-latching                 |
| 0   | CLIPDET_EN | R/W  | 1     | <b>0: Clip Detect disable</b><br><b>1: Clip Detect Enable</b> |

**9.6.28 Clip Window Register (address = 0x23) [default = 0x14]**

The Clip Window register is shown in 图 9-40 and described in 表 9-37. The register value represents the minimum number of 100% duty-cycle PWM cycles before Clip Detect is reported.

**图 9-40. Clip Window Register**

|                      |   |   |   |   |   |   |   |
|----------------------|---|---|---|---|---|---|---|
| 7                    | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| CLIP_WINDOW_SEL[7:1] |   |   |   |   |   |   |   |
| R/W-00010100         |   |   |   |   |   |   |   |

**表 9-37. Clip Window Field Descriptions**

| Bit | Field                | Type | Reset    | Description  |
|-----|----------------------|------|----------|--|
| 7-0 | CLIP_WINDOW_SEL[7:1] | R/W  | 00010100 | Default value is 20. Acceptable range is from 0-20 cycles.<br><b>00010100: 20-100% duty-cycle PWM cycles before Clip Detect is triggered</b> |

**9.6.29 Clip Warning Register (address = 0x24) [default = 0x00]**

The Clip Window register is shown in 图 9-41 and described in 表 9-38.

**图 9-41. Clip Warning Register**

|          |   |   |   |          |          |          |          |
|----------|---|---|---|----------|----------|----------|----------|
| 7        | 6 | 5 | 4 | 3        | 2        | 1        | 0        |
| RESERVED |   |   |   | CH4_CLIP | CH3_CLIP | CH2_CLIP | CH1_CLIP |
|          |   |   |   | R-0      | R-0      | R-0      | R-0      |

**表 9-38. Clip Warning Field Descriptions**

| Bit | Field    | Type | Reset | Description                                |
|-----|----------|------|-------|--|
| 7-4 | RESERVED |      | 0     | RESERVED                                   |
| 3   | CH4_CLIP | R    | 0     | <b>0: No Clip Detect</b><br>1: Clip Detect |
| 2   | CH3_CLIP | R    | 0     | <b>0: No Clip Detect</b><br>1: Clip Detect |
| 1   | CH2_CLIP | R    | 0     | <b>0: No Clip Detect</b><br>1: Clip Detect |
| 0   | CH1_CLIP | R    | 0     | <b>0: No Clip Detect</b><br>1: Clip Detect |

### 9.6.30 ILIMIT Status Register (address = 0x25) [default = 0x00]

The ILIMIT Status register is shown in [図 9-42](#) and described in [表 9-39](#).

**図 9-42. ILIMIT Status Register**

| 7        | 6 | 5 | 4 | 3                   | 2                   | 1                   | 0                   |
|----------|---|---|---|---------------------|---------------------|---------------------|---------------------|
| RESERVED |   |   |   | CH4_ILIMIT_W<br>ARN | CH3_ILIMIT_W<br>ARN | CH2_ILIMIT_W<br>ARN | CH1_ILIMIT_W<br>ARN |
|          |   |   |   | R-0                 | R-0                 | R-0                 | R-0                 |

**表 9-39. ILIMIT Status Field Descriptions**

| Bit | Field           | Type | Reset | Description                              |
|-----|-----------------|------|-------|--|
| 7-4 | RESERVED        |      | 0     | RESERVED                                 |
| 3   | CH4_ILIMIT_WARN | R    | 0     | <b>0: No ILIMIT</b><br>1: ILIMIT Warning |
| 2   | CH3_ILIMIT_WARN | R    | 0     | <b>0: No ILIMIT</b><br>1: ILIMIT Warning |
| 1   | CH2_ILIMIT_WARN | R    | 0     | <b>0: No ILIMIT</b><br>1: ILIMIT Warning |
| 0   | CH1_ILIMIT_WARN | R    | 0     | <b>0: No ILIMIT</b><br>1: ILIMIT Warning |

### 9.6.31 Miscellaneous Control 4 Register (address = 0x26) [default = 0x40]

The Miscellaneous Control 4 register is shown in [図 9-43](#) and described in [表 9-40](#).

**図 9-43. Miscellaneous Control 4 Register**

| 7        | 6 | 5 | 4 | 3        | 2               | 1 | 0 |
|----------|---|---|---|----------|-----------------|---|---|
| RESERVED |   |   |   | BCLK_INV | HPF_CORNER[2:0] |   |   |
| R/W-0100 |   |   |   | R/W-0    | R/W-000         |   |   |

**表 9-40. Misc Control 4 Field Descriptions**

| Bit | Field           | Type | Reset | Description  |
|-----|-----------------|------|-------|--|
| 7-4 | RESERVED        | R/W  | 0100  | RESERVED   |
| 3   | BCLK_INV        | R/W  | 0     | <b>0: All other MCLK/BCLK frequency / phase use cases</b><br>1: Inverted MCLK/BCLK phase relationship when MCLK/BCLK run at the same frequency |
| 2-0 | HPF_CORNER[2:0] | R/W  | 000   | <b>000: 3.7 Hz</b><br>001: 7.4 Hz<br>010: 15 Hz<br>011: 30 Hz<br>100: 59 Hz<br>101: 118 Hz<br>110: 235 Hz<br>111: 463 Hz                       |

## 10 Application Information Disclaimer

### 注

以下のアプリケーション情報は、TI の製品仕様に含まれるものではなく、TI ではその正確性または完全性を保証いたしません。個々の目的に対する製品の適合性については、お客様の責任で判断していただくことになります。また、お客様は自身の設計実装を検証しテストすることで、システムの機能を確認する必要があります。

### 10.1 Application Information

The TAS6424MS-Q1 is a two-channel class-D digital-input audio-amplifier design for use in automotive head units and external amplifier modules. The TAS6424MS-Q1 incorporates the necessary functionality to perform in demanding OEM applications.

#### 10.1.1 AM-Radio Band Avoidance

AM-radio frequency interference can be avoided by setting the switching frequency of the device above the AM band. The switching frequency options available are  $38 f_s$ ,  $44 f_s$ , and  $48 f_s$ . If the switch frequency cannot be set above the AM band, then use the two options of  $8 f_s$  and  $10 f_s$ . These options should be changed to avoid AM active channels.

#### 10.1.2 Parallel BTL Operation (PBTL)

The device can drive more current-parallel BTL channels on the load side of the LC output filter. For parallel operation, the parallel BTL mode, PBTL, must be used and the paralleled channels must have the same state in the state control register. If the two states are not aligned the device reports a fault condition.

To set the requested channels to PBTL mode the device must be in standby mode for the commands to take effect.

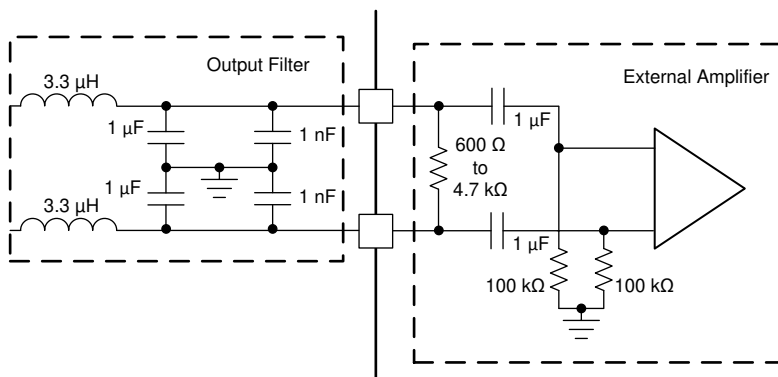
A load diagnostic is supported for PBTL channels. Paralleling on the device side of the LC output filter is not supported.

#### 10.1.3 Demodulation Filter Design

The amplifier outputs are driven by high-current LDMOS transistors in an H-bridge configuration. These transistors are either fully off or fully on. The result is a square-wave output signal with a duty cycle that is proportional to the amplitude of the audio signal. An LC demodulation filter is used to recover the audio signal. The filter attenuates the high-frequency components of the output signals that are out of the audio band. The design of the demodulation filter significantly affects the audio performance of the power amplifier. Therefore, to meet the system THD+N requirements, the selection of the inductors used in the output filter should be carefully considered.

#### 10.1.4 Line Driver Applications

In many automotive audio applications, the same head unit must drive either a speaker (with several ohms of impedance) or an external amplifier input (with several k $\Omega$  of impedance). The design is capable of supporting both applications and has special line-drive gain and diagnostics. Coupled with the high switching frequency, the device is well suited for this type of application. Set the desired channel in line driver mode through I<sup>2</sup>C register 0x00, the externally connected amplifier must have a differential impedance from 600  $\Omega$  to 4.7 k $\Omega$  for the DC line diagnostic to detect the connected external amplifier. [☒ 10-1](#) shows the recommended external amplifier input configuration.



**図 10-1. External Amplifier Input Configuration for Line Driver**

## 10.2 Typical Applications

### 10.2.1 BTL Application

Figure 10-2 shows the schematic of a typical 4-channel solution for a head-unit application.

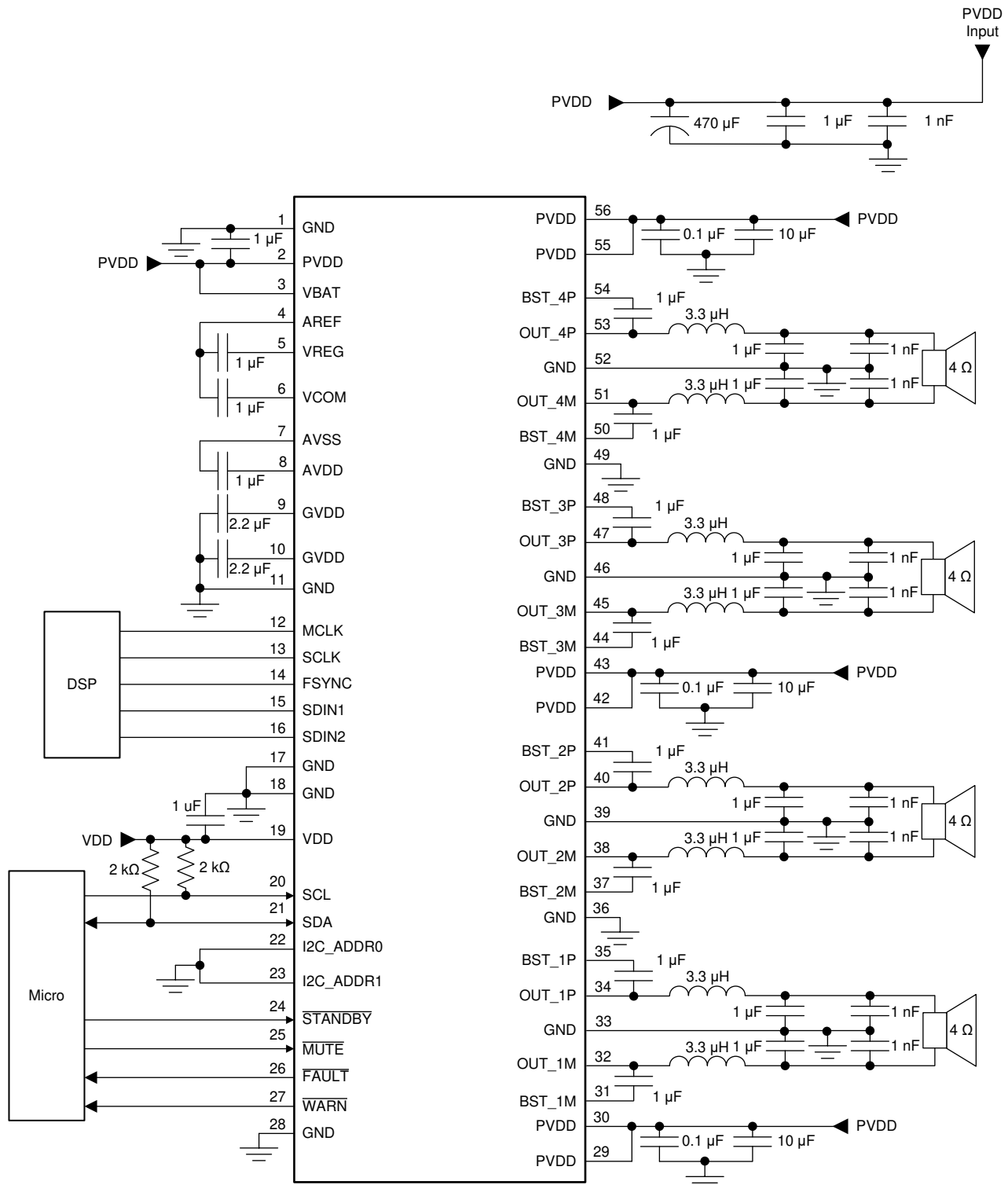


Figure 10-2. Typical 4-Channel BTL Application Schematic

### 10.2.1.1 Design Requirements

Use the following requirements for this design:

- This head-unit example is focused on the smallest solution size for 4 × 50 W output power into 2 Ω with a battery supply of 14.4 V.
- The switching frequency is set above the AM-band with 44 times the input sample rate of 48 kHz which results in a frequency of 2.11 MHz.
- The selection of a 2.11 MHz switch frequency enables the use of a small output inductor value of 3.3 μH which leads to a very small solution size.

#### 10.2.1.1.1 Communication

All communications to the TAS6424MS-Q1 are through the I<sup>2</sup>C protocol. A system controller can communicate with the device through the SDA pins and SCL pins. The device is an I<sup>2</sup>C slave and requires a master. The device cannot generate an I<sup>2</sup>C clock or initiate a transaction. The maximum clock speed accepted by the device is 400 kHz. If multiple TAS6424MS-Q1 devices are on the same I<sup>2</sup>C bus, the I<sup>2</sup>C address must be different for each device. Up to four TAS6424MS-Q1 devices can be on the same I<sup>2</sup>C bus.

The I<sup>2</sup>C bus is shared internally.

---

#### 注

Complete any internal operations, such as load diagnostics, before reading the registers for the results.

---

### 10.2.1.2 Detailed Design Procedure

#### 10.2.1.2.1 Hardware Design

Use the following procedure for the hardware design:

- Determine the input format. The input format can be either I<sup>2</sup>S or TDM mode. The mode determines the correct pin connections and the I<sup>2</sup>C register settings.
- Determine the power output that is required into the load. The power requirement determines the required power-supply voltage and current. The output reconstruction-filter components that are required are also driven by the output power.
- With the requirements, adjust the typical application schematic in [Figure 10-2](#) for the input connections.

#### 10.2.1.2.2 Digital Input and the Serial Audio Port

The TAS6424MS-Q1 device supports four different digital input formats which are: I<sup>2</sup>S, Right Justified, Left Justified, and TDM mode. Depending on the format, the device can support 16, 18, 20, 24, and 32 bit data. The supported frequencies are 96 kHz, 48 kHz, and 44.1 kHz. Please see [SAP Control \(Serial Audio-Port Control\) Register \(address = 0x03\) \[default = 0x04\]](#) for the complete matrix to set up the serial audio port.

---

#### 注

Bits 3, 4, and 5 in this register are ignored in all input formats except for TDM. Setting up all the control registers to the system requirements should be done before the device is placed in Mute mode or Play mode. After the registers are setup, use bit 7 in [Miscellaneous Control 3 Register \(address = 0x21\)](#) to clear any faults. Then read the fault registers to make sure no faults are present. When no faults are present, use [SAP Control \(Serial Audio-Port Control\) Register \(address = 0x03\) \[default = 0x04\]](#) to place the device properly into Play mode.

---

#### 10.2.1.2.3 Bootstrap Capacitors

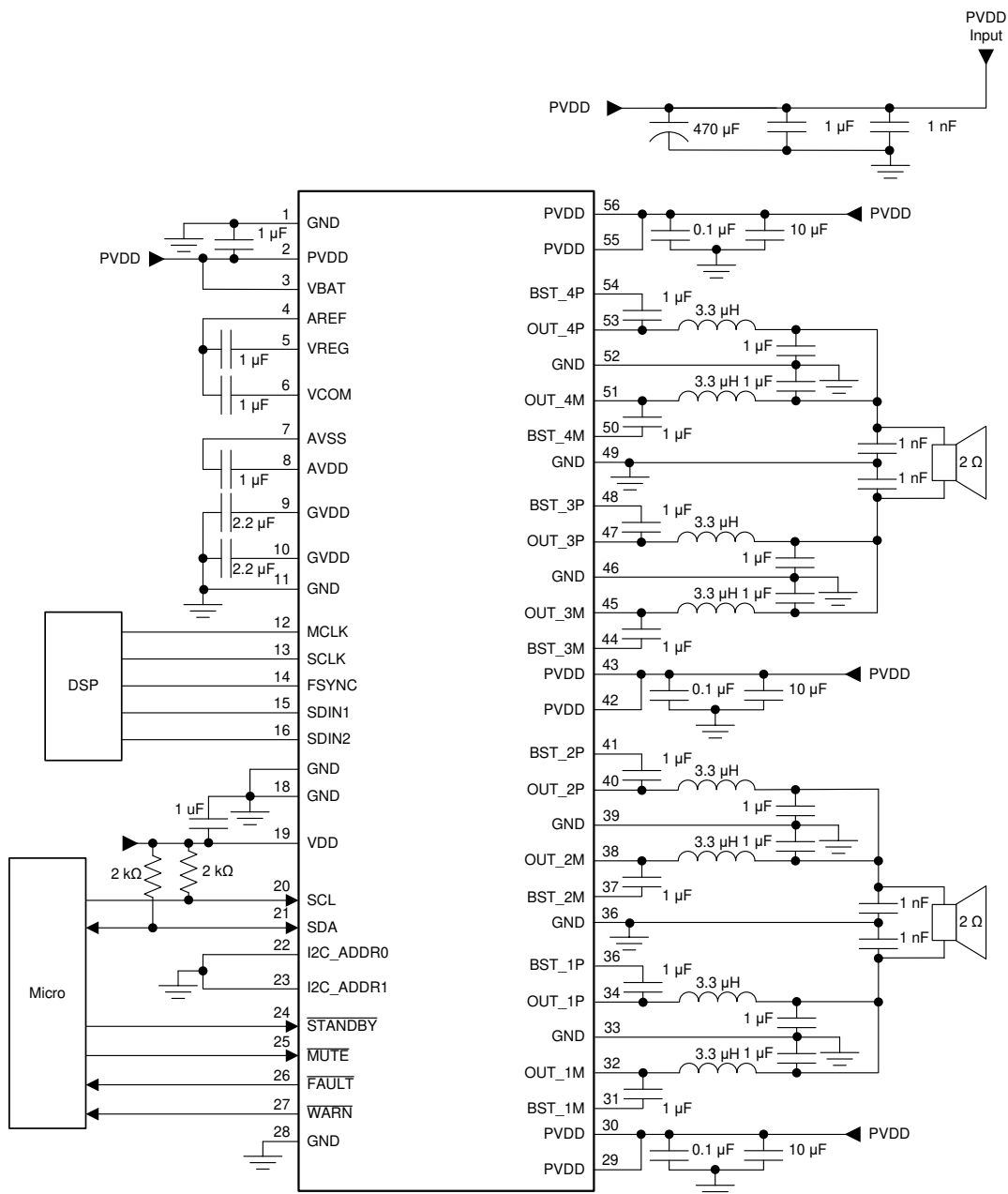
The bootstrap capacitors provide the gate-drive voltage of the upper N-channel FET. These capacitors must be sized appropriately for the system specification. A special condition can occur where the bootstrap may sag if the capacitor is not sized accordingly. The special condition is just below clipping where the PWM is slightly less than 100% duty cycle with sustained low-frequency signals. Changing the bootstrap capacitor value to 2.2 μF for driving subwoofers that require frequencies below 30 Hz may be necessary.

#### 10.2.1.2.4 Output Reconstruction Filter

The output FETs drive the amplifier outputs in an H-Bridge configuration. These transistors are either fully off or fully on. The result is a square-wave output signal with a duty cycle that is proportional to the amplitude of the audio signal. The amplifier outputs require a reconstruction filter that comprises a series inductor and a capacitor to ground on each output, generally called an LC filter. The LC filter attenuates the PWM frequency and reduces electromagnetic emissions, allowing the reconstructed audio signal to pass to the speakers. refer to the [Class-D LC Filter Design Application Report](#), (SLAA701A) for a detailed description of proper component description and design of the LC filter based upon the specified load and frequency response. The recommended low-pass cutoff frequency of the LC filter is dependent on the selected switching frequency. The low-pass cutoff frequency can be as high as 100 kHz for a PWM frequency of 2.1 MHz. At a PWM frequency of 384 kHz the low-pass cutoff frequency should be less than 40 kHz. Certain specifications must be understood for a proper inductor. The inductance value is given at zero current, but the device has current. Use the inductance versus current curve for the inductor to make sure the inductance does not drop below 1  $\mu\text{H}$  (for  $f_{\text{SW}} = 2.1 \text{ MHz}$ ) at the maximum current provided by the system design. The DCR of the inductor directly affects the output power of the system design. The lower the DCR, the more power is provided to the speakers. The typical inductor DCR for a 4  $\Omega$  system is 40 to 50 m $\Omega$  and for a 2  $\Omega$  system is 20 to 25 m $\Omega$ . Further guidance is provided in the [Inductor Selection Guide for 2.1 MHz Class-D Amplifiers](#).

## 10.2.2 PBTL Application

Figure 10-3 shows a schematic of a typical 2-channel solution for a head unit or external amplifier application where high power into  $2\ \Omega$  is required.



**Figure 10-3. Typical 2-Channel PBTL Application Schematic**

To operate in PBTL mode the output stage must be paralleled according to the schematic in Figure 10-3. The device can operate in a mix of PBTL and BTL mode. This application can be set up for 3-channels, with one channel in PBTL mode and two channels in BTL mode. The device does not support a parallel configuration of all four channels for a one channel amplifier.

### 10.2.2.1 Design Requirements

Use the following requirements for this design:

- This head-unit example is focused on the smallest solution size for 2 x 50 W output power into 2  $\Omega$  with a battery supply of 14.4 V.
- The switching frequency is set above the AM-band with 44 times the input sample rate of 48 kHz which results in a frequency of 2.11 MHz.
- The selection of a 2.11 MHz switch frequency enables the use of a small output inductor value of 3.3  $\mu$ H which leads to a very small solution size.

#### 10.2.2.1.1 Detailed Design Procedure

As a starting point, refer to the section for the BTL application. PBTL mode requires schematic changes in the output stage as shown in [Figure 10-3](#). The other required changes include setting up the I<sup>2</sup>C registers correctly (see [Table 9-13](#)) and selecting which frame or channel to use on each output. Bit 6 in register 0x21 controls the frame selection.

## 11 Power Supply Recommendations

The TAS6424MS-Q1 requires three power supplies. The PVDD supply is the high-current supply in the recommended supply range. The VBAT supply is lower current supply that must be in the recommended supply range. The PVDD and VBAT pins can be connected to the same supply if the recommended supply range for VBAT is maintained. The VDD supply is the 3.3 V<sub>dc</sub> logic supply and must be maintained in the tolerance as shown in the [Recommended Operating Conditions](#) table.

For best device performance and to avoid unexpected device behavior follow the recommendations in the [Vehicle-Battery Power-Supply Sequence](#) section.

## 12 Layout

### 12.1 Layout Guidelines

The pinout of the TAS6424MS-Q1 was selected to provide flowthrough layout with all high-power connections on the right side, and all low-power signals and supply decoupling on the left side.

Figure 12-1 shows the area for the components in the application example (see the [Typical Applications](#) section).

The TAS6424MS-Q1 EVM uses a four-layer PCB. The copper thickness was selected as 70  $\mu\text{m}$  to optimize power loss.

The small value of the output filter provides a small size and, in this case, the low height of the inductor enables double-sided mounting.

The EVM PCB shown in Figure 12-1 is the basis for the layout guidelines.

### 12.2 Layout Example

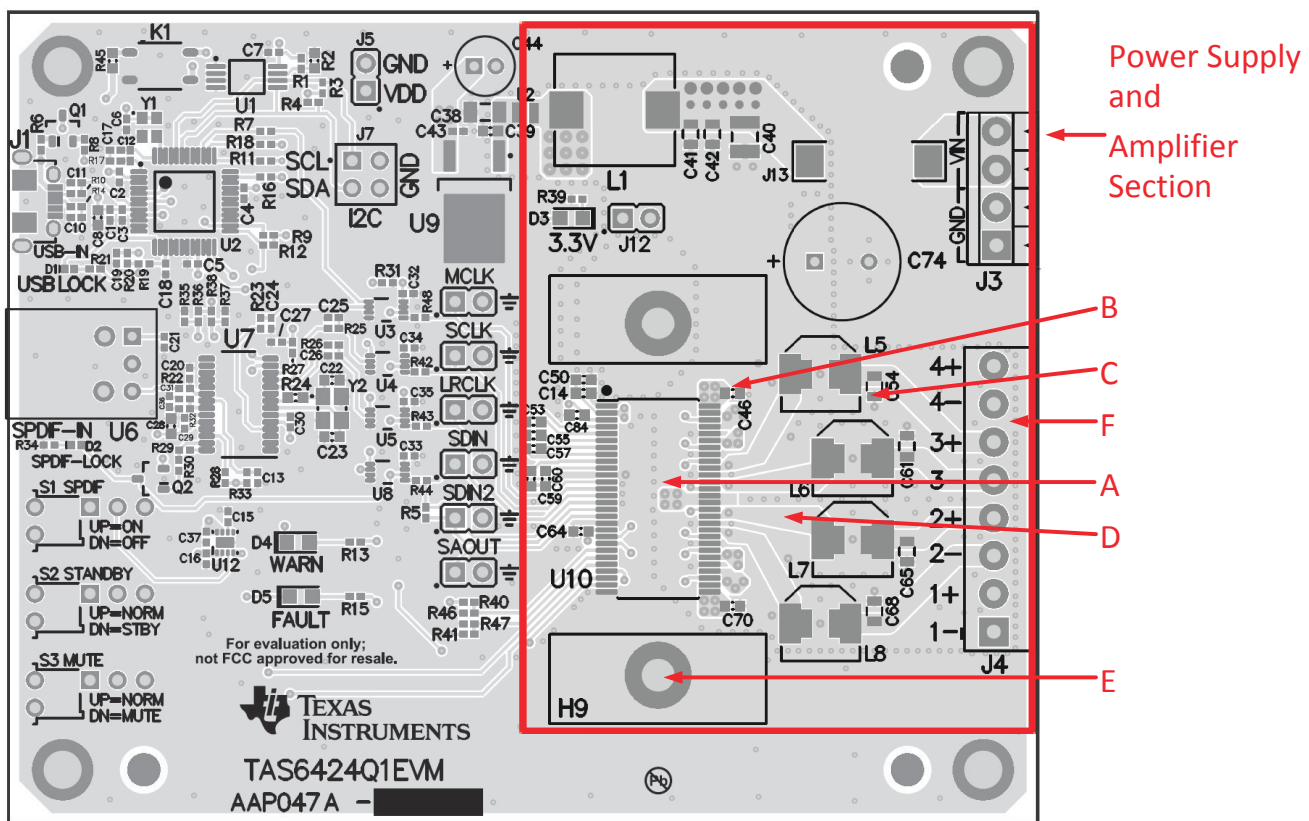


Figure 12-1. EVM Layout

### 12.3 Thermal Considerations

The thermally enhanced PowerPAD package has an exposed pad up for connection to a heat sink. The output power of any amplifier is determined by the thermal performance of the amplifier as well as limitations placed on it by the system, such as the ambient operating temperature. The heat sink absorbs heat from the TAS6424MS-Q1 and transfers it to the air. With proper thermal management this process can reach equilibrium and heat can be continually transferred from the device. Heat sinks can be smaller than that of classic linear amplifier design because of the excellent efficiency of class-D amplifiers. This device is intended for use with a heat sink, therefore,  $R_{\theta JC}$  is used as the thermal resistance from junction to the exposed metal package. This resistance dominates the thermal management, so other thermal transfers is not considered. The thermal resistance of

$R_{\theta JA}$  (junction to ambient) is required to determine the full thermal solution. The thermal resistance is comprised of the following components:

- $R_{\theta JC}$  of the TAS6424MS-Q1
- Thermal resistance of the thermal interface material
- Thermal resistance of the heat sink

The thermal resistance of the thermal interface material can be determined from the manufacturer's value for the area thermal resistance (expressed in  $^{\circ}\text{Cmm}^2/\text{W}$ ) and the area of the exposed metal package. For example, a typical, white, thermal grease with a 0.0254 mm (0.001 inch) thick layer is approximately  $4.52^{\circ}\text{C mm}^2/\text{W}$ . The TAS6424MS-Q1 in the DKQ package has an exposed area of  $47.6 \text{ mm}^2$ . By dividing the area thermal resistance by the exposed metal area determines the thermal resistance for the thermal grease. The thermal resistance of the thermal grease is  $0.094^{\circ}\text{C/W}$

表 12-1 lists the modeling parameters for one device on a heat sink. The junction temperature is assumed to be  $115^{\circ}\text{C}$  while delivering and average power of 10 watts per channel into a  $4 \Omega$  load. The thermal-grease example previously described is used for the thermal interface material. Use 式 3 to design the thermal system.

$$R_{\theta JA} = R_{\theta JC} + \text{thermal interface resistance} + \text{heat sink resistance} \quad (3)$$

**表 12-1. Thermal Modeling**

| Description  | Value   |
|--|---|
| Ambient Temperature                                  | $25^{\circ}\text{C}$  |
| Average Power to load                                | 40W (4 x 10W)   |
| Power dissipation                                    | 8W (4 x 2W)   |
| Junction Temperature                                 | $115^{\circ}\text{C}$   |
| $\Delta T$ inside package                            | $5.6^{\circ}\text{C}$ ( $0.7^{\circ}\text{C/W} \times 8\text{W}$ )  |
| $\Delta T$ through thermal interface material        | $0.75^{\circ}\text{C}$ ( $0.094^{\circ}\text{C/W} \times 8\text{W}$ )   |
| Required heat sink thermal resistance                | $10.45^{\circ}\text{C/W}$ ( $[(115^{\circ}\text{C} - 25^{\circ}\text{C} - 5.6^{\circ}\text{C} - 0.75^{\circ}\text{C}) / 8\text{W}]$ ) |
| System thermal resistance to ambient $R_{\theta JA}$ | $11.24^{\circ}\text{C/W}$   |

## 13 Device and Documentation Support

### 13.1 Documentation Support

### 13.2 Related Documentation

For related documentation see the following:

- [PurePath™ Console 3](#) Graphical Development Suite
- [TAS6422E-Q1 EVM User's Guide](#) (SLOU541)

### 13.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 13.4 サポート・リソース

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### 13.6 静電気放電に関する注意事項



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### 13.7 用語集

**TI 用語集** この用語集には、用語や略語の一覧および定義が記載されています。

## 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable part number            | Status<br>(1) | Material type<br>(2) | Package   Pins   | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|----------------------------------|---------------|----------------------|------------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">TAS6424MSQDKQRQ1</a> | Active        | Production           | HSSOP (DKQ)   56 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -40 to 125   | TAS<br>6424MS       |
| TAS6424MSQDKQRQ1.A               | Active        | Production           | HSSOP (DKQ)   56 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -40 to 125   | TAS<br>6424MS       |
| TAS6424MSQDKQRQ1.B               | Active        | Production           | HSSOP (DKQ)   56 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -40 to 125   | TAS<br>6424MS       |

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

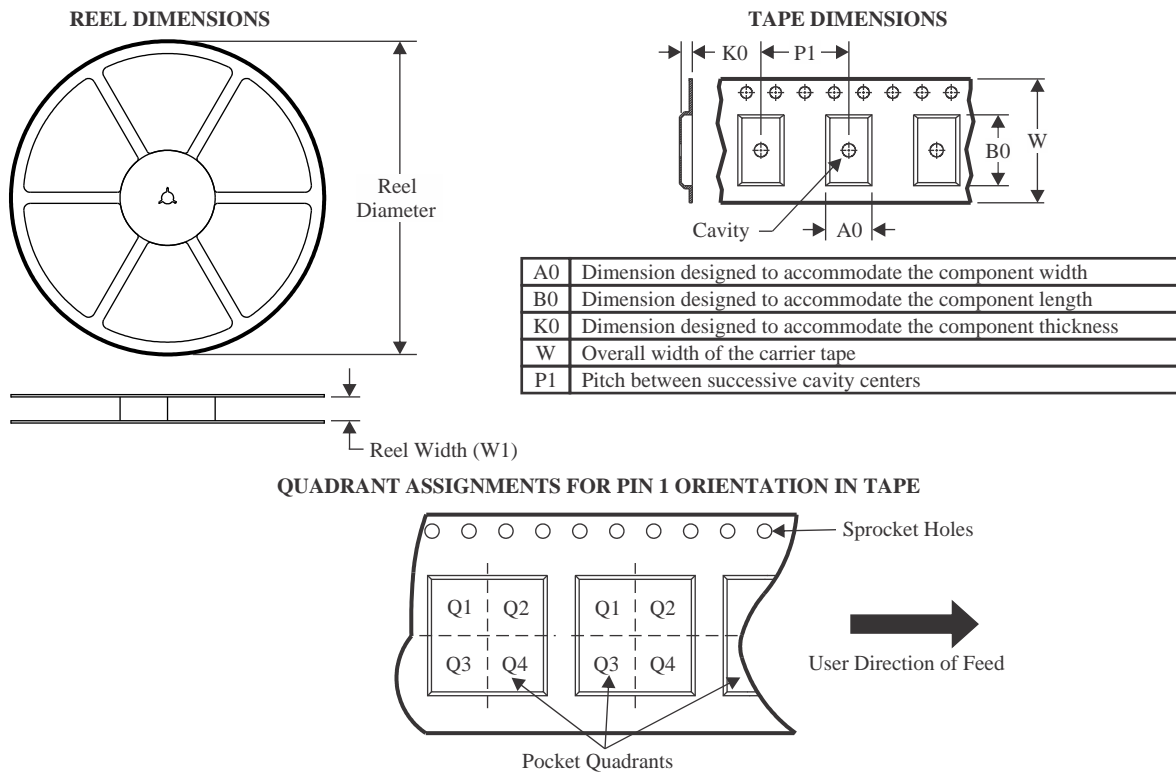
(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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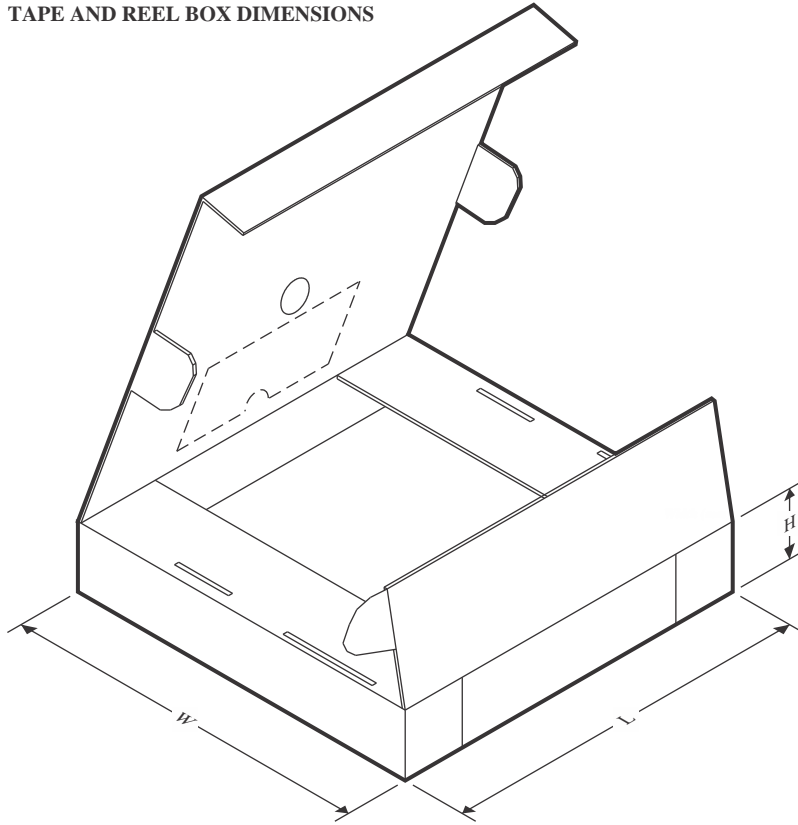
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device           | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|------------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| TAS6424MSQDKQRQ1 | HSSOP        | DKQ             | 56   | 1000 | 330.0              | 32.4               | 11.35   | 18.67   | 3.1     | 16.0    | 32.0   | Q1            |
| TAS6424MSQDKQRQ1 | HSSOP        | DKQ             | 56   | 1000 | 330.0              | 32.4               | 11.35   | 18.67   | 3.1     | 16.0    | 32.0   | Q1            |

## TAPE AND REEL BOX DIMENSIONS



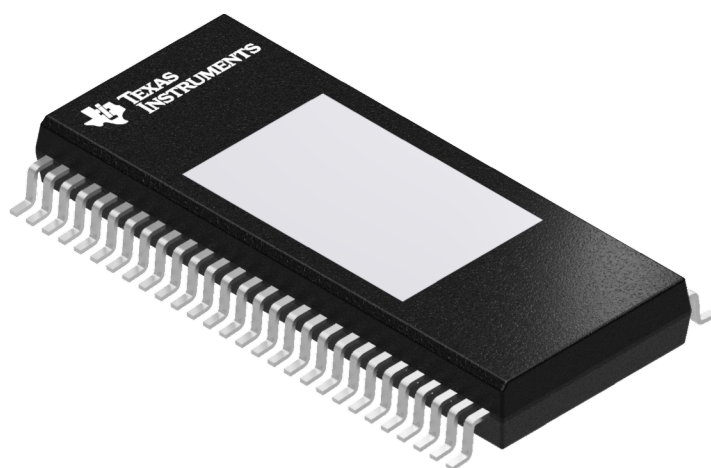
\*All dimensions are nominal

| Device           | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TAS6424MSQDKQRQ1 | HSSOP        | DKQ             | 56   | 1000 | 356.0       | 356.0      | 53.0        |
| TAS6424MSQDKQRQ1 | HSSOP        | DKQ             | 56   | 1000 | 356.0       | 356.0      | 53.0        |

DKQ 56

PowerPAD™ SSOP - 2.34 mm max height

PLASTIC SMALL OUTLINE



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



## PowerPAD™ HSSOP - 2.475 mm max height

## PLASTIC SMALL OUTLINE



PowerPAD is a trademark of Texas Instruments.

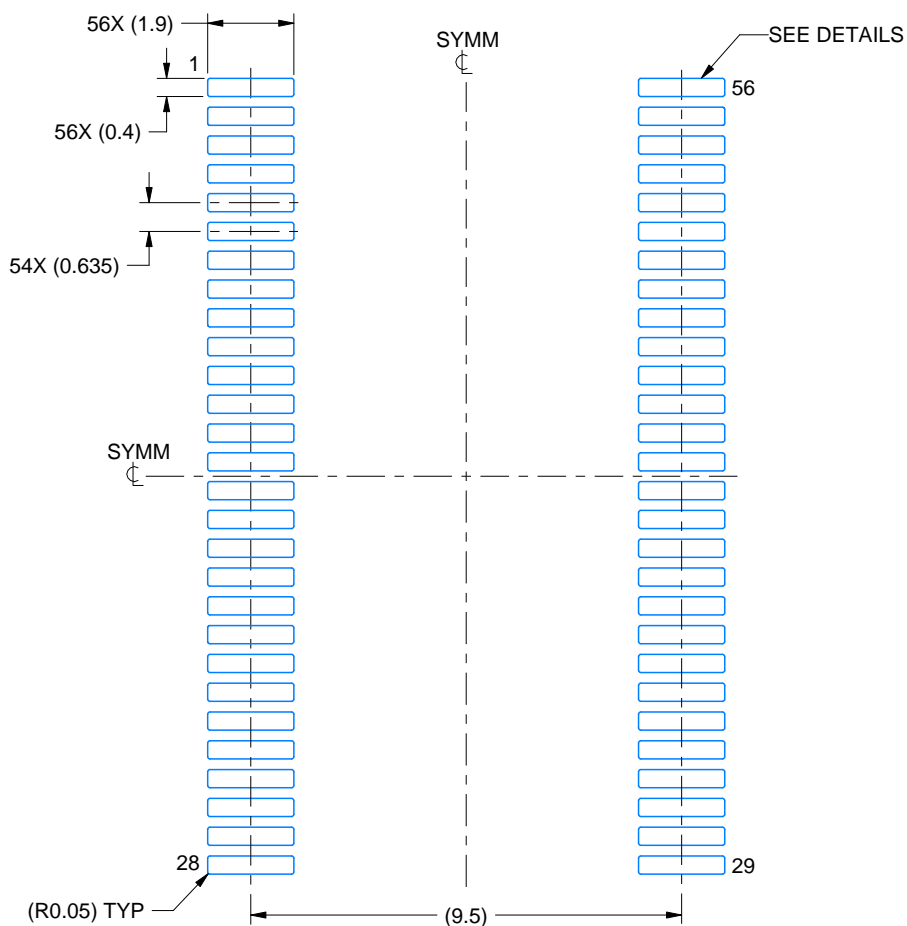
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# EXAMPLE BOARD LAYOUT

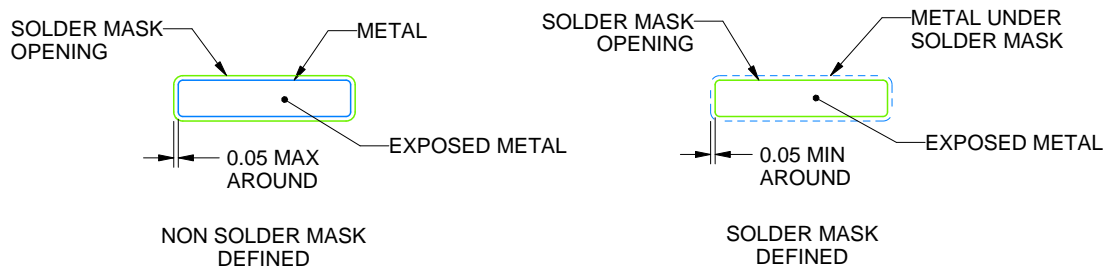
DKQ0056A

PowerPAD™ HSSOP - 2.475 mm max height

PLASTIC SMALL OUTLINE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:6X



SOLDER MASK DETAILS  
NOT TO SCALE

4221870/F 12/2024

NOTES: (continued)

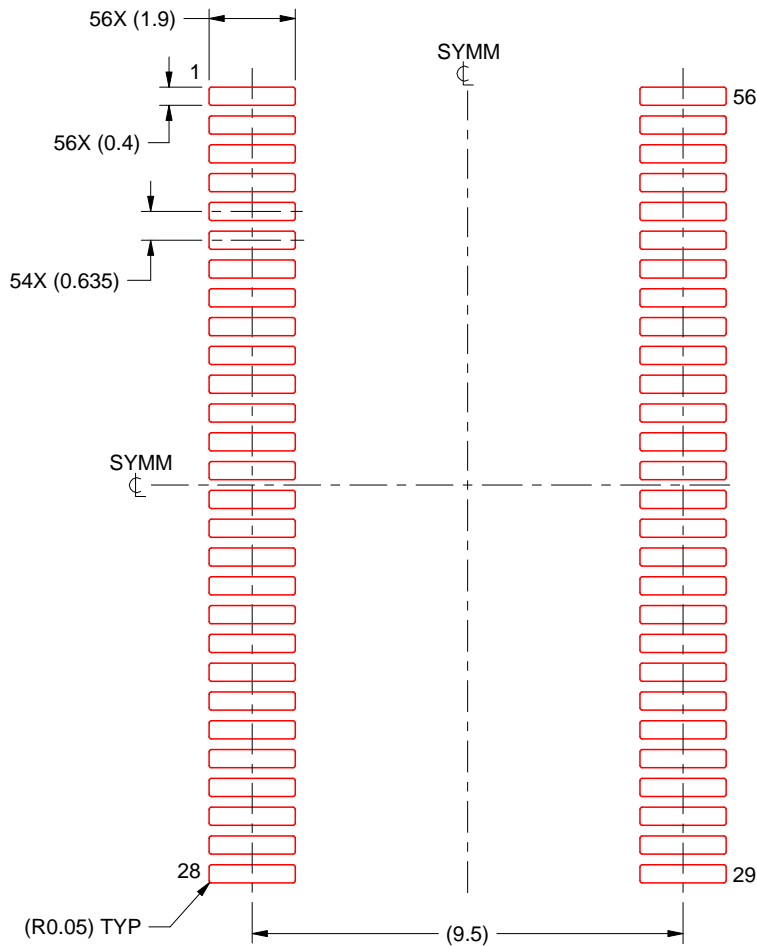
7. Publication IPC-7351 may have alternate designs.
8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
9. Size of metal pad may vary due to creepage requirement.

# EXAMPLE STENCIL DESIGN

DKQ0056A

PowerPAD™ HSSOP - 2.475 mm max height

PLASTIC SMALL OUTLINE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 MM THICK STENCIL  
SCALE:6X

4221870/F 12/2024

NOTES: (continued)

10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
11. Board assembly site may have different recommendations for stencil design.

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